

**PERFORMANCE VERIFICATION TEST REPORT
METSAT AMSU-A2 RECEIVER ASSEMBLY
FOR
INTEGRATED ADVANCED MICROWAVE SOUNDING UNIT-A
(AMSU-A)**

**CONTRACT NO. NAS5-32314
CDRL 208**

NOVEMBER 1998

SUBMITTED TO

**NATIONAL AERONAUTICS AND SPACE ADMINISTRATION
GODDARD SPACE FLIGHT CENTER
GREENBELT, MARYLAND 20771**

SUBMITTED BY

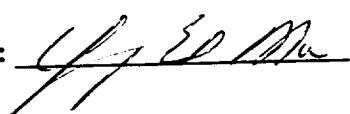
**AEROJET ELECTRONIC SYSTEMS PLANT
1100 WST HOLLYVALE STREET
AZUSA, CALIFORNIA 91702**

AMSU-A RECEIVER VERIFICATION TEST REPORT

LEVEL OF ASSEMBLY: SUBASSEMBLY
TEST ITEM: AMSU-A2 RECEIVER ASSEMBLY
P/N: 1356441-1, S/N: F04
TYPE OF HARDWARE: METSAT FLIGHT MODEL (FM)
TYPE OF TEST: FUNCTIONAL PERFORMANCE
VERIFICATION TEST PROCEDURE: AE-26002/6A
TEST FACILITY LOCATION: AESP
AZUSA, CALIFORNIA

SIGNATURE:

TEST ENGINEER:



DATE: 11/11/1998

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1.0 INTRODUCTION

The AMSU-A receiver subsystem comprises two separated receiver assemblies; AMSU-A1 and AMSU-A2 (P/N 1356441-1). The AMSU-A1 receiver contains 13 channels and the AMSU-A2 receiver 2 channels. The AMSU-A1 receiver assembly is further divided into two parts; AMSU-A1-1 (P/N 1356429-1) and AMSU-A1-2 (P/N 1356409-1), which contain 9 and 4 channels, respectively. Figures 1 and 2 illustrate the functional block diagrams of the AMSU-A1 and AMSU-A2 receivers.

The AMSU-A receiver subsystem stands in between the antenna and signal processing subsystems of the AMSU-A instrument and comprises the RF and IF components from RF isolators to IF attenuators as shown in Figures 1 and 2. It receives the RF signals from the antenna subsystem, down-converts the RF signals to IF signals, amplifies and defines the IF signals to proper power level and frequency bandwidth as specified for each channel, and inputs the IF signals to the signal processing subsystem.

The test reports for the METSAT AMSU-A receiver subsystem are prepared separately for the A1 and A2 receivers so that each receiver stands alone during integration of instruments into the spacecraft. This test report presents the test data of the METSAT AMSU-A2 Flight Model No. 4 (FM-4) receiver. The tests are performed per the Acceptance Test Procedure for the AMSU-A Receiver Subsystem, AE-26002/6A. The functional performance tests are conducted either at the component or subsystem level. While the component-level tests are performed over the entire operating temperature range predicted by thermal analysis, the subsystem-level tests are conducted at ambient temperature only.

2.0 REASON FOR TEST

The Acceptance Test Procedure for the AMSU-A Receiver Subsystem, AE-26002/6A, is prepared to describe in detail the configuration of the test setups and how the tests are to be conducted to verify that the receiver subsystem meets the specifications as required either in the AMSU-A Instrument Performance and Operation Specification, S-480-80, or in AMSU-A Receiver Subsystem Specification, AE-26608, derived by the Aerojet System Engineering. Test results that verify the conformance to the specifications demonstrates the acceptability of that particular receiver.

3.0 ACCEPTANCE TEST

The acceptance tests for the AMSU-A receiver subsystem are performed either at the component or subsystem level. The component-level tests are conducted per the Acceptance Test Procedure of each component at supplier's facilities. The subsystem-level tests are conducted per the Acceptance Test Procedure (ATP), AE-26002/6A at Aerojet Azusa facility.

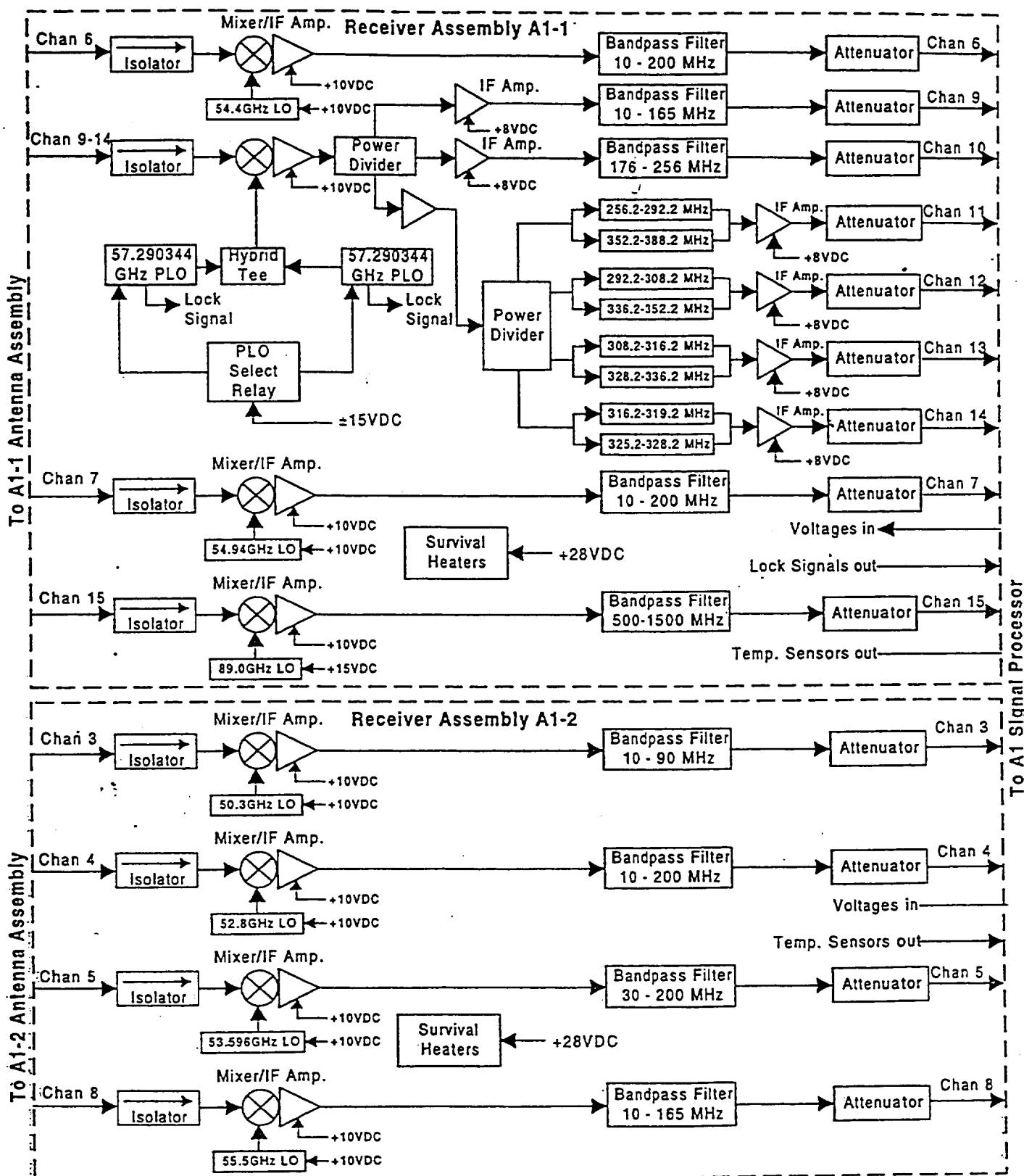


Figure 1. AMSU-A1 Receiver Functional Block Diagram

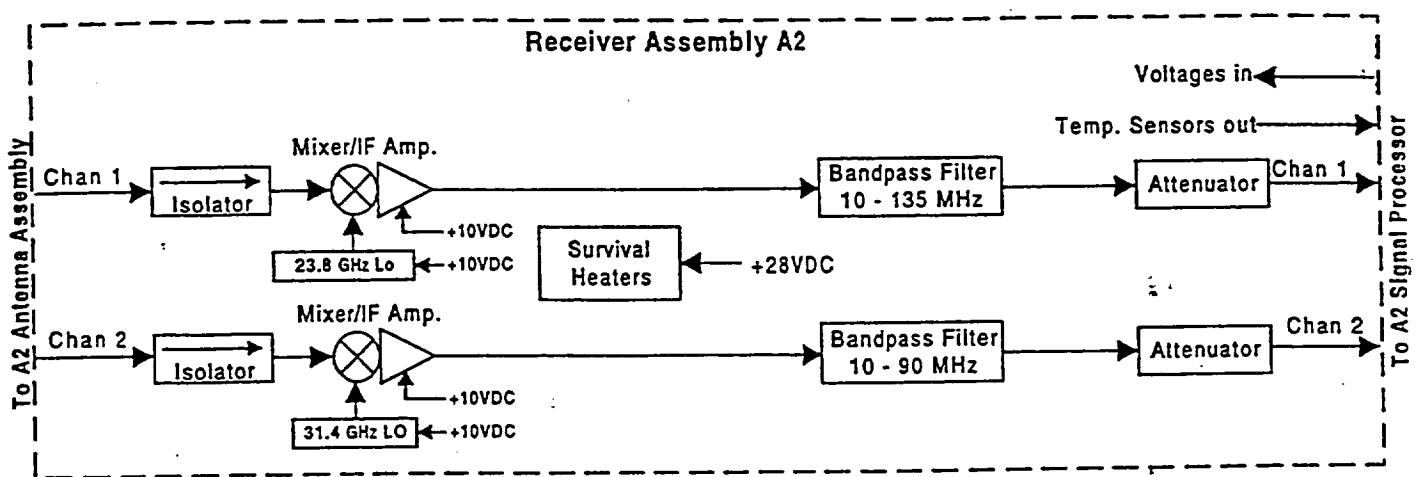


Figure 2. AMSU-A2 Receiver Functional Block Diagram

The component-level tests include the center frequency, center frequency stability, bandpass characteristics, gain stability, and gain compression. Although the bandpass characteristics can change slightly in subsystem level, these performances are mainly dependent on the component characteristics. The subsystem-level tests include the center frequency, IF output power, bandpass characteristics, noise figure, noise power stability, and the tunable short test (for Protoflight Model only).

The subsystem-level tests are performed on the AMSU-A2 receiver. However, since the diplexer of the AMSU-A2 system is inseparably integrated to the receiver, the acceptance tests are conducted with the feedhorn directly connected to the diplexer that precedes the receiver. These tests are performed at room ambient temperature only.

Wire connections between the D-sub connectors and platinum resistance temperature (PRT) sensors and thermistors, and D-sub connector and survival heaters through the thermal switches are verified by measuring either the resistances between the respective two pins or the voltages across the two respective pins. The component bias voltages are verified by measuring the voltages across the two respective banana jacks of the breakout box that are connected to corresponding pins of the D-sub connector.

The subsystem-level tests went smoothly except an error in the LO power adjustment for the channel 1 mixer/IF amplifier (P/N: 1331562-11, S/N: 7A41). While the performance of the unit was optimized at +7dBm at the component level, the LO power level of the mixer was already set at +10.5dBm as nominally applied to the mixers in previous receivers, resulting in higher noise figure of 5.3dB against the specification of 4.5dB. When the LO power of the mixer was reduced to +7dBm, the noise figure of the channel was improved to 4.27dB.

The tunable short tests were not performed as they were performed on previous EOS AMSU-A2 receiver.

4.0 ORGANIZATION OF TEST DATA

The test data are organized in the following formats. The test data obtained at the component level are first summarized for each category for all applicable receiver channels. The bandpass characteristics of the filters are summarized only for the data measured at mid-temperature. Supporting component test data over the operating temperature range then follows the summaries. The subsystem-level test data then follows the component test data. Test data recorded in the test sheet as prepared in the Acceptance Test Procedure and related data plots are included in this test report.

5.0 SUMMARY AND RECOMMENDATIONS

The METSAT AMSU-A2 FM-4 receiver subsystem successfully passed all performance requirements and was delivered to the System Engineering for system integration and test. The test data indicated adequate margins for all performance specifications.

6.0 TEST DATA

In the following, the component and subsystem-level test data are organized as delineated in Paragraph 4.0.

Report No. 11317
November 1998

COMPONENT-LEVEL TEST DATA

**CENTER FREQUENCY AND FREQUENCY STABILITY
FOR
LOCAL OSCILLATORS (LOs)
(DROs)**

CENTER FREQUENCY OF LOs

Channel No.	1	2
Specification (GHz)	23.8	31.4
Setting Accuracy (+/-GHz)	0.002	0.002
Measured (GHz)	23.80050	31.40182

FREQUENCY STABILITY OF LOs

Channel No.	1	2
<u>Short-Term Specification (+/-MHz)</u>	8	8
Setting Accuracy (+/-MHz)	2	2
W/ Temp. & Voltage (+/-MHz)	6	6
Measured (MHz) Total	+0.93, -1.92	+4.22, -3.48
<u>Long-Term Specification (+/-MHz)</u>	2	2
By Design or Analysis * (+/-MHz)	0.1	0.1

* Based on accelerated life-test data of DROs.

Channel 1 LO

DRO (P/N: 1336610-1, S/N: 87057)

LITTON
Solid State

TEST DATA SHEET 7.2

- FUNCTIONAL PERFORMANCE TESTS
INITIAL DATA SET N/A FINAL DATA SET ✓

LITTON TYPE LS K 9604 CF
SERIAL NUMBER: 87057

AESD 1336610-1
ACCEPT TEST ✓

Basic Electrical Test; Ref. Test Para. 5.2.2

<u>SPECIFICATION</u>	<u>MEASUREMENT AT T_{nom} ± 1°C</u>	<u>LIMIT</u>
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Measurement at V_{op}=10 VDC

Temperature	<u>18</u> °C	Table IIIB
Input Voltage	<u>10</u> VDC	10.0 ± 0.2 VDC
Input Current	<u>65.1</u> mA	Table IIIB
Input Power, P _{diss}	<u>0.651</u> W DC	P _{diss} max
Frequency, f _{T_{nom}}	<u>23.80050</u> GHz	Table IIIB
RF Output Power, P _{T_{nom}}	<u>12.4</u> dBm	12 to 17 dBm
Frequency Setting Accuracy, Δf _s (= f _{T_{nom}} - F _o)	<u>0.5</u> MHz	

Frequency and RF Output Power Variation With Voltage, Ref. Test Para 5.2.3

Measurement at 9.5 VDC or at 9.5 VDC

Temperature	<u>18</u> °C	Table IIIB
Input Voltage	<u>9.5</u> VDC	9.5 VDC or Para. 5.2.3.2
Input Current	<u>65.1</u> mA	Table IIIB
Frequency, f _{meas}	<u>23.80050</u> GHz	Table IIIB
RF Output Power, P _{meas}	<u>12.4</u> dBm	12 to 17 dBm

Measurement at 10.5 VDC or at 10.5 VDC

Temperature	<u>18</u> °C	Table IIIB
Input Voltage	<u>10.5</u> VDC	10.5 VDC or Para. 5.2.3.3
Input Current	<u>65.1</u> mA	Table IIIB
Frequency, f _{meas}	<u>23.80050</u> GHz	Table IIIB
RF Output Power, P _{meas}	<u>12.4</u> dBm	12 to 17 dBm

Calculate Frequency Variation, Δf_v = f_{meas} - f_{T_{nom}},

Δf _v at 9.5 VDC or at <u>9.5</u>	VDC =	<u>0</u> MHz
Δf _v at 10.5 VDC or at <u>10.5</u>	VDC =	<u>0</u> MHz

Calculate RF Output Power Variation, ΔP_v = P_{meas} - P_{T_{nom}},

ΔP _v at 9.5 VDC or at <u>9.5</u>	VDC =	<u>0</u> dB
ΔP _v at 10.5 VDC or at <u>10.5</u>	VDC =	<u>0</u> dB

Accept ✓ Reject _____

Test Performed by
Litton QA

Date 4-17-98
Date APR 17 1998

CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 38 OF 68
56348	A	1300823	B3	

LITTON**Solid State**

TEST DATA SHEET 7.3

- FUNCTIONAL PERFORMANCE TESTS
INITIAL DATA SET N/A FINAL DATA SET ✓LITTON TYPE LS K 9604 CF
SERIAL NUMBER: 87057QUAL TEST N/AAESD 1336610-1ACCEPT TEST ✓

Temperature Testing at T=10°C, Ref. Test Para. 5.2.5.1

SPECIFICATIONMEASUREMENT AT T=10° ± 1°CLIMITMeasurement at V_{op}=10 VDC

Temperature	<u>10</u> °C	<u>10° ± 1°C</u>
Input Voltage	<u>10</u> VDC	<u>10.0 ± 0.2 VDC</u>
Input Current	<u>65.0</u> mA	<u>Table IIIB</u>
Input Power, P _{diss}	<u>0.650</u> W DC	<u>Pdiss max</u>
Frequency, f _{10°C}	<u>23.80057</u> GHz	<u>Table IIIB</u>
RF Output Power, P _{10°C}	<u>12.5</u> dBm	<u>12 to 17 dBm</u>

Frequency and RF Output Power Variation With Voltage, Ref. Test Para 5.2.5.1

Measurement at 9.5 VDC or at 9.5 VDC

Temperature	<u>10</u> °C	<u>Table IIIB</u>
Input Voltage	<u>9.5</u> VDC	<u>9.5 VDC or Para. 5.2.3.2</u>
Input Current	<u>64.9</u> mA	<u>Table IIIB</u>
Frequency, f _{meas}	<u>23.80056</u> GHz	<u>Table IIIB</u>
RF Output Power, P _{meas}	<u>12.5</u> dBm	<u>12 to 17 dBm</u>

Measurement at 10.5 VDC or at 10.5 VDC

Temperature	<u>10</u> °C	<u>Table IIIB</u>
Input Voltage	<u>10.5</u> VDC	<u>10.5 VDC or Para. 5.2.3.3</u>
Input Current	<u>65.0</u> mA	<u>Table IIIB</u>
Frequency, f _{meas}	<u>23.80054</u> GHz	<u>Table IIIB</u>
RF Output Power, P _{meas}	<u>12.5</u> dBm	<u>12 to 17 dBm</u>

Calculate Frequency Variation, $\Delta f_V = f_{meas} - f_{10°C}$:

$$\begin{aligned}\Delta f_V \text{ at } 9.5 \text{ VDC or at } & \underline{9.5} \text{ VDC} = & \underline{0.01} \text{ MHz} \\ \Delta f_V \text{ at } 10.5 \text{ VDC or at } & \underline{10.5} \text{ VDC} = & \underline{-8.82} \text{ MHz} \\ \Delta f_T \text{ at } 10.0 \text{ VDC } (=f_{10°C} - f_{T_{nom}}) & = & \underline{0.07} \text{ MHz}\end{aligned}$$

Calculate RF Output Power Variation, $\Delta P_V = P_{meas} - P_{10°C}$:

$$\begin{aligned}\Delta P_V \text{ at } 9.5 \text{ VDC or at } & \underline{9.5} \text{ VDC} = & \underline{\phi} \text{ dB} \\ \Delta P_V \text{ at } 10.5 \text{ VDC or at } & \underline{10.5} \text{ VDC} = & \underline{\phi} \text{ dB} \\ \Delta P_T \text{ at } 10.0 \text{ VDC } (=P_{10°C} - P_{T_{nom}}) & = & \underline{0.1} \text{ dB}\end{aligned}$$

Test Performed by
Litton Q.A.VN 25
8/93Accept ✓ Reject _____
Date 4-17-98
Date 4-29-98

LITTON
Solid State

TEST DATA SHEET 7.4
FUNCTIONAL PERFORMANCE TESTS
 INITIAL DATA SET N/A FINAL DATA SET ✓

LITTON TYPE LS K 9604 CF
 SERIAL NUMBER: 87057 QUAL TEST N/A

AESD 1336610-1
 ACCEPT TEST ✓

Temperature Extreme Testing at T_{min}, Ref. Test Para. 5.2.5.2

<u>SPECIFICATION</u>	<u>MEASUREMENT AT T_{min} ± 1°C</u>	<u>LIMIT</u>
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Measurement at V_{op}=10 VDC

Temperature	<u>-5</u> °C	Table IIIB
Input Voltage	<u>10</u> VDC	10.0 ± 0.2 VDC
Input Current	<u>65.1</u> mA	Table IIIB
Input Power, P _{diss}	<u>0.651</u> W DC	Pdiss max
Frequency, f _{T_{min}}	<u>23.80062</u> GHz	Table IIIB
RF Output Power, P _{T_{min}}	<u>12.5</u> dBm	12 to 17 dBm

Frequency and RF Output Power Variation With Voltage, Ref. Test Para 5.2.5.2

Measurement at 9.5 VDC or at 9.5 VDC

Temperature	<u>-5</u> °C	Table IIIB
Input Voltage	<u>9.5</u> VDC	9.5 VDC or Para 5.2.3.2
Input Current	<u>65.2</u> mA	Table IIIB
Frequency, f _{meas}	<u>23.80060</u> GHz	Table IIIB
RF Output Power, P _{meas}	<u>12.5</u> dBm	12 to 17 dBm

Measurement at 10.5 VDC or at 10.5 VDC

Temperature	<u>-5</u> °C	Table IIIB
Input Voltage	<u>10.5</u> VDC	10.5 VDC or Para 5.2.3.3
Input Current	<u>65.2</u> mA	Table IIIB
Frequency, f _{meas}	<u>23.80059</u> GHz	Table IIIB
RF Output Power, P _{meas}	<u>12.5</u> dBm	12 to 17 dBm

Calculate Frequency Variation, $\Delta f_V = f_{meas} - f_{T_{min}}$:

Δf_V at 9.5 VDC or at <u>9.5</u>	VDC =	<u>-0.02</u> MHz
Δf_V at 10.5 VDC or at <u>10.5</u>	VDC =	<u>-0.01</u> MHz
Δf_T at 10.0 VDC ($= f_{T_{min}} - f_{T_{nom}}$)		<u>0.12</u> MHz

Calculate RF Output Power Variation, $\Delta P_V = P_{meas} - P_{T_{min}}$:

ΔP_V at 9.5 VDC or at <u>9.5</u>	VDC =	<u>0.1</u> dB
ΔP_V at 10.5 VDC or at <u>10.5</u>	VDC =	<u>-0.1</u> dB
ΔP_T at 10.0 VDC ($= P_{T_{min}} - P_{T_{nom}}$)	=	<u>-0.1</u> dB

Accept ✓ Reject

Test Performed by
Litton Q.A.

VN
125
1301

Date 4-17-98
Date APR 29 1998

CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 40 OF 68
56348	A	1300823	B3	

LITTON
Solid State

TEST DATA SHEET 7.5
FUNCTIONAL PERFORMANCE TESTS
INITIAL DATA SET N/A FINAL DATA SET ✓

LITTON TYPE LS K 9604 CF AESD 1336610-1
SERIAL NUMBER: 87057 QUAL TEST N/A ACCEPT TEST ✓

Temperature Testing at T=30°C, Ref. Test Para. 5.2.5.3

<u>SPECIFICATION</u>	<u>MEASUREMENT AT T=30° ± 1°C</u>	<u>LIMIT</u>
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Measurement at V_{op}=10 VDC

Temperature	<u>30</u> °C	<u>30° ± 1°C</u>
Input Voltage	<u>10</u> VDC	<u>10.0 ± 0.2 VDC</u>
Input Current	<u>65.4</u> mA	<u>Table IIIB</u>
Input Power, P _{diss}	<u>0.654</u> W DC	<u>Pdiss max</u>
Frequency, f _{30°C}	<u>23.79972</u> GHz	<u>Table IIIB</u>
RF Output Power, P _{30°C}	<u>12.3</u> dBm	<u>12 to 17 dBm</u>

Frequency and RF Output Power Variation With Voltage, Ref. Test Para 5.2.5.3

Measurement at 9.5 VDC or at 9.5 VDC

Temperature	<u>30</u> °C	<u>Table IIIB</u>
Input Voltage	<u>9.5</u> VDC	<u>9.5 VDC or Para. 5.2.3.2</u>
Input Current	<u>65.4</u> mA	<u>Table IIIB</u>
Frequency, f _{meas}	<u>23.79972</u> GHz	<u>Table IIIB</u>
RF Output Power, P _{meas}	<u>12.3</u> dBm	<u>12 to 17 dBm</u>

Measurement at 10.5 VDC or at 10.5 VDC

Temperature	<u>30</u> °C	<u>Table IIIB</u>
Input Voltage	<u>10.5</u> VDC	<u>10.5 VDC or Para. 5.2.3.3</u>
Input Current	<u>65.4</u> mA	<u>Table IIIB</u>
Frequency, f _{meas}	<u>23.79971</u> GHz	<u>Table IIIB</u>
RF Output Power, P _{meas}	<u>12.3</u> dBm	<u>12 to 17 dBm</u>

Calculate Frequency Variation, $\Delta f_V = f_{meas} - f_{30^\circ C}$:

Δf_V at 9.5 VDC or at <u>9.5</u>	VDC =	<u>0</u> MHz
Δf_V at 10.5 VDC or at <u>10.5</u>	VDC =	<u>- 0.01</u> MHz
Δf_T at 10.0 VDC ($= f_{30^\circ C} - f_{T_{nom}}$)	=	<u>- 0.78</u> MHz

Calculate RF Output Power Variation, $\Delta P_V = P_{meas} - P_{30^\circ C}$:

ΔP_V at 9.5 VDC or at <u>9.5</u>	VDC =	<u>0</u> dB
ΔP_V at 10.5 VDC or at <u>10.5</u>	VDC =	<u>0</u> dB
ΔP_T at 10.0 VDC ($= P_{30^\circ C} - P_{T_{nom}}$)	=	<u>- 0.1</u> dB

Test Performed by
Litton Q.A.

VAF
85

Accept ✓ Reject _____
Date 4-17-98
Date 4-17-98

CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 41 OF 68
56348	A	1300823	B3	

LITTON
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TEST DATA SHEET 7.6
FUNCTIONAL PERFORMANCE TESTS
INITIAL DATA SET N/A FINAL DATA SET ✓

LITTON TYPE LS K 9604 CF AESD 1336610-1
SERIAL NUMBER: 87057 QUAL TEST N/A ACCEPT TEST ✓

Temperature Extreme Testing at T_{max}, Ref. Test Para. 5.2.5.4

<u>SPECIFICATION</u>	<u>MEASUREMENT AT T_{max} ± 1°C</u>	<u>LIMIT</u>
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Measurement at V_{op}=10 VDC

Temperature	<u>40</u> °C	Table IIIB
Input Voltage	<u>10</u> VDC	10.0 ± 0.2 VDC
Input Current	<u>65.6</u> mA	Table IIIB
Input Power, P _{diss}	<u>0.656</u> W DC	Pdiss max
Frequency, f _{T_{max}}	<u>23.79872</u> GHz	Table IIIB
RF Output Power, P _{T_{max}}	<u>12.3</u> dBm	12 to 17 dBm

Frequency and RF Output Power Variation With Voltage, Ref. Test Para 5.2.5.4

Measurement at 9.5 VDC or at 9.5 VDC

Temperature	<u>40</u> °C	Table IIIB
Input Voltage	<u>9.5</u> VDC	9.5 VDC or Para 5.2.3.2
Input Current	<u>65.6</u> mA	Table IIIB
Frequency, f _{meas}	<u>23.79872</u> GHz	Table IIIB
RF Output Power, P _{meas}	<u>12.3</u> dBm	12 to 17 dBm

Measurement at 10.5 VDC or at 10.5 VDC

Temperature	<u>40</u> °C	Table IIIB
Input Voltage	<u>10.5</u> VDC	10.5 VDC or Para 5.2.3.3
Input Current	<u>65.6</u> mA	Table IIIB
Frequency, f _{meas}	<u>23.79873</u> GHz	Table IIIB
RF Output Power, P _{meas}	<u>12.3</u> dBm	12 to 17 dBm

Calculate Frequency Variation, $\Delta f_V = f_{meas} - f_{T_{max}}$:

Δf_V at 9.5 VDC or at <u>9.5</u>	VDC =	<u>0</u> MHz
Δf_V at 10.5 VDC or at <u>10.5</u>	VDC =	<u>+ 0.01</u> MHz
Δf_T at 10.0V ($= f_{T_{max}} - f_{T_{nom}}$)	=	<u>- 1.78</u> MHz

Calculate RF Output Power Variation, $\Delta P_V = P_{meas} - P_{T_{nom}}$:

ΔP_V at 9.5 VDC or at <u>9.5</u>	VDC =	<u>- 0.1</u> dB
ΔP_V at 10.5 VDC or at <u>10.5</u>	VDC =	<u>- 0.1</u> dB
ΔP_T at 10.0 VDC ($= P_{T_{max}} - P_{T_{nom}}$)	=	<u>- 0.1</u> dB

Accept ✓ Reject

Test Performed by
Litton Q.A.



Date 4-17-98
Date

CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 42 OF 68
56348	A	1300823	B3	

LITTON
Solid State

TEST DATA SHEET 7.7
FUNCTIONAL PERFORMANCE TESTS
INITIAL DATA SET N/A FINAL DATA SET ✓

LITTON TYPE LS K 9604 CF AESD 1336610-1
SERIAL NUMBER: 87057 QUAL TEST N/A ACCEPT TEST ✓

Power Supply Immunity, Ref. Test Para. 5.2.4

<u>SPECIFICATION</u>	<u>MEASUREMENT AT T_{nom} ± 1°C</u>	<u>LIMIT</u>
Initial Measurement		
Temperature	<u>18</u> °C	Table IIIB
Input Voltage	<u>10</u> VDC	<u>10.0 ± 0.2</u> VDC
Input Current	<u>6.50</u> mA	Table IIIB
Input Power	<u>0.650</u> W DC	Pdiss max
Frequency (f _{T_{nom}})	<u>23.80065</u> GHz	Table IIIB
RF Output Power	<u>12.3</u> dBm	<u>12 to 17</u> dBm
Frequency Setting Accuracy, Δf _s (= f _{T_{nom}} -F _o)	<u>0.65</u> MHz	

Performance After Short Circuit on Power Supply: Ref Test Para 5.2.4.2

Input Voltage	<u>10</u> VDC	<u>10.0 ± 0.2</u> VDC
Input Current	<u>6.50</u> mA	Table IIIB
Input Power	<u>0.650</u> W DC	Pdiss max
Frequency	<u>23.80063</u> GHz	Table IIIB
RF Output Power	<u>12.3</u> dBm	<u>12 to 17</u> dBm

Over Voltage: Ref Test Para 5.2.4.3

Overvoltage Input Voltage 28 VDC +28V

Performance After Input Overvoltage

Input Voltage	<u>10</u> VDC	<u>10.0 ± 0.2</u> VDC
Input Current	<u>6.50</u> mA	Table IIIB
Input Power	<u>0.650</u> W DC	Pdiss max
Frequency	<u>23.80060</u> GHz	Table IIIB
RF Output Power	<u>12.3</u> dBm	<u>12 to 17</u> dBm

Reverse Polarity: Ref Test Para 5.2.4.4

Reverse Input Voltage -10 VDC -10.0 ± 0.2 VDC

Performance After Reverse Input Voltage

Input Voltage	<u>10</u> VDC	<u>10.0 ± 0.2</u> VDC
Input Current	<u>6.50</u> mA	Table IIIB
Input Power	<u>0.650</u> W DC	Pdiss max
Frequency, f _{T_{nom}}	<u>23.80059</u> GHz	Table IIIB
RF Output Power	<u>12.3</u> dBm	<u>12 to 17</u> dBm
Frequency Setting Accuracy, Δf _s (= f _{T_{nom}} -F _o)	<u>0.65</u> MHz	

Accept ✓ Reject _____
Date APR 29 1990
Date

Test Performed by VN 
Litton Q.A. _____

CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 43 OF 68
56348	A	1300823	B3	

LITTON**Solid State**

TEST DATA SHEET 7.23B
FUNCTIONAL PERFORMANCE TESTS
INITIAL DATA SET N/A FINAL DATA SET ✓

LITTON TYPE LS K 9604 CF
 SERIAL NUMBER: 87057 QUAL TEST —

AESD 1336610-1
 ACCEPT TEST ✓

Frequency Pulling and Load VSWR 2.5:1 max. all phases. Ref Test Para. 5.9

TEST DESCRIPTION**LIMITS**

Output Open and Short. Ref. Test Para. 5.9.5

Temperature	<u>23</u> °C	<u>24°C ± 5°C</u>
Frequency:	<u>23.80006</u> GHz	<u>Table IIIB</u>
RF Output Power:	<u>12.3</u> dBm	<u>12 to 17 dBm</u>
Input Voltage	<u>10</u> VDC	<u>10 ± 0.2 VDC</u>
Input Current:	<u>65.2</u> mA	<u>Table IIIB</u>
Results:	<u>✓</u> Acceptable	<u>No Damage or Degradation</u>

Calculate maximum Frequency Accuracy (both positive and negative),

$\Delta f_{acc} = \Delta f_S$ (Use worst-case Δf_S from 7.2, 7.7, and 7.22A) + Δf_H (from 7.22A) + Δf_L (from 7.23A):

$$\begin{array}{ccc} + & - & \\ \text{Maximum } \Delta f_{acc} = & \begin{array}{l} \text{0.98 MHz (Positive)} \\ \text{- 0.11 MHz (Negative)} \end{array} & \begin{array}{l} \text{Table IIIB} \\ \text{Table IIIB} \end{array} \end{array}$$

Calculate maximum Short-term Frequency Stability (both positive and negative),

$\Delta f_{V+T} = \Delta f_V + \Delta f_T$ (Use worst-case Δf_V and Δf_T from 7.2 thru 7.6):

$$\begin{array}{ccc} + & - & \\ \text{Maximum } \Delta f_{V+T} = & \begin{array}{l} \text{0.01 MHz (Positive)} \\ \text{- 1.78 MHz (Negative)} \end{array} & \begin{array}{l} \text{Table IIIB} \\ \text{Table IIIB} \end{array} \end{array}$$

Calculate maximum overall RF Output Power Stability (both positive and negative),

$\Delta P_{ov} = \Delta P_V + \Delta P_T$ (Use worst-case ΔP_V and ΔP_T from 7.2 thru 7.6) + ΔP_H (from 7.22A) + ΔP_L (from 7.23A):

$$\begin{array}{ccc} + & - & \\ \text{Maximum } \Delta P_{ov} = & \begin{array}{l} \text{0 dB (Positive)} \\ \text{- 8.1 dB (Negative)} \end{array} & \begin{array}{l} \text{1.0 dB} \\ \text{-1.0 dB} \end{array} \end{array}$$

Accept ✓ Reject

Test Performed by VN Date 4-23-98

Litton Q.A. Date APR 29 1998



CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 61 OF 68
56348	A	1300823	B3	

Channel 2 LO

DRO (P/N: 1336610-2, S/N: 87056)

LITTON**Solid State**

TEST DATA SHEET 7.2

FUNCTIONAL PERFORMANCE TESTS

INITIAL DATA SET N/A FINAL DATA SET ✓LITTON TYPE LS A 9635 CF
SERIAL NUMBER: B7056QUAL TEST N/AAESD 1336610-2ACCEPT TEST ✓

Basic Electrical Test; Ref. Test Para. 5.2.2

SPECIFICATIONMEASUREMENT AT T_{nom} ± 1°CLIMITMeasurement at V_{op}=10 VDC

Temperature	<u>18</u> °C	Table IIIB
Input Voltage	<u>10</u> VDC	10.0 ± 0.2 VDC
Input Current	<u>135.5</u> mA	Table IIIB
Input Power, P _{diss}	<u>1.355</u> W DC	P _{diss} max
Frequency, f _{T_{nom}}	<u>31.40182</u> GHz	Table IIIB
RF Output Power, P _{T_{nom}}	<u>15.6</u> dBm	12 to 17 dBm
Frequency Setting Accuracy, Δf_s (= f _{T_{nom}} -F _o)	<u>1.82</u> MHz	

Frequency and RF Output Power Variation With Voltage, Ref. Test Para 5.2.3

Measurement at 9.5 VDC or at 9.5 VDC

Temperature	<u>18</u> °C
Input Voltage	<u>9.5</u> VDC
Input Current	<u>135.5</u> mA
Frequency, f _{meas}	<u>31.40179</u> GHz
RF Output Power, P _{meas}	<u>15.6</u> dBm

Table IIIB
9.5 VDC or Para. 5.2.3.2
Table IIIB
Table IIIB
12 to 17 dBm

Measurement at 10.5 VDC or at 10.5 VDC

Temperature	<u>18</u> °C
Input Voltage	<u>10.5</u> VDC
Input Current	<u>135.6</u> mA
Frequency, f _{meas}	<u>31.40179</u> GHz
RF Output Power, P _{meas}	<u>15.6</u> dBm

Table IIIB
10.5 VDC or Para. 5.2.3.3
Table IIIB
Table IIIB
12 to 17 dBm

Calculate Frequency Variation, $\Delta f_v = f_{meas} - f_{T_{nom}}$,

Δf_v at 9.5 VDC or at 9.5 VDC = -0.03 MHz
 Δf_v at 10.5 VDC or at 10.5 VDC = -0.03 MHz

Calculate RF Output Power Variation, $\Delta P_v = P_{meas} - P_{T_{nom}}$,

ΔP_v at 9.5 VDC or at 9.5 VDC = 0 dB
 ΔP_v at 10.5 VDC or at 10.5 VDC = 0 dB

Accept ✓ Reject _____Test Performed by
Litton QA

VN
LITTON
1160

Date 5-27-98
Date MAY 28 1998

CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 38 OF 68
56348	A	1300823	B3	

LITTON**Solid State**

TEST DATA SHEET 7.3
FUNCTIONAL PERFORMANCE TESTS
 INITIAL DATA SET N/A FINAL DATA SET ✓

LITTON TYPE LS A 9635 CF AESD 1336610-2
 SERIAL NUMBER: 87056 QUAL TEST N/A ACCEPT TEST ✓

Temperature Testing at T=10°C, Ref. Test Para. 5.2.5.1

<u>SPECIFICATION</u>	<u>MEASUREMENT AT T=10° ±1°C</u>	<u>LIMIT</u>
Measurement at V _{op} =10 VDC		
Temperature	<u>10</u> °C	<u>10° ± 1°C</u>
Input Voltage	<u>10</u> VDC	<u>10.0 ± 0.2 VDC</u>
Input Current	<u>135.4</u> mA	Table IIIB
Input Power, P _{diss}	<u>1.354</u> W DC	Pdiss max
Frequency, f _{10°C}	<u>31.40267</u> GHz	Table IIIB
RF Output Power, P _{10°C}	<u>15.6</u> dBm	12 to 17 dBm
Frequency and RF Output Power Variation With Voltage, Ref. Test Para 5.2.5.1		
Measurement at 9.5 VDC or at <u>9.5</u> VDC		
Temperature	<u>10</u> °C	Table IIIB
Input Voltage	<u>9.5</u> VDC	9.5 VDC or Para. 5.2.3.2
Input Current	<u>135.3</u> mA	Table IIIB
Frequency, f _{meas}	<u>31.40263</u> GHz	Table IIIB
RF Output Power, P _{meas}	<u>15.6</u> dBm	12 to 17 dBm
Measurement at 10.5 VDC or at <u>10.5</u> VDC		
Temperature	<u>10</u> °C	Table IIIB
Input Voltage	<u>10.5</u> VDC	10.5 VDC or Para. 5.2.3.3
Input Current	<u>135.4</u> mA	Table IIIB
Frequency, f _{meas}	<u>31.40263</u> GHz	Table IIIB
RF Output Power, P _{meas}	<u>15.6</u> dBm	12 to 17 dBm

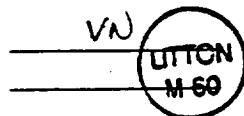
Calculate Frequency Variation, $\Delta f_V = f_{meas} - f_{10°C}$:

Δf_V at 9.5 VDC or at 9.5 VDC = -0.04 MHz
 Δf_V at 10.5 VDC or at 10.5 VDC = -0.04 MHz
 Δf_T at 10.0 VDC ($= f_{10°C} - f_{T_{nom}}$) = 0.85 MHz

Calculate RF Output Power Variation, $\Delta P_V = P_{meas} - P_{10°C}$:

ΔP_V at 9.5 VDC or at 9.5 VDC = φ dB
 ΔP_V at 10.5 VDC or at 10.5 VDC = φ dB
 ΔP_T at 10.0 VDC ($= P_{10°C} - P_{T_{nom}}$) = φ dB

Test Performed by VN
 Litton Q.A.



Accept ✓ Reject _____
 Date 5-27-98
 Date MAY 28 1998

CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 39 OF 68
56348	A	1300823	B3	

LITTON**Solid State**

TEST DATA SHEET 7.4
FUNCTIONAL PERFORMANCE TESTS
 INITIAL DATA SET N/A FINAL DATA SET ✓

LITTON TYPE LS A 9635 CF AESD 1336610- 2
 SERIAL NUMBER: 87056 QUAL TEST N/A ACCEPT TEST ✓

Temperature Extreme Testing at T_{min}, Ref. Test Para. 5.2.5.2

<u>SPECIFICATION</u>	<u>MEASUREMENT AT T_{min} ± 1°C</u>	<u>LIMIT</u>
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Measurement at V_{op}=10 VDC

Temperature	<u>-5</u> °C	Table IIIB
Input Voltage	<u>10</u> VDC	10.0 ± 0.2 VDC
Input Current	<u>134.8</u> mA	Table IIIB
Input Power, P _{diss}	<u>1.348</u> W DC	P _{diss} max
Frequency, f _{T_{min}}	<u>31.403 74</u> GHz	Table IIIB
RF Output Power, P _{T_{min}}	<u>15.5</u> dBm	12 to 17 dBm

Frequency and RF Output Power Variation With Voltage, Ref. Test Para 5.2.5.2

Measurement at 9.5 VDC or at 9.5 VDC

Temperature	<u>-5</u> °C	Table IIIB
Input Voltage	<u>9.5</u> VDC	9.5 VDC or Para 5.2.3.2
Input Current	<u>134.7</u> mA	Table IIIB
Frequency, f _{meas}	<u>31.403 75</u> GHz	Table IIIB
RF Output Power, P _{meas}	<u>15.5</u> dBm	12 to 17 dBm

Measurement at 10.5 VDC or at 10.5 VDC

Temperature	<u>-5</u> °C	Table IIIB
Input Voltage	<u>10.5</u> VDC	10.5 VDC or Para 5.2.3.3
Input Current	<u>134.8</u> mA	Table IIIB
Frequency, f _{meas}	<u>31.403 77</u> GHz	Table IIIB
RF Output Power, P _{meas}	<u>15.5</u> dBm	12 to 17 dBm

Calculate Frequency Variation, $\Delta f_V = f_{meas} - f_{T_{min}}$:

Δf_V at 9.5 VDC or at <u>9.5</u>	VDC =	<u>0.01</u> MHz
Δf_V at 10.5 VDC or at <u>10.5</u>	VDC =	<u>0.03</u> MHz
Δf_T at 10.0 VDC ($= f_{T_{min}} - f_{T_{nom}}$)		<u>1.92</u> MHz

Calculate RF Output Power Variation, $\Delta P_V = P_{meas} - P_{T_{min}}$:

ΔP_V at 9.5 VDC or at <u>9.5</u>	VDC =	<u>-0.1</u> dB
ΔP_V at 10.5 VDC or at <u>10.5</u>	VDC =	<u>-0.1</u> dB
ΔP_T at 10.0 VDC ($= P_{T_{min}} - P_{T_{nom}}$)	=	<u>-0.1</u> dB

Accept ✓ Reject

Test Performed by
Litton Q.A.

VN


Date 5-27-98
Date MAY 28 1998

CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 40 OF 68
56348	A	1300823	B3	

LITTON**Solid State**

TEST DATA SHEET 7.5
FUNCTIONAL PERFORMANCE TESTS
 INITIAL DATA SET N/A FINAL DATA SET ✓

LITTON TYPE LSA 9635 CF
 SERIAL NUMBER: 87056

AESD 1336610- 2
 ACCEPT TEST ✓

Temperature Testing at T=30°C, Ref. Test Para. 5.2.5.3

SPECIFICATION**MEASUREMENT AT T=30° ±1°C****LIMIT**

Measurement at V_{op}=10 VDC

Temperature	<u>30</u>	°C	<u>30° ± 1°C</u>
Input Voltage	<u>10</u>	VDC	<u>10.0 ± 0.2 VDC</u>
Input Current	<u>135.6</u>	mA	<u>Table IIIB</u>
Input Power, P _{diss}	<u>1.356</u>	W DC	<u>Pdiss max</u>
Frequency, f _{30°C}	<u>31.40124</u>	GHz	<u>Table IIIB</u>
RF Output Power, P _{30°C}	<u>15.6</u>	dBm	<u>12 to 17 dBm</u>

Frequency and RF Output Power Variation With Voltage, Ref. Test Para 5.2.5.3

Measurement at 9.5 VDC or at 9.5 VDC

Temperature	<u>30</u>	°C	<u>Table IIIB</u>
Input Voltage	<u>9.5</u>	VDC	<u>9.5 VDC or Para. 5.2.3.2</u>
Input Current	<u>135.6</u>	mA	<u>Table IIIB</u>
Frequency, f _{meas}	<u>31.40117</u>	GHz	<u>Table IIIB</u>
RF Output Power, P _{meas}	<u>15.6</u>	dBm	<u>12 to 17 dBm</u>

Measurement at 10.5 VDC or at 10.5 VDC

Temperature	<u>30</u>	°C	<u>Table IIIB</u>
Input Voltage	<u>10.5</u>	VDC	<u>10.5 VDC or Para. 5.2.3.3</u>
Input Current	<u>135.6</u>	mA	<u>Table IIIB</u>
Frequency, f _{meas}	<u>31.4012</u>	GHz	<u>Table IIIB</u>
RF Output Power, P _{meas}	<u>15.6</u>	dBm	<u>12 to 17 dBm</u>

Calculate Frequency Variation, $\Delta f_V = f_{meas} - f_{30^\circ C}$:

$$\begin{array}{lll} \Delta f_V \text{ at } 9.5 \text{ VDC or at } & \text{VDC} = & -0.07 \text{ MHz} \\ \underline{9.5} & & \\ \Delta f_V \text{ at } 10.5 \text{ VDC or at } & \text{VDC} = & -0.12 \text{ MHz} \\ \underline{10.5} & & \\ \Delta f_T \text{ at } 10.0 \text{ VDC } (=f_{30^\circ C} - f_{T_{nom}}) & = & -0.58 \text{ MHz} \end{array}$$

Calculate RF Output Power Variation, $\Delta P_V = P_{meas} - P_{30^\circ C}$:

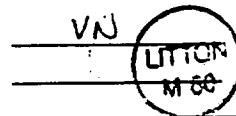
$$\begin{array}{lll} \Delta P_V \text{ at } 9.5 \text{ VDC or at } & \text{VDC} = & \phi \text{ dB} \\ \underline{9.5} & & \\ \Delta P_V \text{ at } 10.5 \text{ VDC or at } & \text{VDC} = & \phi \text{ dB} \\ \underline{10.5} & & \\ \Delta P_T \text{ at } 10.0 \text{ VDC } (=P_{30^\circ C} - P_{T_{nom}}) & = & \phi \text{ dB} \end{array}$$

Accept ✓ Reject

Date 5-27-98

Date MAY 28 1998

Test Performed by
Litton Q.A.



CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 41 OF 68
56348	A	1300823	B3	

LITTON**Solid State**

TEST DATA SHEET 7.6
FUNCTIONAL PERFORMANCE TESTS
 INITIAL DATA SET N/A FINAL DATA SET ✓

LITTON TYPE LS A 9635 CF
 SERIAL NUMBER: 87056

AESD 1336610-2
 ACCEPT TEST ✓

Temperature Extreme Testing at T_{max}, Ref. Test Para. 5.2.5.4

<u>SPECIFICATION</u>	<u>MEASUREMENT AT T_{max} ± 1°C</u>	<u>LIMIT</u>
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Measurement at V_{op}=10 VDC

Temperature	<u>40</u> °C	Table IIIB
Input Voltage	<u>10</u> VDC	10.0 ± 0.2 VDC
Input Current	<u>136.5</u> mA	Table IIIB
Input Power, P _{diss}	<u>1.365</u> W DC	P _{diss} max
Frequency, f _{Tmax}	<u>31.3988</u> GHz	Table IIIB
RF Output Power, P _{Tmax}	<u>15.6</u> dBm	12 to 17 dBm

Frequency and RF Output Power Variation With Voltage, Ref. Test Para 5.2.5.4

Measurement at 9.5 VDC or at 9.5 VDC

Temperature	<u>40</u> °C	Table IIIB
Input Voltage	<u>9.5</u> VDC	9.5 VDC or Para 5.2.3.2
Input Current	<u>136.5</u> mA	Table IIIB
Frequency, f _{meas}	<u>31.39887</u> GHz	Table IIIB
RF Output Power, P _{meas}	<u>15.6</u> dBm	12 to 17 dBm

Measurement at 10.5 VDC or at 10.5 VDC

Temperature	<u>40</u> °C	Table IIIB
Input Voltage	<u>10.5</u> VDC	10.5 VDC or Para 5.2.3.3
Input Current	<u>136.5</u> mA	Table IIIB
Frequency, f _{meas}	<u>31.39885</u> GHz	Table IIIB
RF Output Power, P _{meas}	<u>15.6</u> dBm	12 to 17 dBm

Calculate Frequency Variation, $\Delta f_V = f_{meas} - f_{Tmax}$:

Δf_V at 9.5 VDC or at <u>9.5</u>	VDC =	<u>- 0.01</u> MHz
Δf_V at 10.5 VDC or at <u>10.5</u>	VDC =	<u>- 0.03</u> MHz
Δf_T at 10.0V ($= f_{Tmax} - f_{Tnom}$)	=	<u>- 2.94</u> MHz

Calculate RF Output Power Variation. $\Delta P_V = P_{meas} - P_{Tnom}$:

ΔP_V at 9.5 VDC or at <u>9.5</u>	VDC =	<u>∅</u> dB
ΔP_V at 10.5 VDC or at <u>10.5</u>	VDC =	<u>∅</u> dB
ΔP_T at 10.0 VDC ($= P_{Tmax} - P_{Tnom}$)	=	<u>∅</u> dB

Accept ✓ Reject

Test Performed by
itton Q.A.

VN
LITTON
M 60

Date 5-27-98
Date MAY 28 1998

CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 42 OF 68
56348	A	1300823	B3	

LITTON
Solid State

TEST DATA SHEET 7.7
FUNCTIONAL PERFORMANCE TESTS
INITIAL DATA SET N/A FINAL DATA SET ✓

LITTON TYPE LS A 9635 CF AESD 1336610- 2
SERIAL NUMBER: 87056 QUAL TEST N/A ACCEPT TEST ✓

Power Supply Immunity, Ref. Test Para. 5.2.4

<u>SPECIFICATION</u>	<u>MEASUREMENT AT T_{nom} ± 1°C</u>	<u>LIMIT</u>
Initial Measurement		
Temperature	<u>18</u> °C	Table IIIB
Input Voltage	<u>10</u> VDC	10.0 ± 0.2 VDC
Input Current	<u>135.9</u> mA	Table IIIB
Input Power	<u>1.359</u> W DC	Pdiss max
Frequency (f _{T_{nom}})	<u>31.40125</u> GHz	Table IIIB
RF Output Power	<u>15.6</u> dBm	12 to 17 dBm
Frequency Setting Accuracy, Δf _s (= f _{T_{nom}} -F _o)	<u>1.25</u> MHz	

Performance After Short Circuit on Power Supply: Ref Test Para 5.2.4.2

Input Voltage	<u>10</u> VDC	10.0 ± 0.2 VDC
Input Current	<u>135.8</u> mA	Table IIIB
Input Power	<u>1.358</u> W DC	Pdiss max
Frequency	<u>31.40132</u> GHz	Table IIIB
RF Output Power	<u>15.6</u> dBm	12 to 17 dBm

(Over Voltage: Ref Test Para 5.2.4.3

Overvoltage Input Voltage	<u>28</u> VDC	+28V
---------------------------	---------------	------

Performance After Input Overvoltage

Input Voltage	<u>10</u> VDC	10.0 ± 0.2 VDC
Input Current	<u>135.8</u> mA	Table IIIB
Input Power	<u>1.358</u> W DC	Pdiss max
Frequency	<u>31.40150</u> GHz	Table IIIB
RF Output Power	<u>15.6</u> dBm	12 to 17 dBm

Reverse Polarity: Ref Test Para 5.2.4.4

Reverse Input Voltage	<u>-10</u> VDC	-10.0 ± 0.2 VDC
-----------------------	----------------	-----------------

Performance After Reverse Input Voltage

Input Voltage	<u>10</u> VDC	10.0 ± 0.2 VDC
Input Current	<u>135.8</u> mA	Table IIIB
Input Power	<u>1.358</u> W DC	Pdiss max
Frequency, f _{T_{nom}}	<u>31.40160</u> GHz	Table IIIB
RF Output Power	<u>15.6</u> dBm	12 to 17 dBm
Frequency Setting Accuracy, Δf _s (= f _{T_{nom}} -F _o)	<u>1.6</u> MHz	

Accept ✓ Reject

Date 5-27-98

Date MAY 28 1998

Test Performed by VN
Litton Q.A. LITTON

M.S.O.

CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 43 OF 68
56348	A	1300823	B3	

LITTON
Solid State

TEST DATA SHEET 7.23B
FUNCTIONAL PERFORMANCE TESTS
INITIAL DATA SET N/A FINAL DATA SET ✓

LITTON TYPE LS A 9635 CF
SERIAL NUMBER: 87056 QUAL TEST N/A

AESD 1336610-2
ACCEPT TEST ✓

Frequency Pulling and Load VSWR 2.5:1 max. all phases. Ref Test Para. 5.9

TEST DESCRIPTION

LIMITS

Output Open and Short. Ref. Test Para. 5.9.5

Temperature	<u>24</u> °C	<u>24°C ± 5°C</u>
Frequency:	<u>31.40190</u> GHz	Table IIIB
RF Output Power:	<u>15.6</u> dBm	12 to 17 dBm
Input Voltage	<u>10</u> VDC	<u>10 ± 0.2</u> VDC
Input Current:	<u>135.5</u> mA	Table IIIB
Results:	<u>✓</u> Acceptable	No Damage or Degradation

Calculate maximum Frequency Accuracy (both positive and negative),

$$f_{acc} = \Delta f_S \text{ (Use worst-case } \Delta f_S \text{ from 7.2, 7.7, and 7.22A) + } \Delta f_H \text{ (from 7.22A) + } \Delta f_L \text{ (from 7.23A):}$$

Maximum Δf_{acc} = 1.85 MHz (Positive) Table IIIB
- 0.12 MHz (Negative) Table IIIB

Calculate maximum Short-term Frequency Stability (both positive and negative),

$$\Delta f_{V+T} = \Delta f_V + \Delta f_T \text{ (Use worst-case } \Delta f_V \text{ and } \Delta f_T \text{ from 7.2 thru 7.6):}$$

Maximum Δf_{V+T} = 1.95 MHz (Positive) Table IIIB
- 3.06 MHz (Negative) Table IIIB

Calculate maximum overall RF Output Power Stability (both positive and negative),

$$\Delta P_{ov} = \Delta P_V + \Delta P_T \text{ (Use worst-case } \Delta P_V \text{ and } \Delta P_T \text{ from 7.2 thru 7.6) + } \Delta P_H \text{ (from 7.22A) + } \Delta P_L \text{ (from 7.23A):}$$

Maximum ΔP_{ov} = 0.41 dB (Positive) 1.0 dB
- 0.30 dB (Negative) -1.0 dB

Accept ✓ Reject _____

Test Performed by VN

Date 5-28-98

Litton Q.A.

Date MAY 28 1998



CODE IDENT NO.	SIZE	NUMBER	REV	SHEET 61 OF 68
56348	A	1300823	B3	

Report No. 11317
November 1998

**BANDPASS CHARACTERISTICS
FOR
IF FILTERS**

3 dB BANDWIDTH OF IF FILTERS

Channel No.	1	2
<u>Specification</u> (MHz)	135	90
3 dB bandwidth (MHz) *	127	82
$f_L - f_H$ (MHz)	8-135	8-90
<u>Measured</u> (MHz)		
3 dB bandwidth (MHz)	125.51	80.16
$f_L - f_H$ (MHz)	8.60-134.11	9.06-89.22

* Actual specifications for IF filters.

Channel 1 Mixer/Amplifier

Mixer/Amplifier (P/N: 1331562-11, S/N: 7A41)

TEST DATA SHEET NO. 6. AMPLIFIER TESTS

REF: SDAR#29

GAIN FLATNESS TEST: ATP PARAGRAPH 5.1.3

GAIN FLATNESS SPEC. GAIN FLATNESS
(dB)ppK (dB)ppK

ACC REJ

0.65 0.50



GAIN VERSUS VOLTAGE SENSITIVITY TEST: ATP PARAGRAPH 5.1.4

AMPLIFIER VOLTAGE	GAIN READING (dBm)	$\Delta G/\Delta V$
9.96	70.77 70.50	2.5
10.00	71.05 70.60	
10.04	71.13 70.70	
$\Delta G_V =$	0.20 dB	

SPEC.
 $\Delta G/\Delta V$

ACC REJ

ENGINEERING DATA
ONLY. SEE AE 24869
PARA. 3.2.1.15.2



DATE ACC REJ

PART NO. 1331562-116

SPACEK QA

6-5-98



SER NO. 7A41

TEST FAILURE:

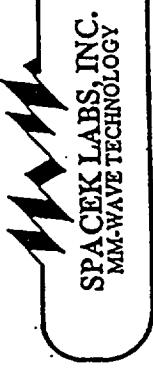
TESTED BY: 7A41

FAILURE ANALYSIS NO.

END DATE: 6-5-98

Spacek Labs, Inc.
212 E. Gutierrez St.
Santa Barbara, CA, 93101

END TIME: 1600

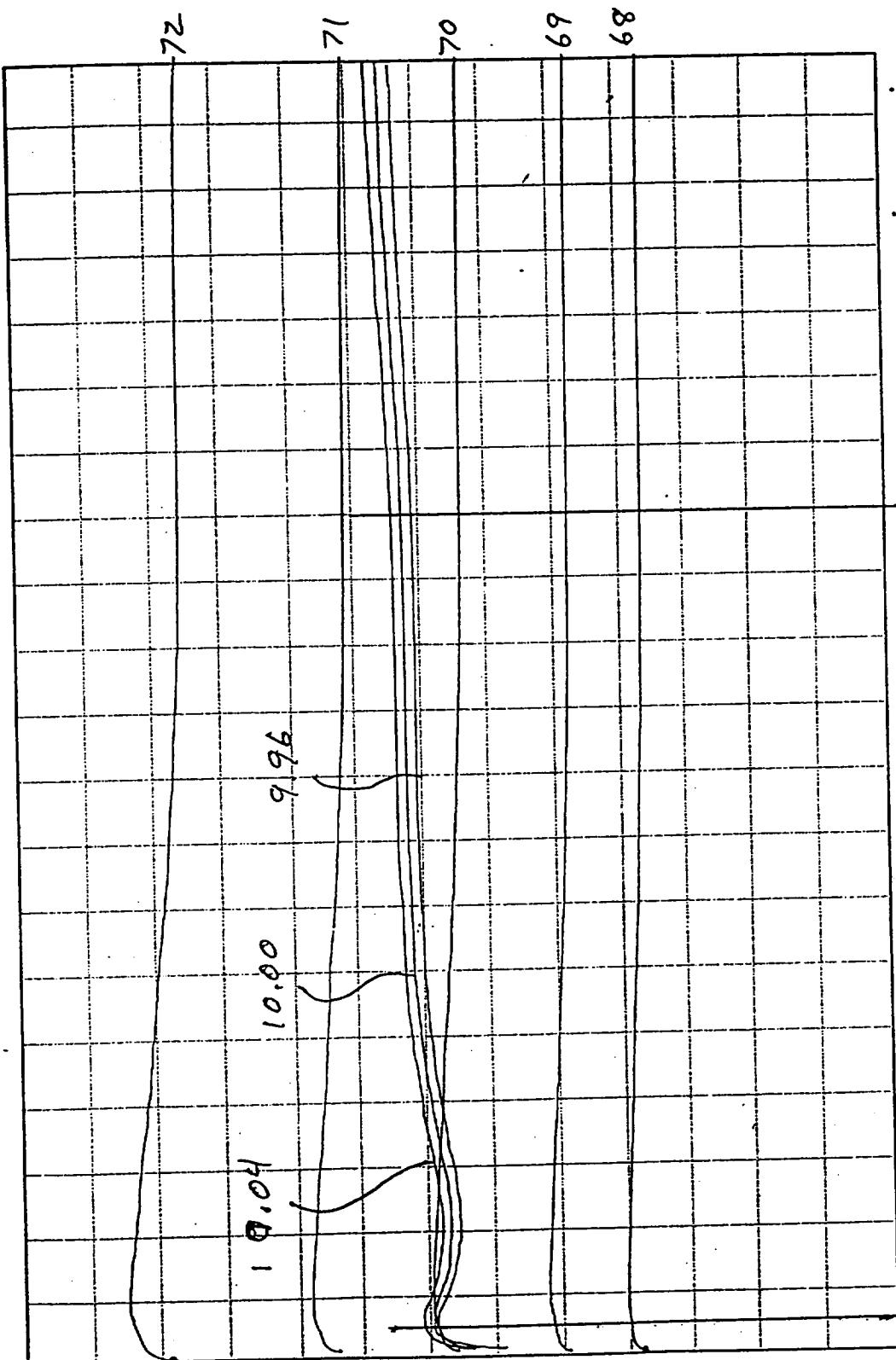


Amplifier Gain

Amb Temp +2.3

Amplifier Gain (db)

Model No. 1331562-11
Serial No. 7A WT
Date 6-5-98
Tested By 2278



8

TRANSMITTER (MHz)

150

QA
1

TEST DATA SHEET NO. 7. AMPLIFIER TESTS

GAIN VERSUS TEMPERATURE SENSITIVITY TEST: ATP PARAGRAPH 5.1.5

Nominal Temperature (°C)	Relative Gain	ΔG/ΔT	SPEC	ACC	REJ
T1 -6	G _{T1} 71.52	* 0.009	0.085dB/°C	QA 1	
T2 +8	G _{T2} 71.39	* 0.022	0.020dB/°C	QA 1	
T3 +28	G _{T3} 70.95	* 0.026	0.035dB/°C	QA 1	
T4 +40	G _{T4} 70.64				

* Perform the following calculations and record on the TDS

$$\Delta G/\Delta T = \frac{G_{T_i} - G_{T_{i+1}}}{T_i - T_{i+1}} \quad i = 1, 2, 3, 4 \quad \Delta G_T = 0.88 \text{ dB}$$

$$\Delta G_{\text{TOTAL}} = \Delta G_V + \Delta G_T + 0.4 = 1.48 \text{ dB Spec } 1.4 \text{ dB}$$

ACC _____ REJ _____

DATE ACC REJ ENGINEERING DATA
ONLY. SEE AE2C
PARA. 3.2.1.15.

PART NO. 1331562-11F

SPACEK QA

6-8-78

QA 1

SER NO. 7A41

TEST FAILURE: _____

TESTED BY: 778

FAILURE ANALYSIS NO. _____

END DATE: 6-5-98

Spacek Labs, Inc.
212 E. Gutierrez St.
Santa Barbara, CA, 93101

END TIME: 1600

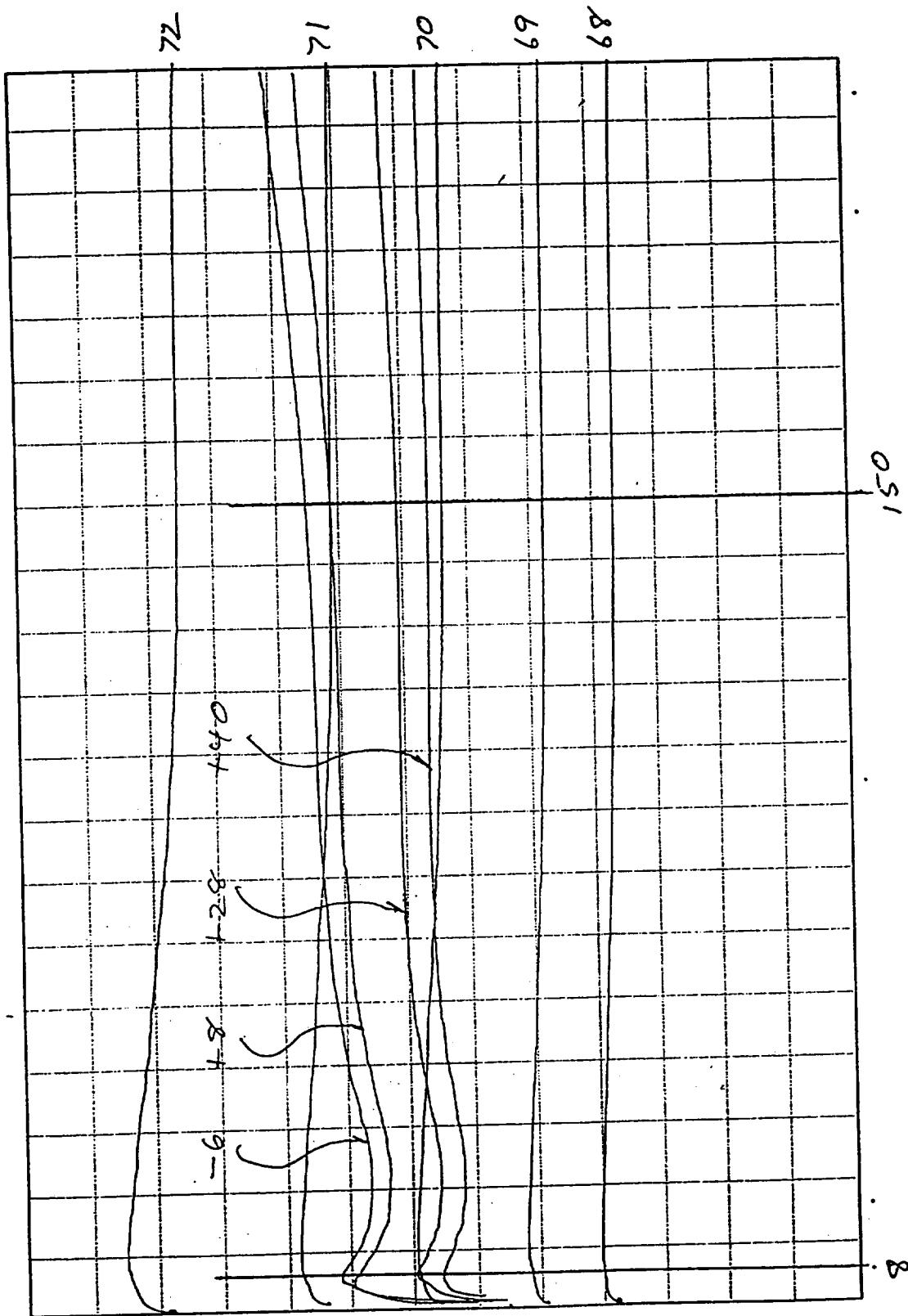


Amplifier Gain

Amb Temp +23°C

Amplifier Gain (db)

Model No. 1331542-11
Serial No. 7A41
Date 6-5-78
Tested By 7774



TEST DATA SHEET NO. 8. AMPLIFIER TESTSOUTPUT 1.0 dB COMPRESSION POINT TEST: ATP PARAGRAPH 5.1.6

DASH #

11	12	13	14	15	16	17	18	19	20	FREQ. (MHz)	P2 COMP (dBm)	OUTPUT COMP. at +10(dBm)	SPEC. COMP.	ACC	REJ
X	X	X	X	X	X	X	X	X	X	10	-2.3	0.7	1.0		
									X	20					
										50					
X	X	X	X	X	X	X	X	X	X	100	-2.4	0.6	1.0		
X	X	X	X	X	X	X	X	X	X	150	-2.5	0.5	1.0		
									X	200					
										400					
									X	500					
										X					
										1000					
									X	1500					

AMPLIFIER NOISE FIGURE AND TOTAL POWER TEST: ATP PARAGRAPH 5.1.7DATE: 6-5-98 AMBIENT ROOM TEMPERATURE °C: 23°C

AMPLIFIER OUTPUT POWER AMBIENT (dBm)	AMPLIFIER OUTPUT POWER (-77 K)(dBm)	Y FACTOR (dB)	AMPLIFIER NOISE FIGURE (dB)
<u>-22.9</u>	<u>-26.7</u>	<u>3.8</u>	<u>1.04</u>

Above data taken with Daden filter attached (except -19).

Intermediate test results for information only

PART NO. 1331562-11F

SPACEK QA

DATE 6-8-98 ACC REJ SER NO. 7A41

TEST FAILURE: _____

TESTED BY: 77A

FAILURE ANALYSIS NO. _____

END DATE: 6-5-98Spacek Labs, Inc.
212 E. Gutierrez St.
Santa Barbara, CA, 93101END TIME: 1600

TEST DATA SHEET NO. 13. MIXER-AMPLIFIER ASSEMBLY TESTS

NOISE FIGURE, TOTAL POWER AND CURRENT VS. TEMPERATURE TEST:
ATP PARA 5.4.8.

DATE: 8-20-98 AMBIENT ROOM TEMPERATURE °C: +21

UUT TEMP °C.	UUT CURRENT	MIXER- AMP. OUTPUT POWER (AMBIENT) (dBm)	MIXER- AMP. OUTPUT POWER (77 DEG K) (dBm)	Y FACTOR (dB)	MIXER- AMP. NOISE FIGURE (dB)	SPEC. MIXER- AMP. NOISE FIGURE (dB)	ACC	REJ
-6	<u>43.1</u>	<u>-22.20</u>	<u>-24.10</u>	<u>1.90</u>	<u>3.3</u>	<u>3.5</u>	<u>8-1</u>	
+8	<u>43.1</u>	<u>-22.40</u>	<u>-24.30</u>	<u>1.90</u>	<u>3.3</u>	<u>3.5</u>	<u>8-1</u>	
+28	<u>43.2</u>	<u>-22.70</u>	<u>-24.60</u>	<u>1.90</u>	<u>3.3</u>	<u>3.5</u>	<u>8-1</u>	
+40	<u>43.3</u>	<u>-22.90</u>	<u>-24.75</u>	<u>1.85</u>	<u>3.4</u>	<u>3.5</u>	<u>8-1</u>	

Noise figure change 0.1 dB Spec is .5dB peak to peak on -20

ACC

REJ

NOTE: Above data to be taken with the Daden filter, except on the -19 unit.

NEΔT-NOISE POWER STABILITY TEST: ATP PARAGRAPH 5.4.9

Date: 8/23/98 Ambient Room Temperature °C: 24

Attach computer generated NEΔT spreadsheet to this test data sheet.

Record the calculated Nps(K) from spreadsheet data: 0.060

Record Nps(K) 0.07 for dash number from Aerojet specification AE-24869, Table II.
Accept units if calculated Nps(K) is less than or equal to specified Nps(K), otherwise reject.

ACC
8-1
REJ

DATE ACC REJ
8-25-98 8-1

PART NO. 1331562-115

SPACEK QA

SER NO. 7A41

TEST FAILURE:

TESTED BY: 404

FAILURE ANALYSIS NO. _____

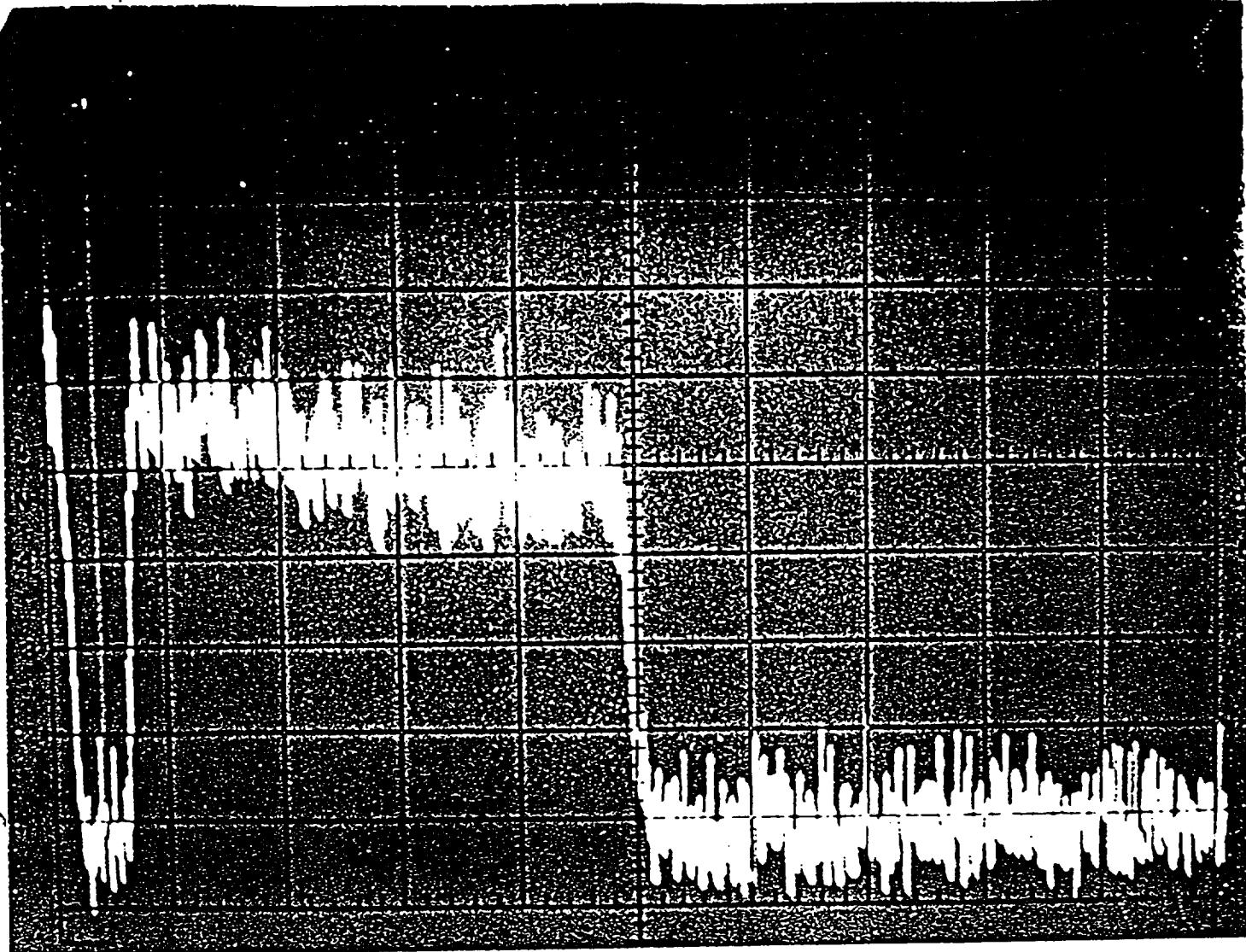
END DATE: 8-20-98

Spacek Labs, Inc.

END TIME: 1600

212 E. Gutierrez St.

Santa Barbara, CA, 93101



5.4.14 Noise Power Profile

Model No.: 1331562-11G

Serial No.: 7A41

Date: 8-25-98

Tested by: AB

Spectrum Analyzer Parameters

Vertical Scale: 2 dB/div.

Scan Width: 30 mhz/Div.

IF Band Width: 10 Khz

Scan Time: 3 sec/Div.

No video filter.



Channel 2 Mixer/Amplifier

Mixer/Amplifier (P/N: 1331562-12, S/N: 7A32)

TEST DATA SHEET NO. 6. AMPLIFIER TESTS

GAIN FLATNESS TEST: ATP PARAGRAPH 5.1.3

GAIN FLATNESS (dB)ppK	SPEC. GAIN FLATNESS (dB)ppK	ACC	REJ
<u>0.3</u>	<u>0.5</u>		—

GAIN VERSUS VOLTAGE SENSITIVITY TEST: ATP PARAGRAPH 5.1.4

AMPLIFIER VOLTAGE	GAIN READING (dBm)	$\Delta G/\Delta V$	SPEC. $\Delta G/\Delta V$	ACC	REJ
<u>9.96</u>	<u>70.72</u>	<u>2.13</u>	<u>2.0</u>		E&N CAMSU-1352
<u>10.00</u>	<u>70.80</u>				
<u>10.04</u>	<u>70.89</u>				
$\Delta G_V =$	<u>0.17</u> dB				

DATE ACC REJ

PART NO. 1331562-125

SPACEK QA

6-29-98



SER NO. 7A32

TEST FAILURE: _____

TESTED BY: 77H

FAILURE ANALYSIS NO. _____

END DATE: 6-5-98

Spacek Labs, Inc.
212 E. Gutierrez St.
Santa Barbara, CA, 93101

END TIME: 1600

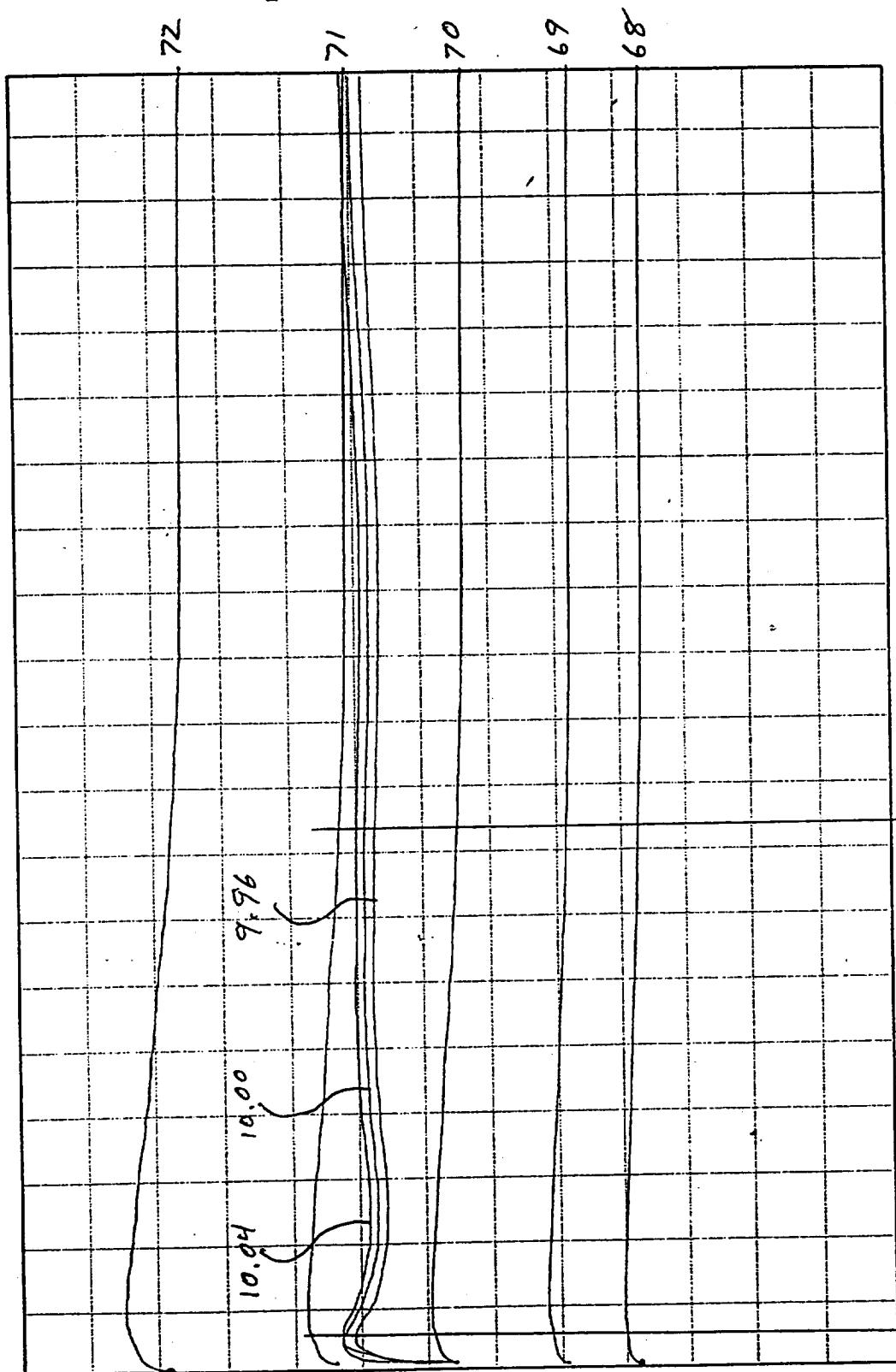


Amplifier Gain

Amb Temp +23°C

Amplifier Gain (db)

Model No. 1331562-12
Serial No. 7A32
Date 6-5-98
Tested By 272



TEST DATA SHEET NO. 7. AMPLIFIER TESTS

GAIN VERSUS TEMPERATURE SENSITIVITY TEST: ATP PARAGRAPH 5.1.5

Nominal Temperature (°C)	Relative Gain	ΔG/ΔT	SPEC	ACC	REJ
T1 -6	G _{T1} 71.38	* 0.014	0.035dB/°C	QA 1	
T2 +8	G _{T2} 71.19	* 0.022	0.020dB/°C		QA 1
T3 +28	G _{T3} 70.75	* 0.025	0.035dB/°C	QA 1	
T4 +40	G _{T4} 70.45				

ECN
CAMSU-1352

* Perform the following calculations and record on the TDS

$$\Delta G/\Delta T = \frac{G_{Ti} - G_{Ti+1}}{T_i - T_{i+1}} \quad i = 1, 2, 3, 4 \quad \Delta G_T = 0.93 \text{ dB}$$

$$\Delta G_{TOTAL} = \Delta G_V + \Delta G_T + 0.4 = 1.5 \text{ dB Spec 1.4dB} \quad ACC \quad REJ$$

ECN
CAMSU-1352

PART NO. 1331562-125

SPACEK QA

6-27-98

QA 1

DATE ACC REJ

SER NO. 7A32

TEST FAILURE: _____

TESTED BY: 778

FAILURE ANALYSIS NO. _____

END DATE: 6-5-98

Spacek Labs, Inc.
212 E. Gutierrez St.
Santa Barbara, CA, 93101

END TIME: 1600

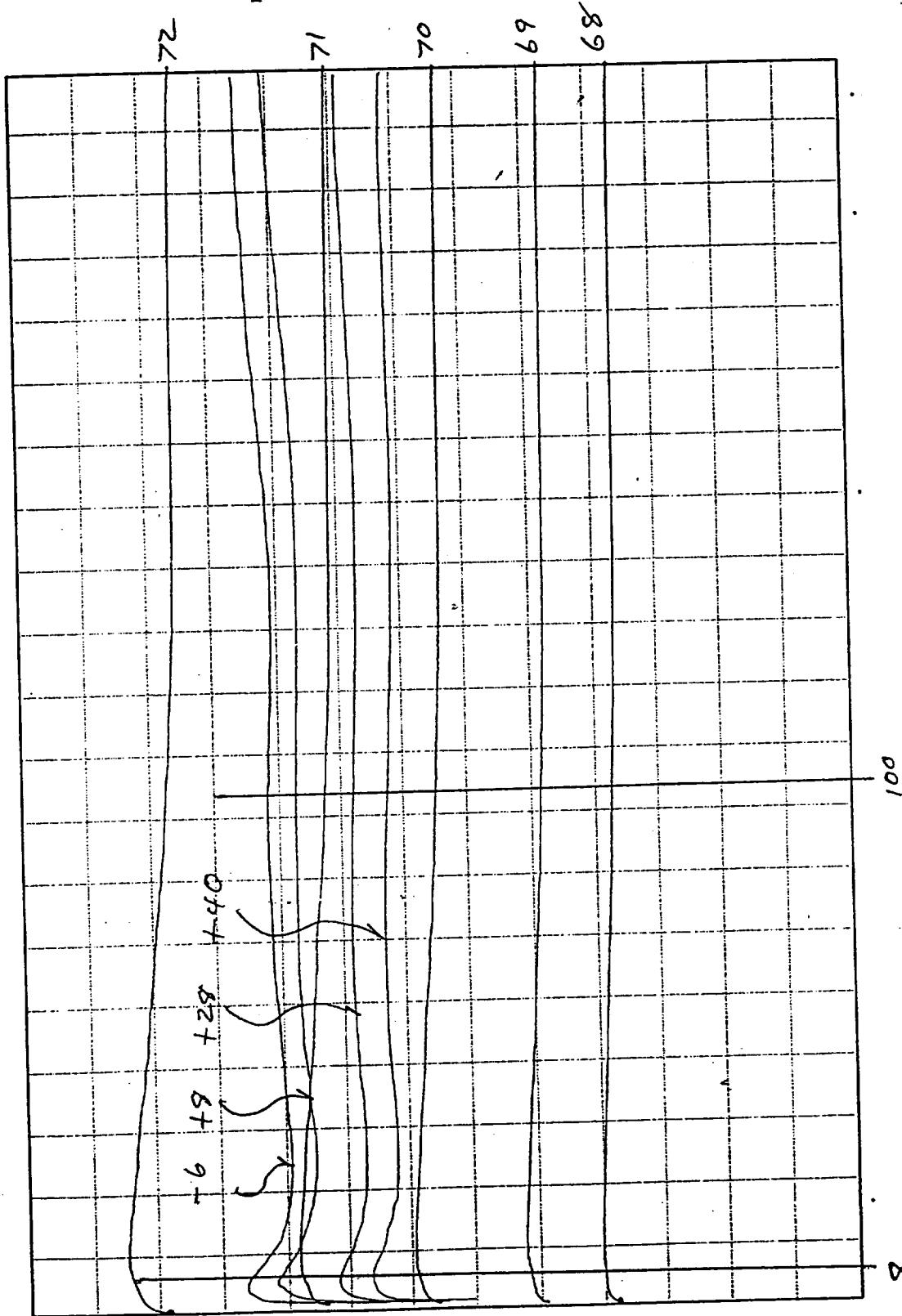


Amplifier Gain

Amb Temp $+23^{\circ}\text{C}$

Amplifier Gain (db)

Model No. 1331542-12
Serial No. 7A32
Date 6-5-98
Tested By 774



Frequency (MHz)

01
1

100

8

TEST DATA SHEET NO. 8. AMPLIFIER TESTS

OUTPUT 1.0 dB COMPRESSION POINT TEST: ATP PARAGRAPH 5.1.6

DASH #

11	12	13	14	15	16	17	18	19	20	FREQ. (MHz)	P2 COMP (dBm)	OUTPUT COMP. at+10(dBm)	SPEC. COMP.	ACC.	REJ.
X	X	X	X	X	X	X	X	X	X	10	-2.6	0.4	1.0	3 -	3 -
										20	-2				QA
										50	-2.7	0.3			QA -
										100	-2.5	0.5		V	5 -
X	X	X	X	X	X	X	X	X	X	150					
										200					
										400					
										500					
										X					
										1000					
										X					
										1500					

AMPLIFIER NOISE FIGURE AND TOTAL POWER TEST: ATP PARAGRAPH 5.1.7

DATE: 6-5-98 AMBIENT ROOM TEMPERATURE °C: 23°C

AMPLIFIER OUTPUT POWER AMBIENT (dBm)	AMPLIFIER OUTPUT POWER (-77 K)(dBm)	Y FACTOR (dB)	AMPLIFIER NOISE FIGURE (dB)
<u>-24.4</u>	<u>-29.1</u>	<u>3.7</u>	<u>1.11</u>

Above data taken with Daden filter attached (except -19).

Intermediate test results for information only

PART NO. 1331562-125

SPACEK QA

DATE 6-29-98 ACC 3 - REJ 3 -

SER NO. 7A32

TEST FAILURE: _____

TESTED BY: 77A

FAILURE ANALYSIS NO. _____

END DATE: 6-5-98

Spacek Labs, Inc.
212 E. Gutierrez St.
Santa Barbara, CA, 93101

END TIME: 1600

TEST DATA SHEET NO. 13. MIXER-AMPLIFIER ASSEMBLY TESTS

NOISE FIGURE, TOTAL POWER AND CURRENT VS. TEMPERATURE TEST:
ATP PARA 5.4.8.

DATE: 6-24-98 AMBIENT ROOM TEMPERATURE °C: +21

UUT TEMP °C.	UUT CURRENT	MIXER-AMP. OUTPUT POWER (AMBIENT) (dBm)	MIXER-AMP. OUTPUT POWER (77 DEG K) (dBm)	Y FACTOR (dB)	MIXER-AMP. NOISE FIGURE (dB)	SPEC. MIXER-AMP. NOISE FIGURE (dB)	ACC	REJ
-6	<u>43.4</u>	<u>-22.80</u>	<u>-24.80</u>	<u>2.0</u>	<u>3.1</u>	<u>3.2</u>	04	1
+8	<u>43.5</u>	<u>-23.00</u>	<u>-24.95</u>	<u>1.95</u>	<u>3.2</u>	<u>3.2</u>	04	1
+28	<u>43.7</u>	<u>-23.10</u>	<u>-25.10</u>	<u>1.90</u>	<u>3.2</u>	<u>3.2</u>	04	1
+40	<u>43.8</u>	<u>-23.60</u>	<u>-25.50</u>	<u>1.90</u>	<u>3.2</u>	<u>3.2</u>	04	1

Noise figure change 0.1 dB Spec is .5dB peak to peak on -20

ACC

REJ

NOTE: Above data to be taken with the Daden filter, except on the -19 unit.

NEΔT-NOISE POWER STABILITY TEST: ATP PARAGRAPH 5.4.9

Date: 6-23-98 Ambient Room Temperature °C: 25

Attach computer generated NEΔT spreadsheet to this test data sheet.

Record the calculated Nps(K) from spreadsheet data: 0.038

Record Nps(K) 0.07 for dash number from Aerojet specification AE-24869, Table II.
Accept units if calculated Nps(K) is less than or equal to specified Nps(K), otherwise reject.



REJ

DATE 6-23-98 ACC REJ

PART NO. 1331562-12F

SPACEK QA

SER NO. 7A32

TEST FAILURE: _____

TESTED BY: 778

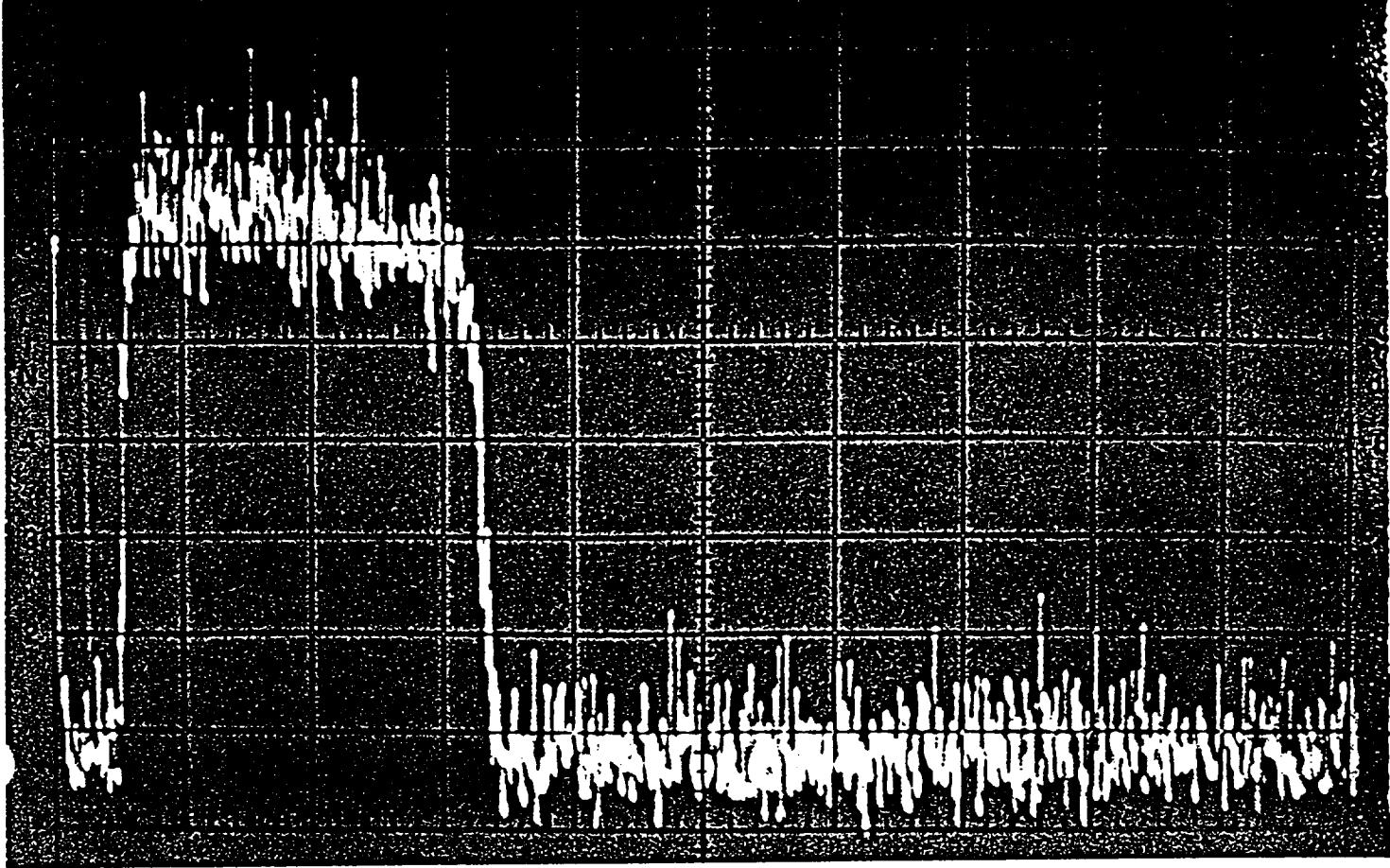
FAILURE ANALYSIS NO. _____

END DATE: 6-23-98

Spacek Labs, Inc.

END TIME: 1600

212 E. Gutierrez St.
Santa Barbara, CA, 93101



5.4.14 Noise Power Profile

Model No.: 1331562-12G

Serial No.: 7A92

Date: 6-29-98

Tested by: DK

Spectrum Analyzer Parameters

Vertical Scale: 2 dB/div.

Scan Width: 30 mhz/Div.

IF Band Width: 10 Khz

Scan Time: 3 sec/Div.



Report No. 11317
November 1998

SUBSYSTEM-LEVEL TEST DATA

CENTER FREQUENCY OF LOs

Channel No.	1	2
Specification (GHz) *	23.8	31.4
Setting Accuracy (+/-GHz)	0.008	0.008
Measured (GHz) **	23.8002	31.4004

* Specification in vacuum condition.

** Measured at ambient pressure (standard atmosphere).

Report No. 11317
November 1998

TEST DATA
FOR
AMSU-A2 (P/N: 1356441-1, S/N: F04)

TEST DATA SHEET 3
LO Frequency Test Data (Paragraph 3.5.1) (A2)

Test Setup Verified: D. J. Murray
Signature

Baseplate Temperature (T_B) 23.3 °C

Component	Channel No.	V_b (V)	I_b (mA)	P_{dc} (mW)			f_o (GHz)		
				Required (Max)	Measured	Pass/Fail	Required	Measured	Pass/Fail
LO	1	10.01	65.0	2,000	650.7	P	23.800 ± 0.008	23.800	P
	2	10.02	135.7	2,100	1359.7	P	31.400 ± 0.008	31.401	P
Mixer/ Amps	All	10.01	83.4	900	834.8				
TOTAL				5,000	2845.2				

Pass = P, Fail = F

Part No.: 1356441-1

Test Engineer: M. H. Murray

Serial No.: F04

Quality Assurance: W. D. Johnson OCT 22 98

Date: 10/20/98

FOR REFERENCE ONLY

<0 FREQUENCY , A2 , S/N : F04

HP REF 0.0 dBm

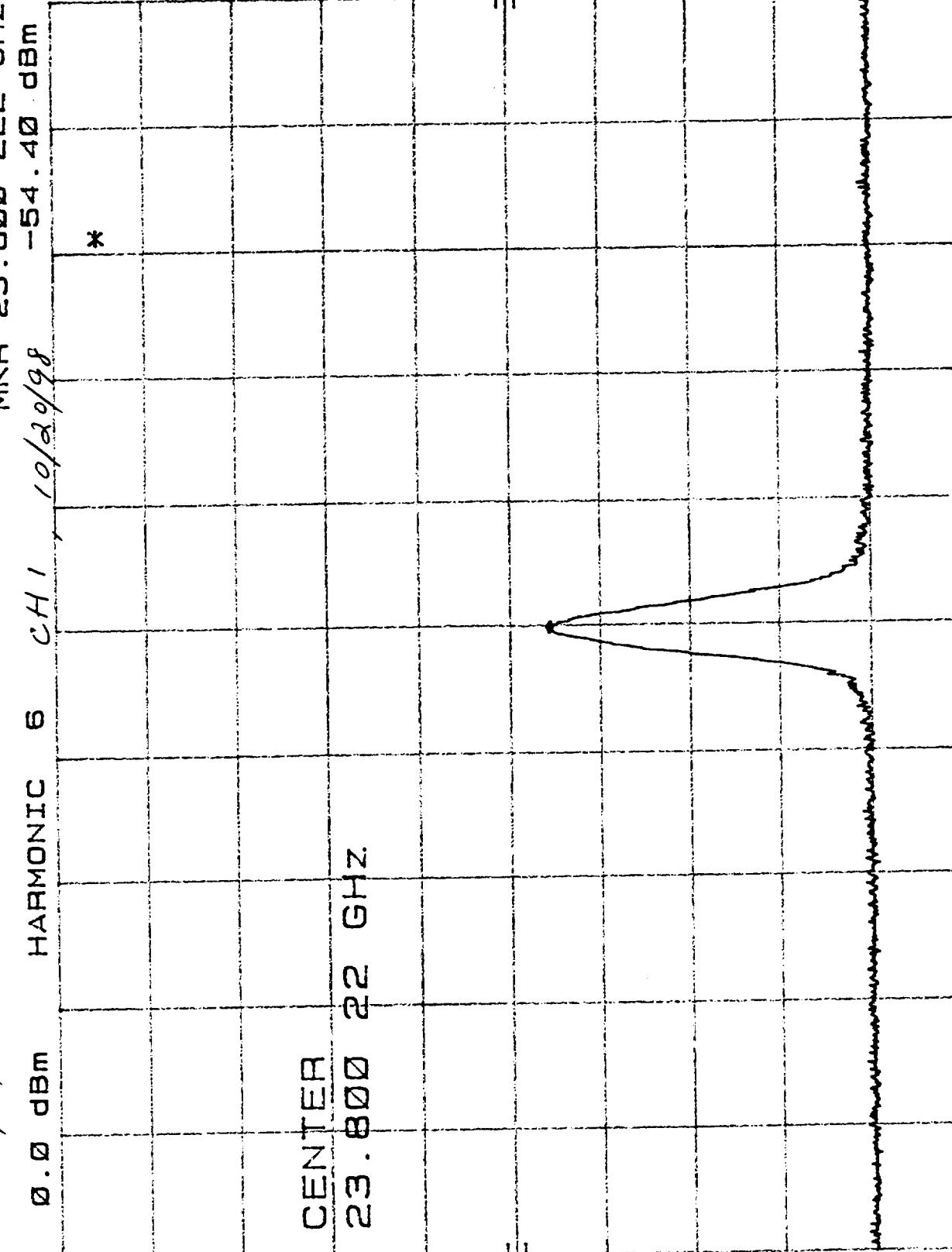
10 dB/

2.725

CNVLOSS
18.0
dB

CENTER

23.800 22 GHz

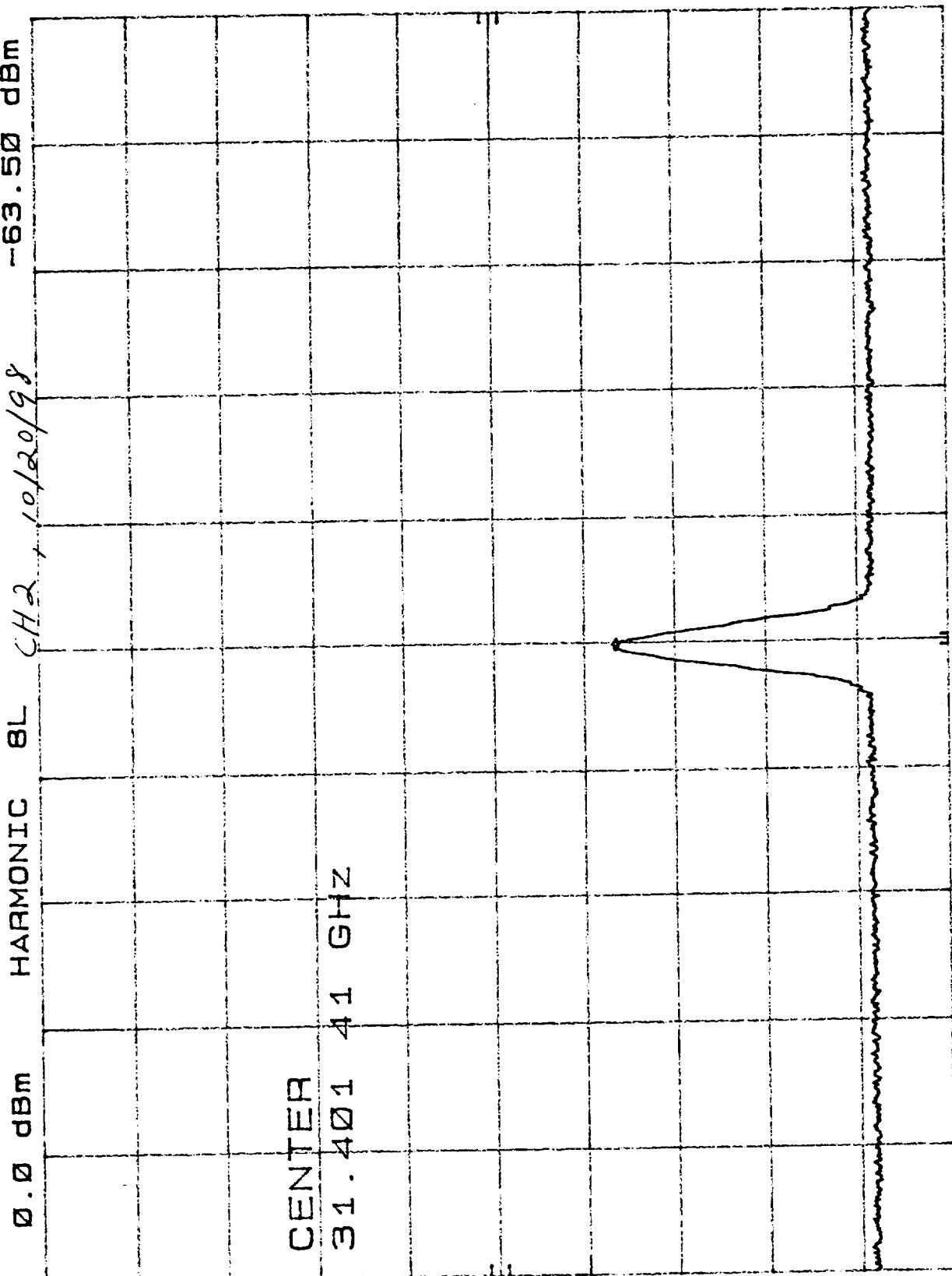


CENTER 23.800 22 GHz
RES BW 30 kHz
VBW 1 kHz

SPAN 1.99 MHz
SWP 1.00 sec

FOR REFERENCE ONLY

LO FREQUENCY , A2 , S/N : FO4



10 dB/

1.7m

CNVLOSS
20.0
dB

CENTER 31.401 41 GHz
RES BW 30 kHz

VBW 1 kHz

SPAN 2.00 MHz
SWP 200 msec

TEST DATA SHEET 6
IF Output Test Data (Paragraph 3.5.2) (A2)

Test Setup Verified: J. J. Hwy
Signature

Baseplate Temperature (T_B) -23.6 ^\circ C

Component	Channel No.	V_b (V)	I_b (mA)	P_o (dBm)	Atten (dB)	P_o (dBm)		
						Required	Measured	Pass/Fail
LO	1	10.01	65.0	-22.19	5	-27.0 ± 1.0	-27.21 -27.21 27.21	P
	2	10.02	135.7	-23.19	4	-27.0 ± 1.0	-27.26	P
Mixer/ Amps	All	10.01	83.4					

Pass = P, Fail = F

Part No.: 1356441-1

Test Engineer: J. J. Hwy

Serial No.: F04

Quality Assurance: W. H. H. OCT 22 '98

Date: 10/20/98

TEST DATA SHEET 9
Bandpass Characteristics Test Data (Paragraph 3.5.3) (A2)

Test Setup Verified: 7.7 my
Signature

Baseplate Temperature (T_B) 24.7 °C

Component	Channel No.	V_b (V)	I_b (mA)	3 dB BW Frequency (MHz)		3 dB BW Frequency (MHz)		Pass/Fail
				Lower	Higher	Required MAX.	Measured	
LO	1	10.02	65.1	8.6	133.9	135	125.23	P
	2	10.02	135.8	9.0	88.2	90	79.2	P
Mixer/Amps	All	10.01	83.4					

Component	Channel No.	V_b (V)	I_b (mA)	40 dB BW Frequency (MHz)		40 dB BW Frequency (MHz) (Ref. Only)		Pass/Fail
				Lower	Higher	Required MAX.	Measured	
LO	1	10.02	65.1	3.6	146.2	351	142.6	P
	2	10.02	135.8	3.6	99.0	234	95.4	P
Mixer/Amps	All	10.01	83.4					

Part No.: 1356441-1

Test Engineer: Phettay

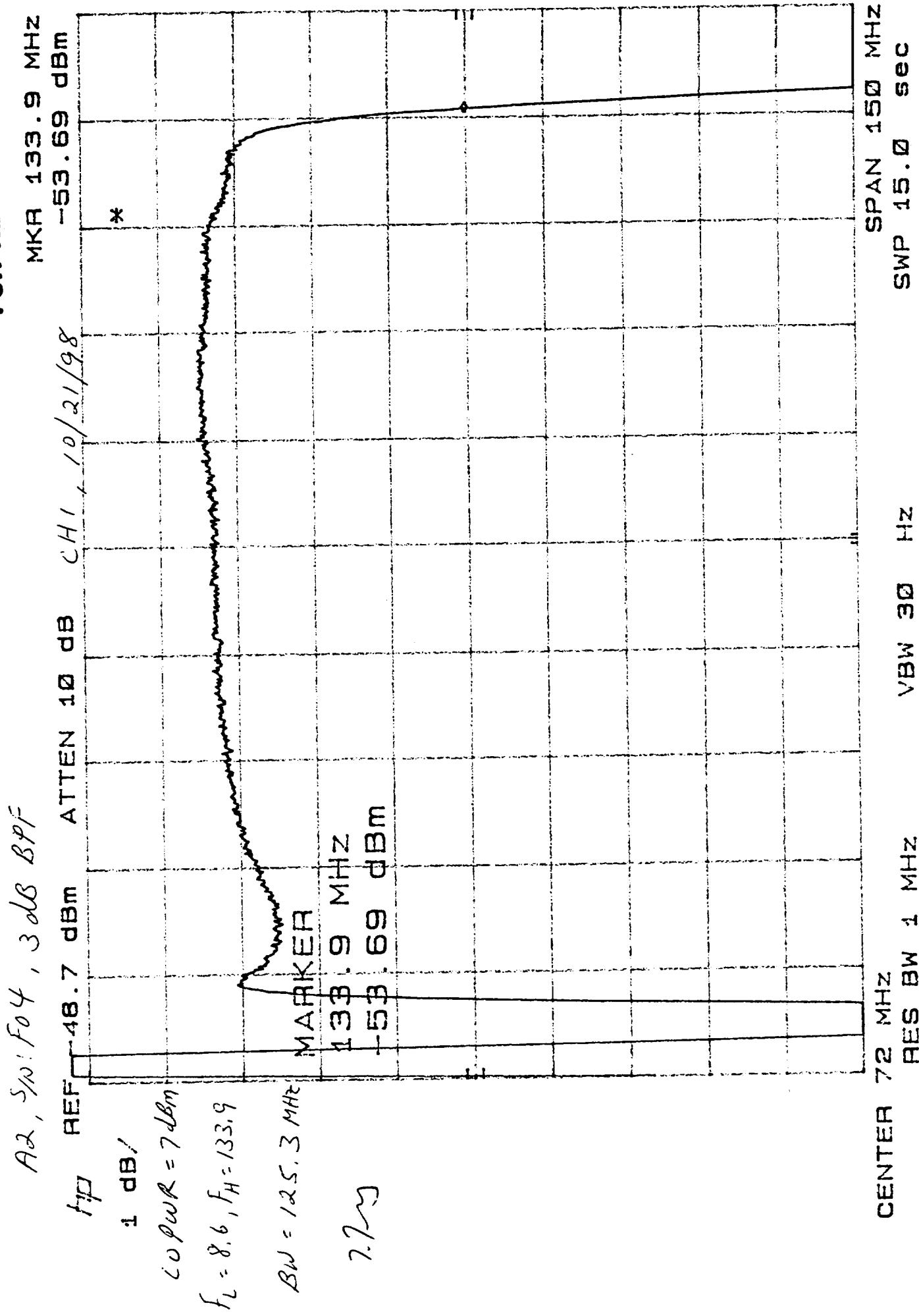
Serial No.: F04

Quality Assurance: [Signature]

Date: 10/21/98

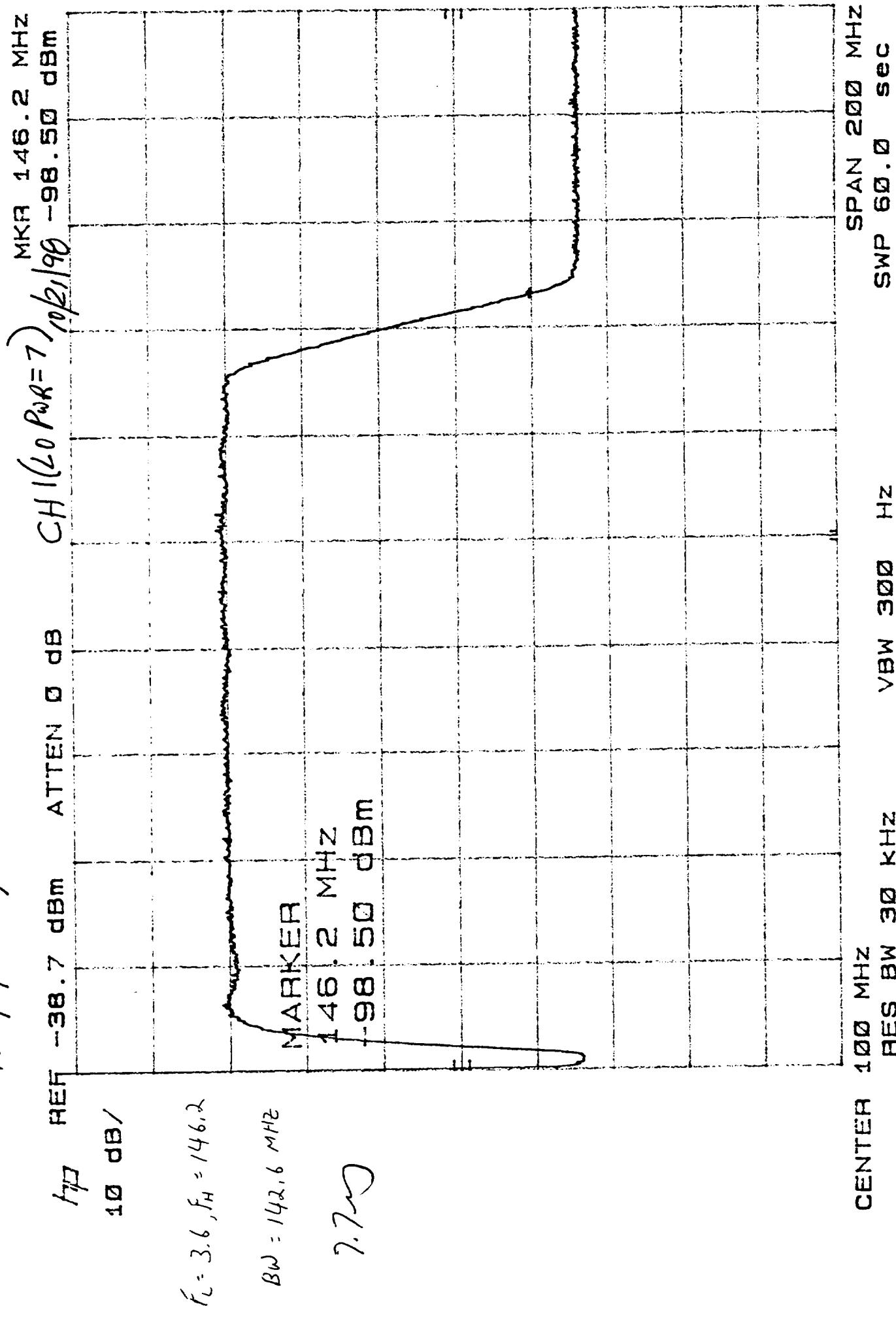
OCT 22 '98

FOR REFERENCE ONLY



A2, 5% F04, 40dB BPF

FOR REFERENCE ONLY



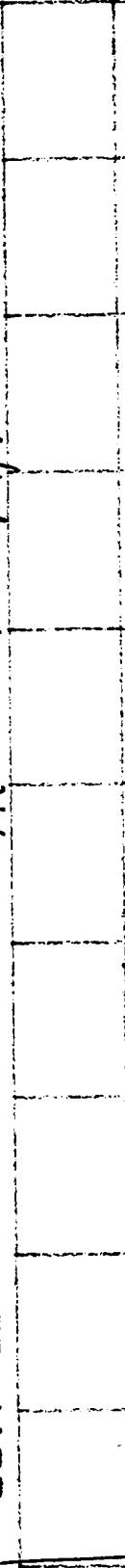
FOR REFERENCE ONLY

A2, 804 Stopband

10 dB/
REF

MKR 3.70 MHz

-98.90 dBm



2.7 mJ

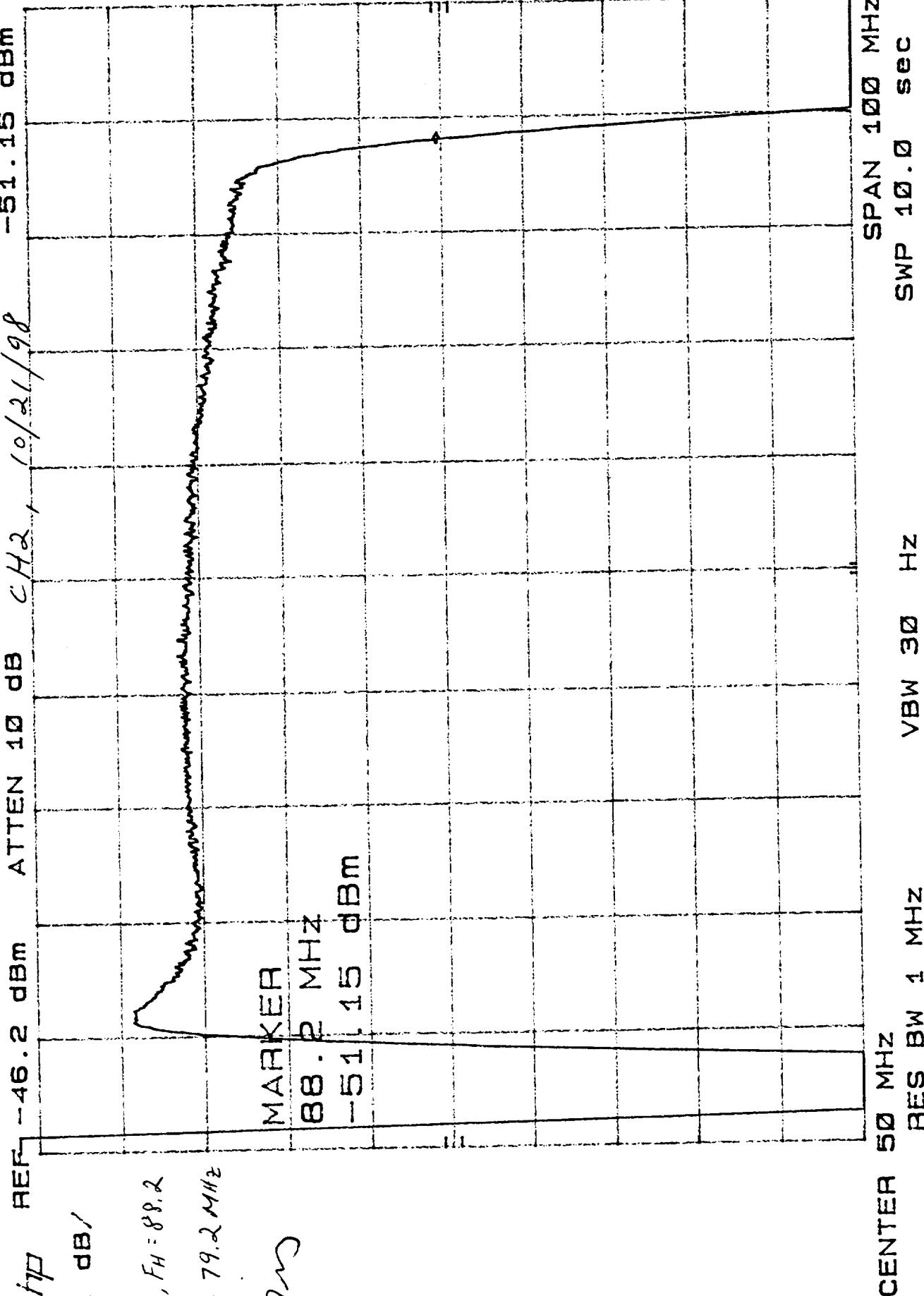
MARKER
3.70 MHz
-98.90 dBm

START 0 Hz
STOP 10.0 MHz
RES BW 30 kHz
SWP 3.00 sec

FOR REFERENCE ONLY

A2, S/N: F04, 3 dB BPF

1 dB/
rpt



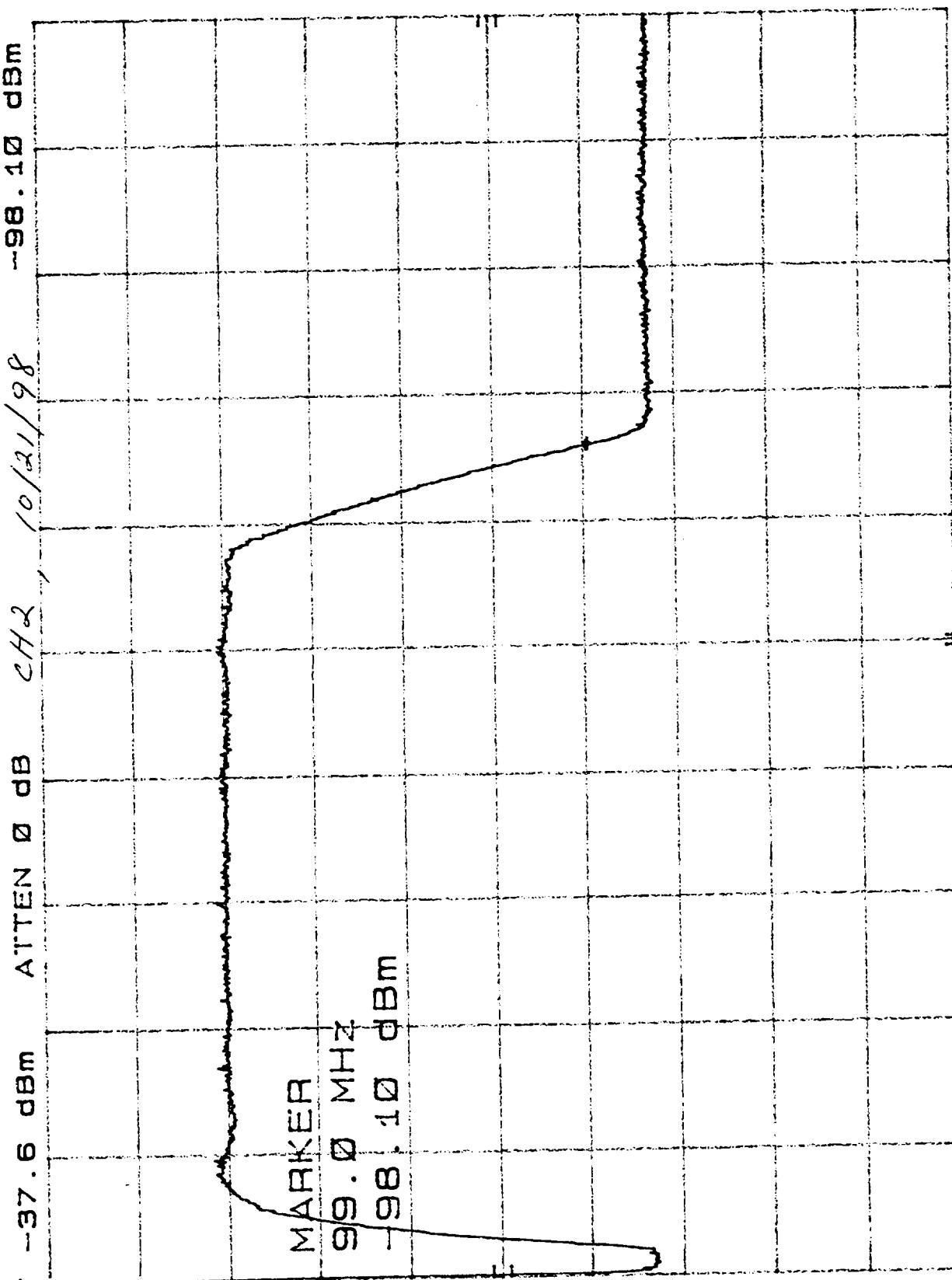
$$f_L = 9.0, f_H = 88.2$$

$$BW = 79.2 \text{ MHz}$$

7.7 m

FOR REFERENCE ONLY

A2, S/N: 504, 40 dB BPF



10 dB /

$f_L = 3.6, f_H = 99.0$

$BW = 95.4 \text{ kHz}$

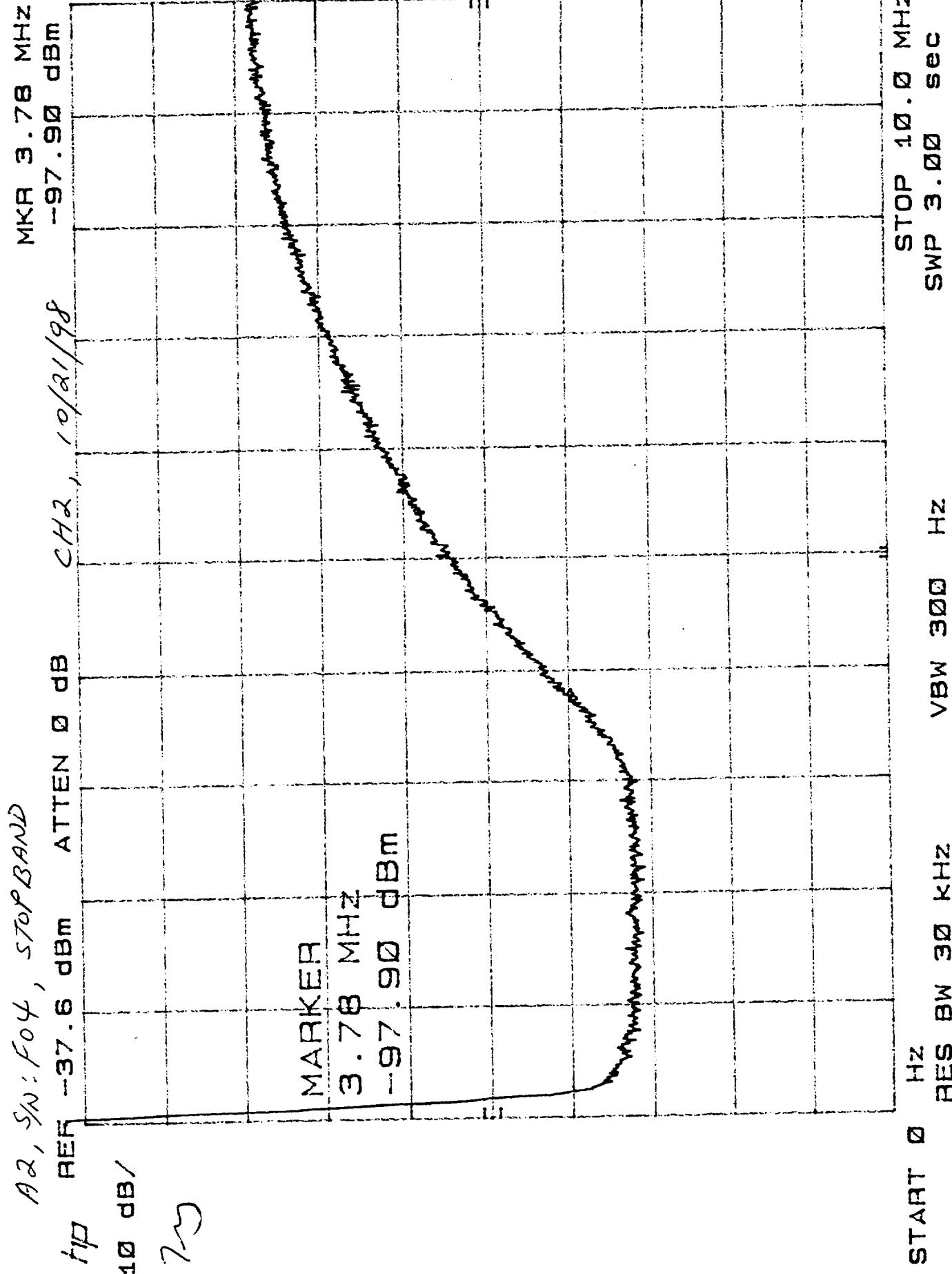
7.7 mJ

CENTER 75 MHz
RES BW 30 kHz
VBW 300 Hz
SPAN 150 MHz
SWP 45.0 sec

FOR REFERENCE ONLY

A2, SW: F04, STOPBAND

10 dB/
2.75



STOP 10.0 MHz
SWP 3.00 sec

TEST DATA SHEET 12 (Sheet 1 of 4)
Noise Figure and Noise Power Stability Test Data (Paragraph 3.5.4) (A2)

Test Setup Verified: 7.7mW Baseplate Temperature (T_B) 25.7 °C
Signature

Component	Channel No.	V_b (V)	I_b (mA)	T_H (°C)	V_H (V)		T_C (°C)	V_C (V)	
					Mean	Standard Deviation		Mean	Standard Deviation
LO	1	10.02	65.1	23.0	-93075	.00021	-194.0	-67299	.00018
					-93058	.00023	-194.0	-67059	.00016
					-93051	.00023	-194.0	-67267	.00018
					-93078	.00024	-194.0	-67135	.00017
					-93054	.00020	-194.0	-67274	.00017
					-93067	.00020	-194.0	-67186	.00015
					-93092	.00021	-194.0	-67299	.00016
					-93094	.00022	-194.0	-67255	.00013
					-93078	.00020	-194.0	-67195	.00017
					-93092	.00021	-194.0	-67151	.00016
Mixer/Amps	All	10.01	83.4						
IF Amps	All	N/A	N/A						

Part No.: 1356441-1

Test Engineer: Hether

Serial No.: F04

Quality Assurance: in progress OCT 22 '98

Date: 10/21/98

TEST DATA SHEET 12 (Sheet 3 of 4)
Noise Figure and Noise Power Stability Test Data (Paragraph 3.5.4) (A2)Test Setup Verified: J. Dunn
SignatureBaseplate Temperature (T_B) 25.7 °C

Channel No.	NF (dB)				NPS (K)				
	Required (Max)	Measured	Average	Pass/Fail	Required (Max)	Measured	Average	Delta	Pass/Fail
1		4.28			0.03				
		4.24			0.08				
		4.28			0.07				
		4.25			0.09				
		4.28			0.04				
		4.26			0.04				
		4.28			0.02				
		4.27			0.07				
		4.26			0.04				
		4.26			0.02				
	4.5		4.27	P	0.09		0.05	0.077	P

Pass = P, Fail = F

Part No.: 1356441-1Test Engineer: HunterSerial No.: F04Quality Assurance: John G. Campbell OCT 22 '98Date: 10/21/98

FOR REFERENCE ONLY

AMSU-A TEST

AMSU-A2, S/N: F04, CH1, LO POWER=7.1 dBm, NF & NPS DATA, TB=25.7C, 10/21/98

SEQ	TEMP_TEST	TEST TEMP	VOLTAGE	STD_DEV	NF (dB)	NPS(K)
1	WARM TEST	296.15	-.93075367	.00020665	-----	-----
2	COLD TEST	79.15	-.67298859	.00018073	4.28250247	.02730919
3	WARM TEST	296.15	-.93057793	.00023029	-----	-----
4	COLD TEST	79.15	-.67058927	.00016283	4.24407642	.08045363
5	WARM TEST	296.15	-.93050567	.00022503	-----	-----
6	COLD TEST	79.15	-.67267258	.00018075	4.28018131	.06991896
7	WARM TEST	296.15	-.93078297	.00023832	-----	-----
8	COLD TEST	79.15	-.67134821	.00016505	4.25437701	.09550154
9	WARM TEST	296.15	-.93054189	.00020375	-----	-----
10	COLD TEST	79.15	-.67274166	.00016513	4.28090963	.03970158
11	WARM TEST	296.15	-.93066635	.00020400	-----	-----
12	COLD TEST	79.15	-.67186366	.00015227	4.26450671	.03871695
13	WARM TEST	296.15	-.93091818	.00020808	-----	-----
14	COLD TEST	79.15	-.67298522	.00016017	4.28042629	.01838761
15	WARM TEST	296.15	-.93094441	.00022390	-----	-----
16	COLD TEST	79.15	-.67254876	.00012664	4.27270442	.06693901
17	WARM TEST	296.15	-.93078286	.00020428	-----	-----
18	COLD TEST	79.15	-.67194706	.00017051	4.26449457	.03778497
19	WARM TEST	296.15	-.93091786	.00020783	-----	-----
20	COLD TEST	79.15	-.67150655	.00015817	4.25540717	.02013159

CH. 1 ,125.3 MHz MHz .

NOISE FIGURE AVERAGE (dB) = 4.2679775064

NOISE POWER STABILITY (K) = .0494855036981

NOISE POWER STABILITY DELTA (K) = .0771139279986

NPS_MAX (K) = .09550154213 NPS_MIN (K) = .0183876141314

INTEGRATION TIME = .158

10 June 1998

TEST DATA SHEET 12 (Sheet 2 of 4)
Noise Figure and Noise Power Stability Test Data (Paragraph 3.5.4) (A2)

Test Setup Verified: 7.2mV
Signature

Baseplate Temperature (T_B) 25.7 °C

Component	Channel No.	V_b (V)	I_b (mA)	T_H (°C)	V_H (V)		T_C (°C)	V_C (V)	
					Mean	Standard Deviation		Mean	Standard Deviation
LO	2	10.02	135.8	23.0	-88289	.00027	-194.0	-59431	.00024
				23.0	-88220	.00024	-194.0	-59435	.00024
				23.0	-88172	.00026	-194.0	-59412	.00021
				23.0	-88166	.00028	-194.0	-59461	.00023
				23.0	-88149	.00025	-194.0	-59374	.00025
				23.0	-88150	.00028	-194.0	-59527	.00020
				23.0	-88125	.00027	-194.0	-59342	.00018
				23.0	-88153	.00022	-194.0	-59294	.00020
				23.0	-88133	.00027	-194.0	-59392	.00026
				23.0	-88153	.00024	-194.0	-59408	.00021
Mixer/Amps	All	10.01	83.4						
IF Amps	All	N/A	N/A						

Part No.: 1356441-1Test Engineer: HartleySerial No.: F04Quality Assurance: QA Manager OCT 22 98Date: 10/21/98

TEST DATA SHEET 12 (Sheet 4 of 4)
Noise Figure and Noise Power Stability Test Data (Paragraph 3.5.4) (A2)

Test Setup Verified: <u>J. J. New</u> Signature				Baseplate Temperature (T_B) <u>25.7 °C</u>					
Channel No.	NF (dB)			NPS (K)					
	Required (Max)	Measured	Average	Pass/Fail	Required (Max)	Measured	Average	Delta	Pass/Fail
2		3.56				0.08			
		3.56				0.06			
		3.57				0.05			
		3.57				0.09			
		3.56				0.03			
		3.59				0.10			
		3.56				0.07			
		3.55				0.08			
		3.57				0.08			
		3.57				0.05			
	3.95		3.57	P	0.09		0.07	0.067	P
Pass = P, Fail = F									
Part No.: <u>1356441-1</u>	Test Engineer: <u>Phatay</u>								
Serial No.: <u>F04</u>	Quality Assurance: <u> </u>								
Date: <u>10/21/98</u>									

FOR REFERENCE ONLY

AMSU-A TEST

AMSU-A2, S/N: F04, CH2, NF & NPS DATA, TB = 25.7 C, 10/21/98

SEQ	TEMP_TEST	TEST TEMP	VOLTAGE	STD_DEV	NF (dB)	NPS(K)
1	WARM TEST	296.15	-.88288601	.00027115	-----	-----
2	COLD TEST	79.15	-.59431112	.00024391	3.55566048	.07969987
3	WARM TEST	296.15	-.88219801	.00023707	-----	-----
4	COLD TEST	79.15	-.59439313	.00023584	3.56495555	.05836065
5	WARM TEST	296.15	-.88171541	.00025949	-----	-----
6	COLD TEST	79.15	-.59411625	.00020567	3.56569121	.05445363
7	WARM TEST	296.15	-.88166028	.00027655	-----	-----
8	COLD TEST	79.15	-.59461455	.00023262	3.57386049	.09058862
9	WARM TEST	296.15	-.88148899	.00025259	-----	-----
10	COLD TEST	79.15	-.59373968	.00025359	3.56227756	.03117418
11	WARM TEST	296.15	-.88149773	.00028110	-----	-----
12	COLD TEST	79.15	-.59527214	.00019978	3.58559413	.08861723
13	WARM TEST	296.15	-.88124573	.00026657	-----	-----
14	COLD TEST	79.15	-.59341662	.00018449	3.55985227	.07173872
15	WARM TEST	296.15	-.88152986	.00022482	-----	-----
16	COLD TEST	79.15	-.59293577	.00020273	3.54963036	.08082976
17	WARM TEST	296.15	-.88133487	.00026823	-----	-----
18	COLD TEST	79.15	-.59391763	.00026212	3.56657270	.07503417
19	WARM TEST	296.15	-.88153157	.00024048	-----	-----
20	COLD TEST	79.15	-.59408297	.00021343	3.56707262	.04934157

CH. 2 ,79.2 MHz MHz

NOISE FIGURE AVERAGE (dB) = 3.56522651574

NOISE POWER STABILITY (K) = .0689838378223

NOISE POWER STABILITY DELTA (K) = .0674430491914

NPS_MAX (K) = .0986172251355 NPS_MIN (K) = .0311741759441

INTEGRATION TIME = .158

TEST DATA SHEET 18
Temperature Sensor and Thermistor Test Data (Paragraph 3.6.1) (A2)

Test Setup Verified: 7.7.98
Signature

Baseplate Temperature (T_B) 22.3 °C

Reference Designation	Specification	Measured Value	Pass/Fail
RT 12	$2200 \pm 100 \Omega$	2166 Ω	P
RT 19	$2200 \pm 100 \Omega$	2168 Ω	P
RT 20	$2200 \pm 100 \Omega$	2170 Ω	P
RT 13	$2200 \pm 100 \Omega$	2169 Ω	P
RT 14	$2200 \pm 100 \Omega$	2172 Ω	P
RT 17	$2200 \pm 100 \Omega$	2168 Ω	P
TB 58	$3000 \pm 100 \Omega$	3013 Ω	P
TB 59	$3000 \pm 100 \Omega$	3002 Ω	P
TB 53	4.1 – 4.6 V	4.34 V	P

Pass = P, Fail = F

Part No.: 1356441-1

Test Engineer: H. H. H.

OCT 22 1998

Serial No.: F04

Quality Assurance: H. H. H.

Date: 10/20/98 S

TEST DATA SHEET 22
Survival Heater and Thermal Switch Test Data (Paragraph 3.6.3) (A2)

Test Setup Verified: 7.7 revs
Signature

Baseplate Temperature (T_B) 22.4 °C

Reference Designation	Open Switch		Closed Switch		
	>10 MΩ	Pass/Fail	Specification	Measured Value	Pass/Fail
HR1/TS1	50MΩ	P	50 - 65 Ω	58.3	P
	50MΩ	P		58.1	P
HR2/TS2	50MΩ	P		55.1	P
	50MΩ	P		55.4	P

Pass = P, Fail = F

Part No.: 1356441-1
Serial No.: F04

Test Engineer: Rehilly
Quality Assurance: Rehilly OCT 22 '98
Date: 10/20/98

TEST DATA SHEET 23 (Sheet 3 of 3)
Bias Voltage Verification Test Data (Paragraph 3.6.4) (A2)

Test Setup Verified: J. Juno
Signature

Baseplate Temperature (T_B) 22.5 °C

Reference Designation	Specification	Measured Value (V)	Pass/Fail
Mixer/IF AMP Ch 1, 2	+10 ±0.1	10.00	P
DRO Ch 1	+10 ±0.1	10.01	P
DRO Ch 2	+10 ±0.1	10.01	P

Part No.: 1356441-1

Serial No.: F04

Test Engineer: J. Juno

Quality Assurance: W. Miller Oct 22 98

Date: 10/20/98

GENCORP AEROJET	MANUFACTURING ASSEMBLY INSTRUCTIONS (M.A.I.)						PAGE	OF
	PART DESCRIPTION RECEIVER ASSEMBLY (A2)			PART NUMBER 1356441-1		1	4	
PLANNED BY B. MULLIGAN	DATE 6/4/98	REVISION 01	NEXT ASSEMBLY 1356006-1/1331200-2		OPER 0004			

ASSEMBLY INSTALLATION AND REPLACEMENT LOG

INITIAL INSTALLATION							REPLACEMENT			
ITEM NO.	PART NUMBER	REV	DESCRIPTION	S/N	MFG	INSP	REV	S/N	MFG	IN.
5	1331084-1	F	DIPLEXER, 3 PORT	05	MFG 155 7/10/98					
7	1331100-1	D	WAVEGUIDE ATTENUATOR	102 101	MFG 161 7/16/98					
8	1331100-2	E	WAVEGUIDE ATTENUATOR	104	MFG 155 7/16/98					
9	1331111-2	G	ISOLATOR	006	MFG 155 7/16/98					
10	1331112-2	G	ISOLATOR	007	MFG 155 7/16/98					
16	1336610-1	E	STABLE OSCILLATOR	87060 87077	MFG 161 7/16/98					
17	1336610-2	E	STABLE OSCILLATOR	87056 9821	MFG 161 7/16/98					
19	1331559-3	E	IF BAND PASS FILTER	P229- 008	MFG 155 7-11-98					
20	1331559-6	E	IF BAND PASS FILTER	P232- 006	MFG 155 7/25/98					
21	1331562-11		MIXER/AMP, CHAN 1	7A41	MFG 155 9-29-98					
22	1331562-12	G	MIXER/AMP, CHAN 2	7A32	MFG 155 7/16/98					
29	1337640-4	N/A	THERMOFOIL HEATER	HR15IN 0024 HR25IN 0029	MFG 155 7/25/98					

NOTES:

1. THIS LOG SHALL BE COMPLETED AT THE TIME THAT THE COMPONENT(S) OR PART(S) ARE BEING INSTALLED INTO THE ASSEMBLY. EACH LINE SHALL BE ENTERED AND STAMPED BY THE OPERATOR THAT INSTALLED THE COMPONENT(S) OR PART(S).
2. IF A COMPONENT(S) OR PART(S) ARE REMOVED AND REPLACED, RECORD THE REPLACEMENT PART ON IT'S RESPECTIVE LINE.
3. IF A COMPONENT(S) OR PART(S) HAVE BEEN REMOVED AND REPLACED MORE THAN ONCE, RECORD THE REPLACEMENT P. NUMBER AT THE END OF THE ASSEMBLY LOG.

FORMS

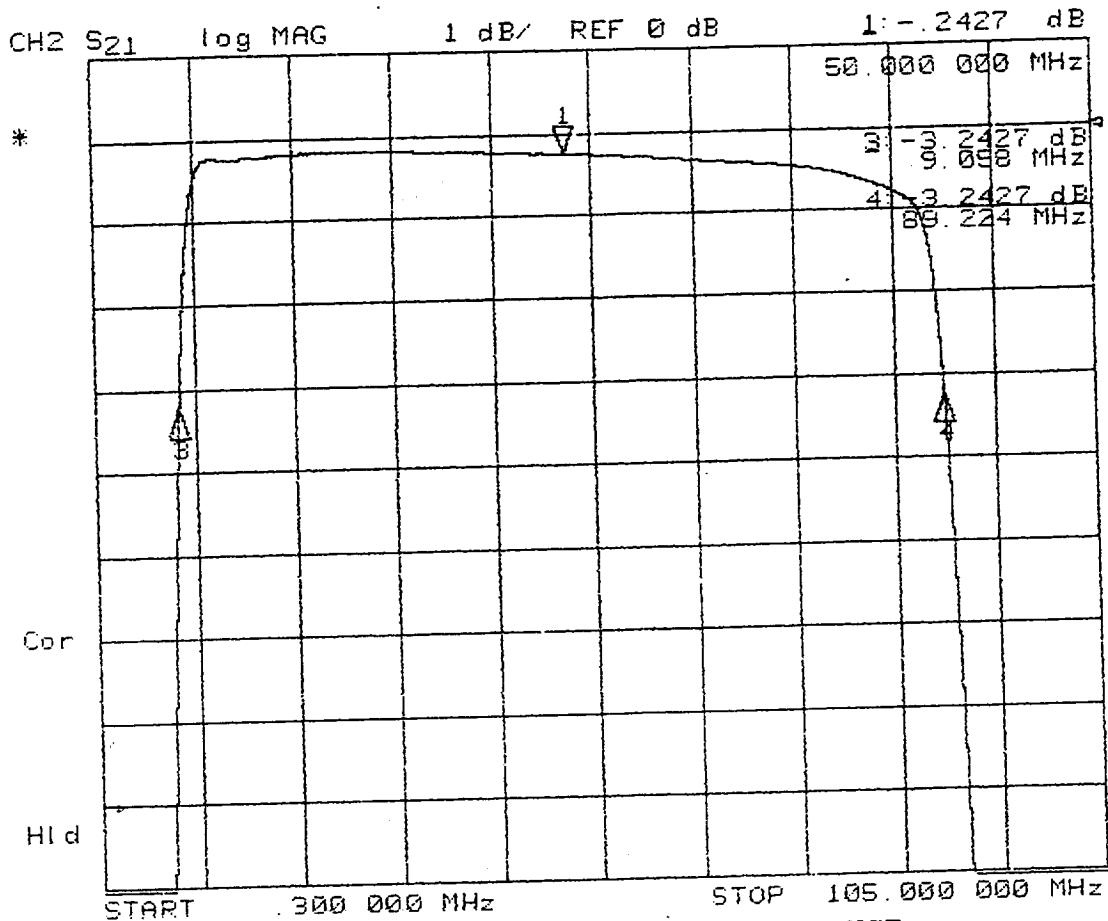


National Aeronautics and
Space Administration

Report Documentation Page

1. Report No. ---	2. Government Accession No. ---	3. Recipient's Catalog No. ---	
4. Title and Subtitle Integrated Advanced Microwave Sounding Unit-A (AMSU-A), Performance Verification Report		5. Report Date November 1998	
		6. Performing Organization Code ---	
7. Author(s) R. Kapper		8. Performing Organization Report No. 11317	
		10. Work Unit No. ---	
9. Performing Organization Name and Address Aerojet 1100 W. Hollyvale Azusa, CA 91702		11. Contract or Grant No. NAS 5-32314	
		13. Type of Report and Period Covered Final	
12. Sponsoring Agency Name and Address NASA Goddard Space Flight Center Greenbelt, Maryland 20771		14. Sponsoring Agency Code ---	
15. Supplementary Notes ---			
16. ABSTRACT (Maximum 200 words) This is the Performance Verification Report, METSAT AMSU-A2 Receiver Assembly (P/N 1356441-1, S/N F04) S/N 107, for the Integrated Advanced Microwave Sounding Unit-A (AMSU-A).			
17. Key Words (Suggested by Author(s)) EOS Microwave System		18. Distribution Statement Unclassified --- Unlimited	
19. Security Classif. (of this report) Unclassified	20. Security Classif. (of this page) Unclassified	21. No. of pages ---	22. Price ---

NASA FORM 1626 OCT 86



FINAL FUNCTIONAL PERFORMANCE

TRANSMISSION LOSS

SERIAL NO. P229-008

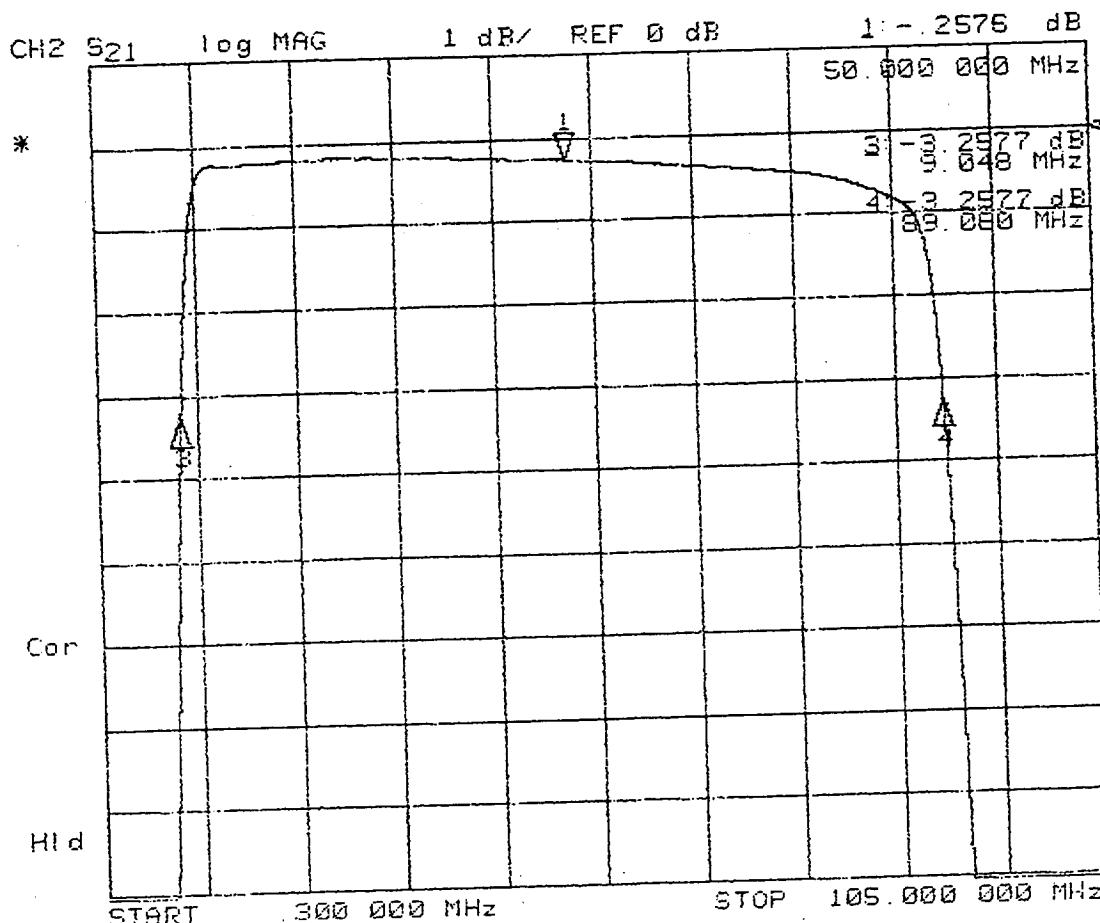
+15C DATA

OPR: R. HOGGATT DATE DEC 18 1996

MARKER PARAMETERS

MARKER 1	14.000000 MHz	50.000000 MHz
	OFF	- .2427 dB
MARKER 2	86.000000 MHz	49.141672 MHz
	OFF	OFF
MARKER 3	20.000000 MHz	9.058860 MHz
	OFF	-3.2427 dB
MARKER 4	80.000000 MHz	89.224484 MHz
	OFF	-3.2427 dB
MKR STIMULUS OFFSET	0.000000 MHz	89.425802 MHz
	0 dB	-3.2342 dB

REFERENCE MARKER PLACEMENT	OFF	OFF
MARKER SEARCH	CONTINUOUS	CONTINUOUS
TARGET VALUE	OFF	OFF
MARKER WIDTH VALUE	-14 dB	-3 dB
MARKER TRACKING	-3 dB	-3 dB
	OFF	OFF
	OFF	OFF



FINAL FUNCTIONAL PERFORMANCE
TRANSMISSION LOSS
SERIAL NO. P229-008

+40C DATA

OPR: R. HOGGATT DATE DEC 18 1996

MARKER PARAMETERS

MARKER 1	14.000000 MHz OFF	50.000000 MHz .2576 dB
MARKER 2	86.000000 MHz OFF	49.054793 MHz OFF
MARKER 3	20.000000 MHz OFF	9.048819 MHz -3.2577 dB
MARKER 4	80.000000 MHz OFF	89.060767 MHz -3.2577 dB
MKR STIMULUS OFFSET	0.000000 MHz 0 dB	89.425802 MHz -3.2342 dB

REFERENCE MARKER PLACEMENT	OFF	OFF
MARKER SEARCH	CONTINUOUS	CONTINUOUS
TARGET VALUE	OFF	OFF
MARKER WIDTH VALUE	-14 dB	-3 dB
MARKER TRACKING	-3 dB	-3 dB
	OFF	OFF
	OFF	OFF

APPENDIX CACCEPTANCE TEST REPORTBANDPASS FILTER MODEL HL50-80-10SS1 S/N P229-008
AEROJET 1331559-3 REV. EPASSBAND RIPPLE (CON'T)

{11f} RECORD PASS/FAIL (0.5 dB MAX)

PASS/FAILPASS/FAILPASS/FAIL{11g) ATTACH PASSBAND RIPPLE
PERFORMANCE X-Y PLOT(S)}✓(√)✓(√)✓(√)OUT-OF-BAND REJECTION

ACCEPTANCE TEST PROCEDURE

-10°C

+15°C

+40°C

63-0005-02 PARA 4.5.5

Fc=50.0 MHz.

REF {5A} FOR INSERTION LOSS @ Fc

{12} WORST CASE REJECTION FROM
0.300 MHz TO 1.0 MHz>100 dB
(40.0 dB MIN)>100 dB
(40.0 dB MIN)>100 dB
(40.0 dB MIN){13a} WORST CASE REJECTION FROM
102.0 MHz TO 1000.0 MHz-57.6 dB
(40.0 dB MIN)-57.8 dB
(40.0 dB MIN)-57.8 dB
(40.0 dB MIN)

{13c} RECORD MEASURED TEMPERATURE

-12.9 °C
(-15.0 TO -10.0)+14.3 °C
(12.5 TO 17.5)+42.8 °C
(40.0 TO 45.0){14} ATTACH REJECTION PERFORMANCE
X-Y PLOT(S)✓(√)
✓(√)✓(√)
✓(√)✓(√)
✓(√)TEST PERFORMED BY R. HOGGATT DATE 12/18/91NOTE IF TEST WITNESSED BY AESD: Not witnessed
this time. DLD

***** END OF FUNCTIONAL PERFORMANCE TEST *****

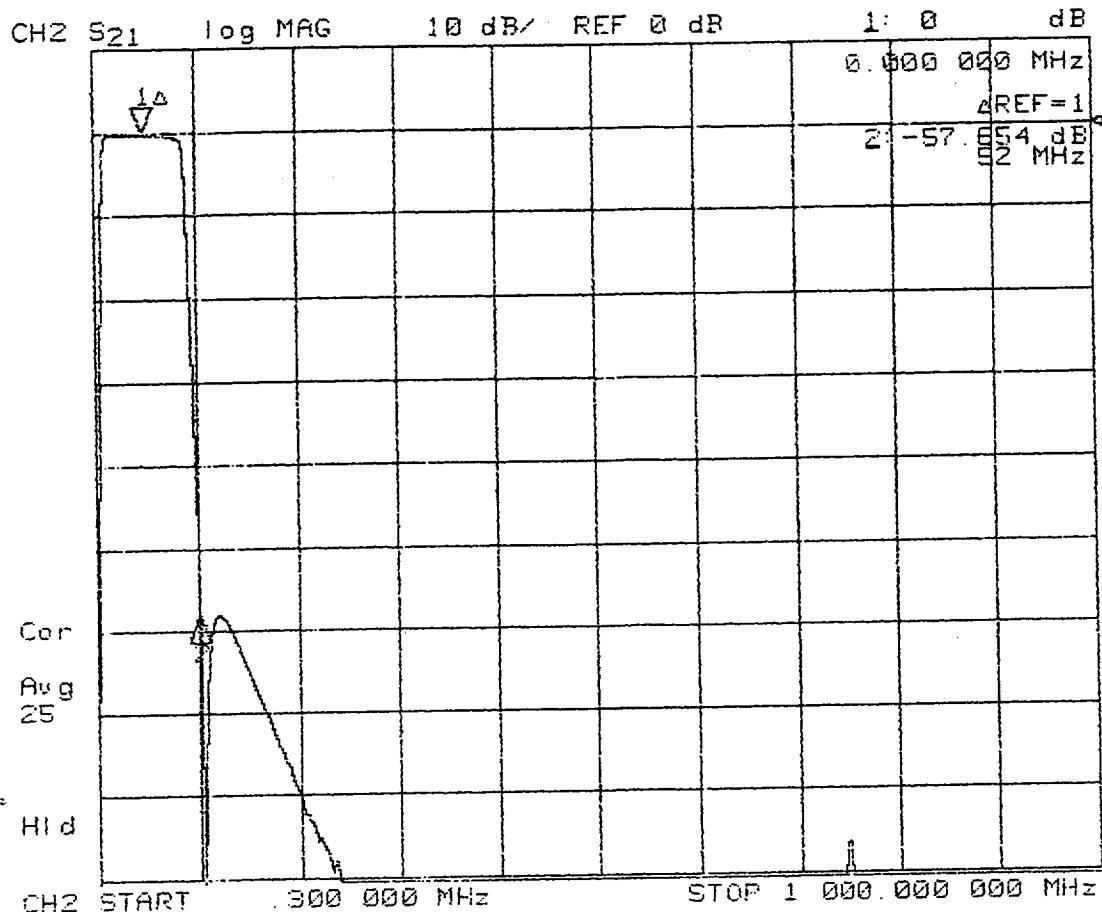
OUTLINE AND MOUNTING DIMENSIONS VERIFICATION

{16} REFERENCE CUSTOMER DRAWING 1331559

DESCRIPTION OF MEASUREMENT	DIMENSION AND TOLERANCE	ACTUAL MEASUREMENT
OVER ALL LENGTH	$3.50 \pm .03$	<u>3.501</u>
MOUNTING HOLE CENTER	$0.125 \pm .010$	<u>0.127</u>
BETWEEN UPPER MOUNTING HOLES	<u>3.250</u>	<u>3.250</u>
BETWEEN LOWER MOUNTING HOLES	<u>3.250</u>	<u>3.250</u>

Prepared in accordance with MIL-STD-100

CONTRACT NO.	SIZE A	CAGE CODE	DWG. NO.	REV. J
DADEN-ANTHONY ASSOCIATES INC.		57032	63-0005-02	



FINAL FUNCTIONAL PERFORMANCE

REJECTION PERFORMANCE

SERIAL NO. P229-008

-10C DATA

OPR: R. HOGGATT DATE DEC 18 1996

MARKER PARAMETER channel 1 channel 2

MARKER 1	1.000000 MHz	50.000000 MHz
	OFF	0 dB

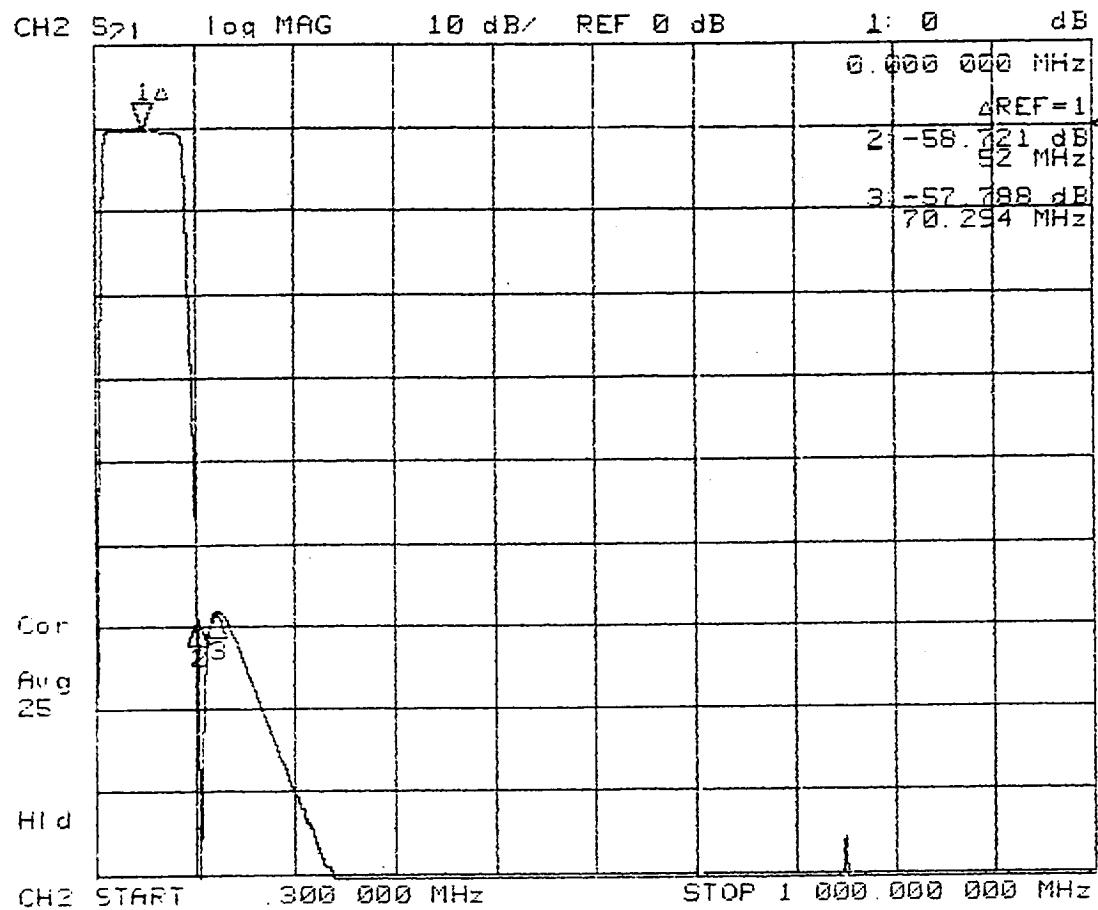
MARKER 2	5.000000 MHz	102.000000 MHz
	OFF	-57.654 dB

MARKER 3	5.000000 MHz	120.494452 MHz
	OFF	OFF

MARKER 4	5.000000 MHz	1000.000000 MHz
	OFF	OFF

MKR STIMULUS OFFSET	0.000000 MHz	0.000000 MHz
	0 dB	0 dB

REFERENCE MARKER PLACEMENT	OFF	MARKER 1
MARKER SEARCH	CONTINUOUS	CONTINUOUS
TARGET VALUE	OFF	OFF
MARKER WIDTH VALUE	-3 dB	-3 dB
	-3 dB	-3 dB
MARKER TRACKING	OFF	OFF
	OFF	OFF



FINAL FUNCTIONAL PERFORMANCE

REJECTION PERFORMANCE

SERIAL NO. P229-008

+15C DATA

OPR: R. HOGGATT DATE DEC 18 1996

MARKER PARAMETERS

Marker 1

Channel 2

MARKER 1 1.000000 MHz 50.000000 MHz
OFF OFF 0 dB

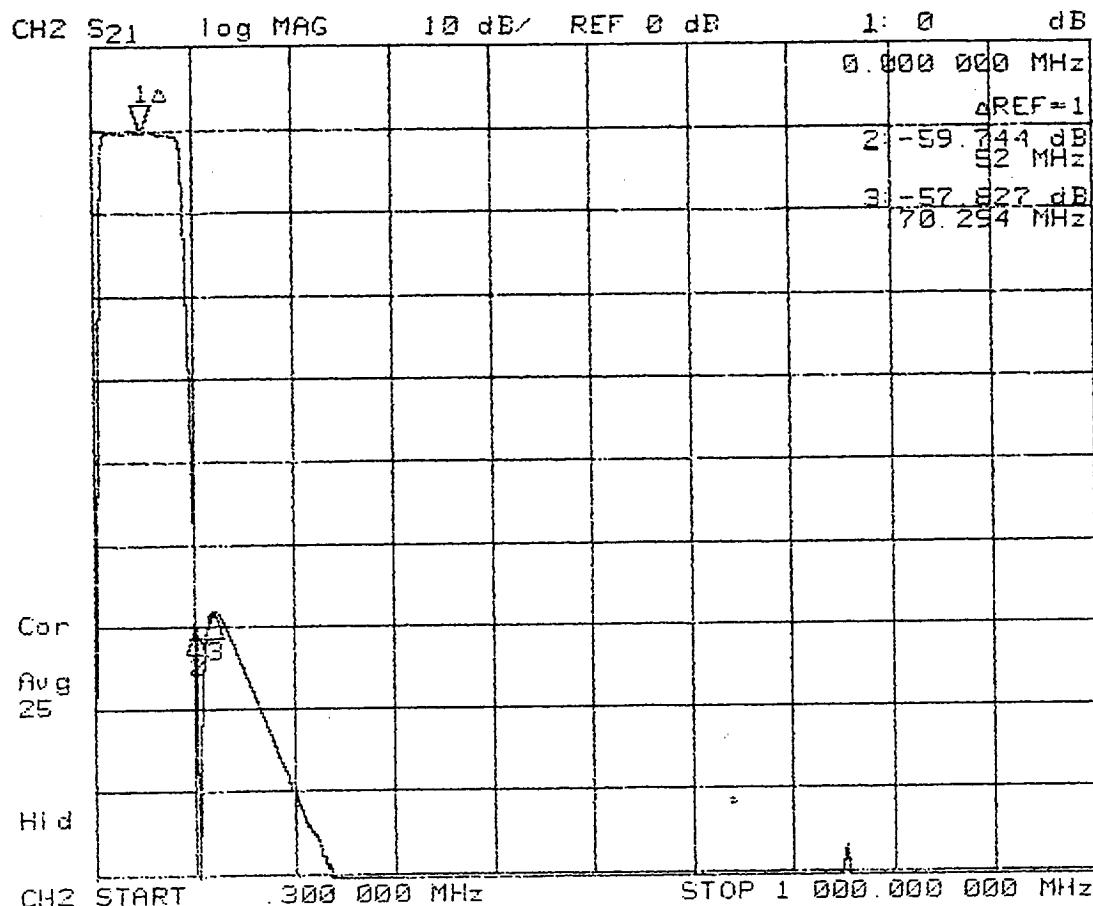
MARKER 2 5.000000 MHz 102.000000 MHz
OFF OFF -58.721 dB

MARKER 3 5.000000 MHz 120.294510 MHz
OFF OFF -57.788 dB

MARKER 4 5.000000 MHz 1000.000000 MHz
OFF OFF OFF

MKR STIMULUS OFFSET 0.000000 MHz 0.000000 MHz
0 dB OFF 0 dB

REFERENCE MARKER PLACEMENT	OFF	MARKER 1
MARKER SEARCH	CONTINUOUS	CONTINUOUS
TARGET VALUE	OFF	OFF
MARKER WIDTH VALUE	-3 dB	-3 dB
MARKER TRACKING	OFF	OFF
	OFF	OFF



FINAL FUNCTIONAL PERFORMANCE

REJECTION PERFORMANCE

SERIAL NO. P229-008

+40C DATA

OPR: R. HOGGATT DATE DEC 18 1996

MARKER PARAMETERS

channel 1 channel 2

MARKER 1	1.000000 MHz OFF	50.000000 MHz 0 dB
MARKER 2	5.000000 MHz OFF	102.000000 MHz -59.744 dB
MARKER 3	5.000000 MHz OFF	120.294511 MHz -57.827 dB
MARKER 4	5.000000 MHz OFF	1000.000000 MHz OFF
MKR STIMULUS OFFSET	0.000000 MHz 0 dB	0.000000 MHz 0 dB
REFERENCE MARKER PLACEMENT	OFF	MARKER 1
MARKER SEARCH	CONTINUOUS	CONTINUOUS
TARGET VALUE	OFF	OFF
MARKER WIDTH VALUE	-3 dB	-3 dB
MARKER TRACKING	OFF	OFF

APPENDIX CACCEPTANCE TEST REPORT

BANDPASS FILTER MODEL HL50-80-10SS1 S/N P229-008
 AEROJET 1331559-3 REV. E

BANDPASS CHARACTERISTICS MEASUREMENT

PER ATP PARA 4.6

(REF: AE-24687, PARA 4.8.2)

RECORD THE AMBIENT ROOM TEMPERATURE. +22.5 °C (+19°C TO +29.0°C)

{15} ATTACH PASSBAND PERFORMANCE X-Y PLOT

✓ (✓)

{24} TEST POINT MATRIX

REF	FREQ	UNIT	VALUE	REF	FREQ	UNIT	VALUE
F1	0.5	MHz	-103.3 dB	F11	(*) 60.0	MHz	-0.32 dB
F2	1.0	MHz	-96.3 dB	F12	(*) 70.0	MHz	-0.41 dB
F3	5.0	MHz	-31.9 dB	F13	80.0	MHz	-0.63 dB
F4	7.5	MHz	-11.1 dB	F14	85.0	MHz	-0.85 dB
F5	10.0	MHz	-1.54 dB	F15	90.0	MHz	-5.56 dB
F6	15.0	MHz	-0.26 dB	F16	100.0	MHz	-46.5 dB
F7	20.0	MHz	-0.21 dB	F17	200.0	MHz	-80.2 dB
F8	(*) 30.0	MHz	-0.18 dB	F18	300.0	MHz	-103.8 dB
F9	(*) 40.0	MHz	-0.21 dB	F19	500.0	MHz	-104.2 dB
F10	50.0	MHz	-0.24 dB	F20	1000.0	MHz	-106.2 dB

TEST PERFORMED BY: R. Hoggatt DATE 12/18/96DA
SNOTE IF TEST WITNESSED BY AESD Not witnessed this time. DLD _____

***** END OF BANDPASS CHARACTERISTICS TEST *****

FUNCTIONAL PERFORMANCE TEST

ACCEPTANCE TEST PROCEDURE

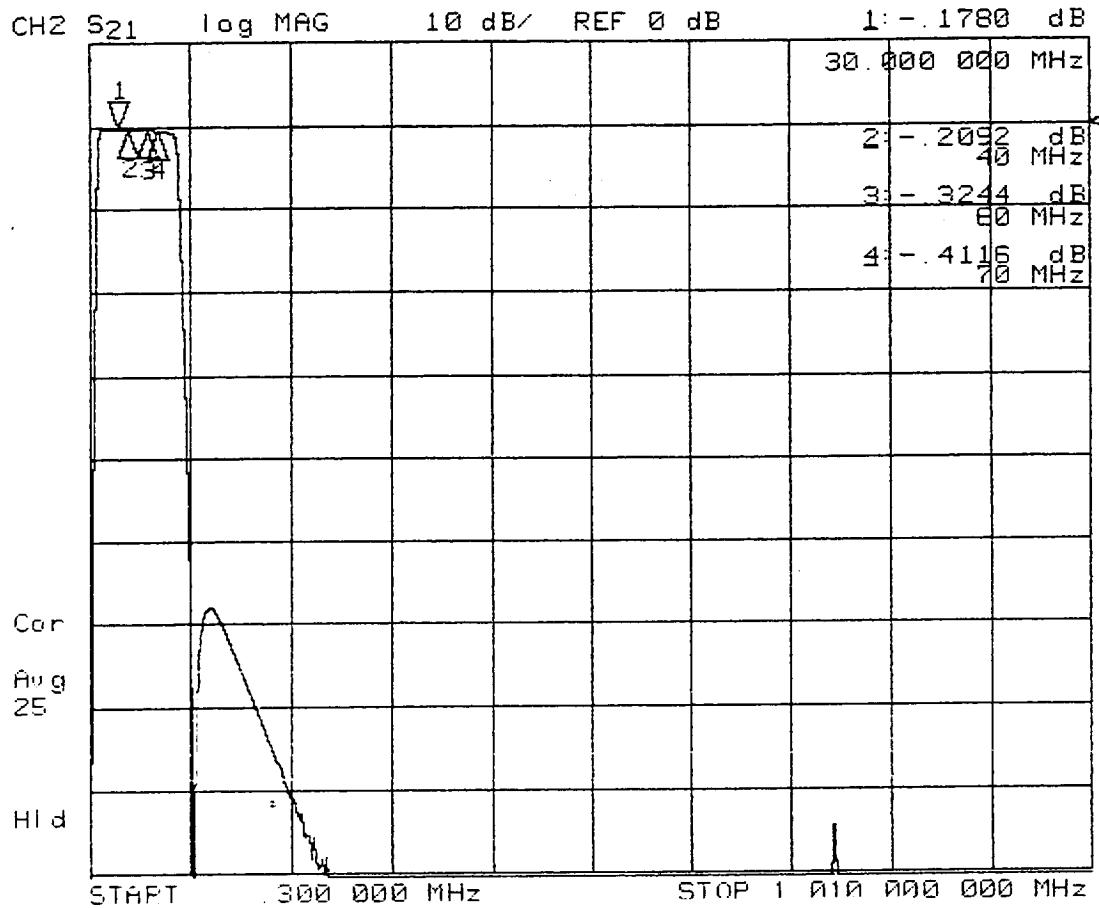
63-0005-02 PARA 4.1

BRIEF TEST DESCRIPTION: THE TESTS DESCRIBED IN APPENDIX C PAGE 10 THRU PAGE 13 ARE PERFORMED TO DOCUMENT THE FUNCTIONAL PERFORMANCE OF THE UNIT AT THE CONCLUSION OF ALL ENVIRONMENTAL TESTING. THE TESTS ARE AS FOLLOWS AND IN ANY SEQUENCE:

- a.) VSWR PER ATP PARA 4.5.1.
- b.) INSERTION LOSS PER ATP PARA 4.5.2
- c.) INSERTION LOSS VS TEMPERATURE PER ATP PARA 4.5.6.
- d.) 3.0 dB BANDWIDTH PER ATP PARA 4.5.3.
- e.) CENTER FREQUENCY (fc) PER ATP PARA 4.5.7 (PART OF 3.0 dB B/W TEST)
- f.) PASSBAND RIPPLE PER ATP PARA 4.5.4 (PART OF INSERTION LOSS TEST).
- g.) OUT-OF-BAND REJECTION PER ATP PARA 4.5.5.

Prepared in accordance with MIL-STD-100

CONTRACT NO.	SIZE A	CAGE CODE 57032	DWG. NO. 63-0005-02	REV. J
DADEN-ANTHONY ASSOCIATES INC.	FILE: ACAD/63/0502APCJ.DOC	SHEET	11	



**POST THERMAL CYCLE
PASSBAND CHARACTERISTICS
SERIAL NO. P229-008**

AMBIENT

OPR: R. HOGGATT DATE DEC 18 1996

MARKER PARAMETER

Marker 1

Channel 2

MARKER 1	30.000000 MHz OFF	30.000000 MHz - .1780 dB
MARKER 2	40.000000 MHz OFF	40.000000 MHz - .2092 dB
MARKER 3	60.000000 MHz OFF	60.000000 MHz - .3244 dB
MARKER 4	70.000000 MHz OFF	70.000000 MHz - .4116 dB
MKR STIMULUS OFFSET	0.000000 MHz 0 dB	0.000000 MHz 0 dB
REFERENCE MARKER PLACEMENT	OFF	OFF
MARKER SEARCH	CONTINUOUS	CONTINUOUS
TARGET VALUE	OFF	OFF
MARKER WIDTH VALUE	-3 dB	-3 dB
MARKER TRACKING	OFF	OFF

Report No. 11317
November 1998

**GAIN STABILITY AND GAIN COMPRESSION
FOR
MIXER/IF AMPLIFIERS**

GAIN-TEMPERATURE SENSITIVITY FOR MIXER/AMPLIFIERS

Channel No.	1	2
Specification (+/-dB/°C)	0.02	0.02
Measured (dB/°C)	-0.015	-0.017

Channel 1 Bandpass Filter

IF Filter (S/N: 1331559-6, S/N: P232-006)

APPENDIX E**ACCEPTANCE TEST REPORT**

BANDPASS FILTER MODEL HL72.5-125-10SS1 S/N P232-006
 AEROJET 1331559-6 REV. E

3.0 dB BANDWIDTH

ACCEPTANCE TEST PROCEDURE
 63-0005-02 PARA 4.5.3

	-10°C	+15°C	+40°C
{7} UPPER 3.0 dB BANDEDGE	<u>134.32</u> MHz (133.0-135.0)	<u>134.11</u> Mhz (133.0-135.0)	<u>133.87</u> MHz (133.0-135.0)
{8} LOWER 3.0 dB BANDEDGE	<u>8.62</u> MHz (8.0-10.0)	<u>8.60</u> Mhz (8.0-10.0)	<u>8.59</u> MHz (8.0-10.0)
{9} 3.0 dB RELATIVE BANDWIDTH	<u>125.76</u> MHz (123.0-127.0)	<u>125.51</u> Mhz (123.0-127.0)	<u>125.28</u> MHz (123.0-127.0)
{10} ADD {7} AND {8} ÷ 2 =	<u>71.47</u> MHz (72.5 NOM)	<u>71.36</u> MHz (72.5 NOM)	<u>71.23</u> Mhz (72.5 NOM)
{10a} RECORD MEASURED TEMPERATURE	<u>-13.0</u> °C (-15.0 TO -10.0)	<u>+14.1</u> °C (12.5 TO 17.5)	<u>+42.5</u> °C (40.0 TO 45.0)
{6} ATTACH TRANSMISSION LOSS PERFORMANCE X-Y PLOT	<u>✓</u> (✓)	<u>✓</u> (✓)	<u>✓</u> (✓)

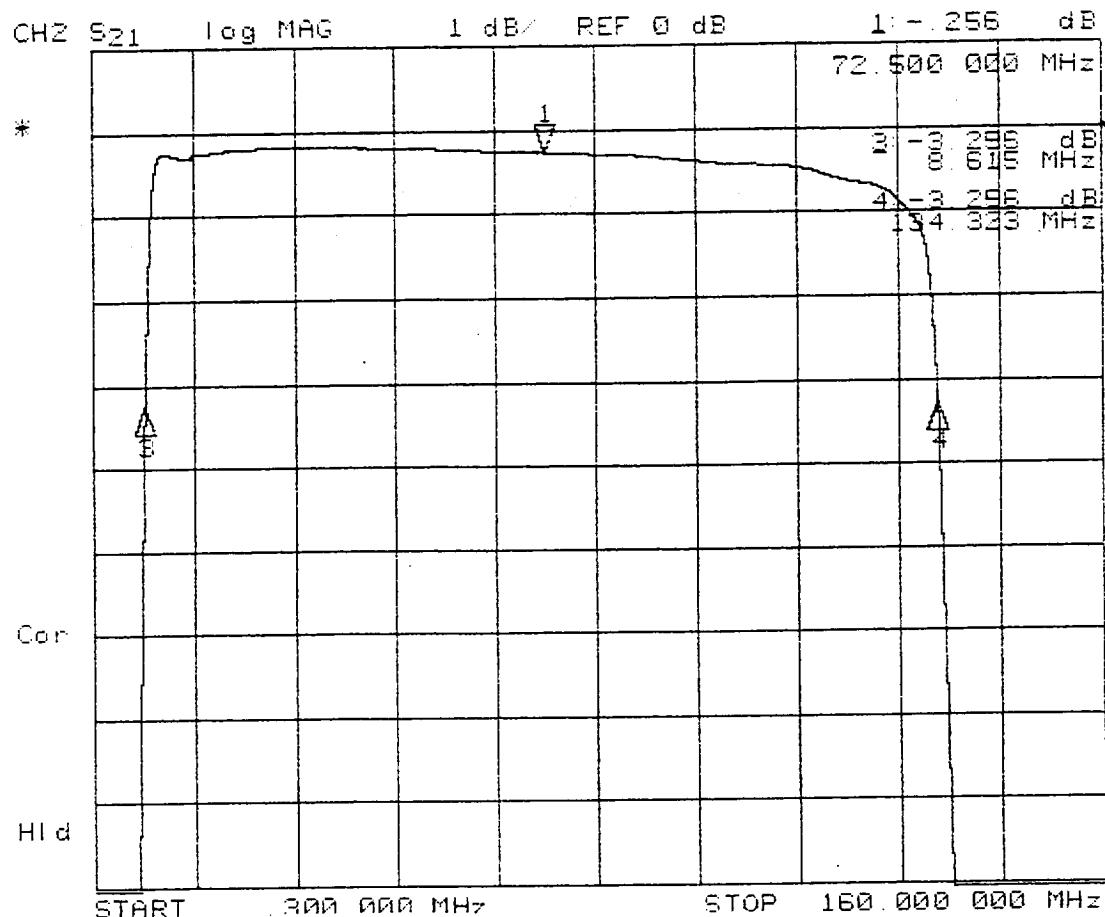
PASSBAND RIPPLE

ACCEPTANCE TEST PROCEDURE
 63-0005-02 PARA 4.5.4

	-10°C	+15°C	+40°C
{11a} MIN INSERTION LOSS FREQ	<u>32.63</u> MHz	<u>31.84</u> Mhz	<u>31.84</u> MHz
MIN INSERTION LOSS PERFORMANCE	<u>-0.17</u> dB	<u>-0.17</u> dB	<u>-0.17</u> dB
{11b} 75% BW LOWER BANDEDGE FREQ	<u>10.24</u> MHz	<u>10.17</u> Mhz	<u>10.13</u> MHz
75% BW LOWER BANDEDGE I.L. PERF	<u>-0.41</u> dB	<u>-0.43</u> dB	<u>-0.46</u> dB
{11c} 75% BW UPPER BANDEDGE FREQ	<u>103.99</u> MHz	<u>103.92</u> Mhz	<u>103.88</u> MHz
75% BW UPPER BANDEDGE I.L. PERF	<u>-0.42</u> dB	<u>-0.43</u> dB	<u>-0.45</u> dB
{11d} PERFORMANCE DELTA (I.L. @ {11b} - I.L. @ {11a})	<u>0.24</u> dB	<u>0.26</u> dB	<u>0.29</u> dB
{11e} PERFORMANCE DELTA (I.L. @ {11c} - I.L. @ {11a})	<u>0.25</u> dB	<u>0.26</u> dB	<u>0.28</u> dB

Prepared in accordance with MIL-STD-100

CONTRACT NO.	SIZE A	CAGE CODE 57032	DWG. NO. 63-0005-02	REV. J
DADEN-ANTHONY ASSOCIATES INC.		FILE: ACAD\53\0502APFJ.DOC	SHEET	12



FINAL FUNCTIONAL PERFORMANCE

TRANSMISSION LOSS

SERIAL NO. P232-006

-10C DATA

OPR: R. HOGGATT DATE 12/11/96

MARKER PARAMETERS

Channel 2

MARKER 1	16.250000 MHz	72.500000 MHz
	OFF	-256 dB

MARKER 2	129.750000 MHz	71.469838 MHz
	OFF	OFF

MARKER 3	129.625000 MHz	8.615992 MHz
	OFF	-3.256 dB

MARKER 4	129.375000 MHz	134.323684 MHz
	OFF	-3.256 dB

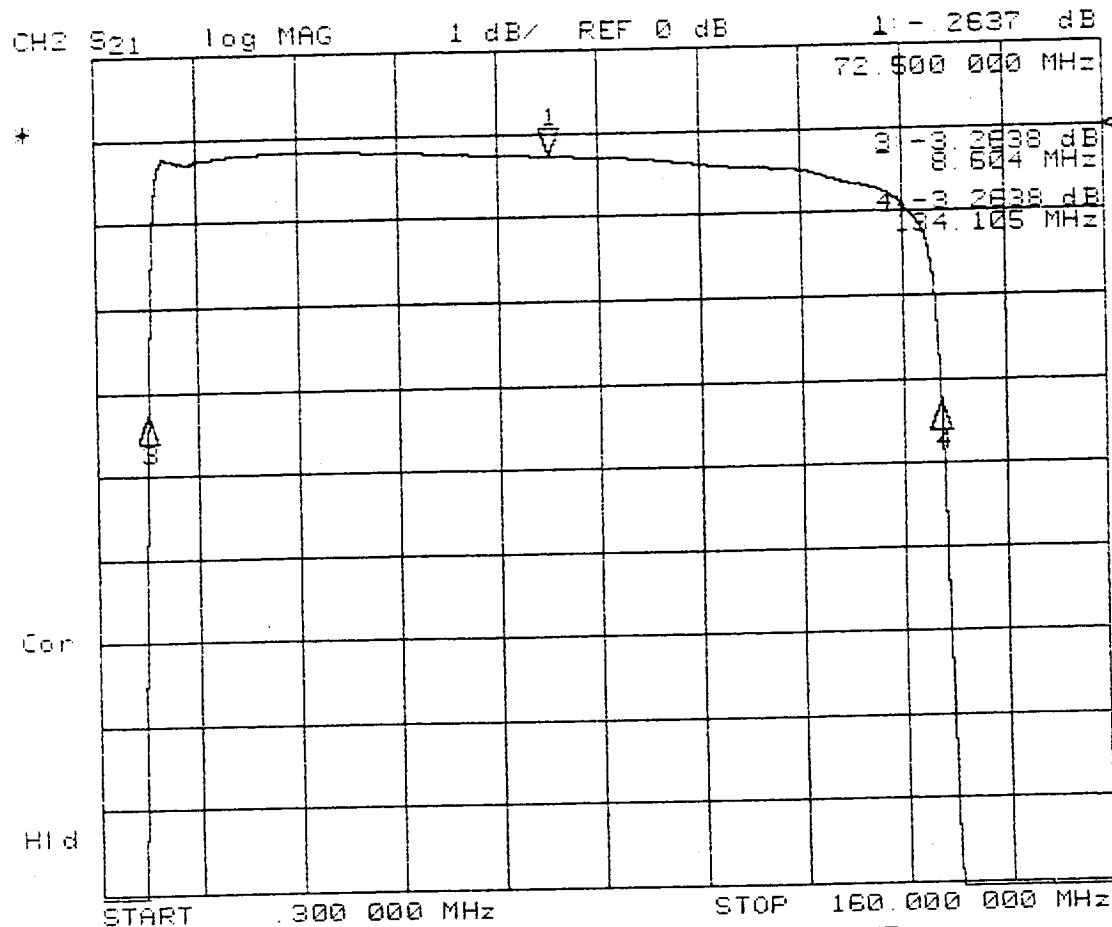
MKR STIMULUS OFFSET	0.000000 MHz	89.425802 MHz
	0 dB	-3.2342 dB

REFERENCE MARKER PLACEMENT	OFF	OFF
MARKER SEARCH	CONTINUOUS	CONTINUOUS

TARGET VALUE	OFF	OFF
--------------	-----	-----

MARKER WIDTH VALUE	-3 dB	-3 dB
--------------------	-------	-------

MARKER TRACKING	OFF	OFF
-----------------	-----	-----



FINAL FUNCTIONAL PERFORMANCE

TRANSMISSION LOSS

SERIAL NO. P232-006

+15C DATA

OPR: R. HOGGATT DATE 12/11/96

MARKER PARAMETER

MARKER 1	16.250000 MHz	72.500000 MHz
	OFF	- .2637 dB

MARKER 2	128.750000 MHz	71.354527 MHz
	OFF	OFF

MARKER 3	25.625000 MHz	8.604033 MHz
	OFF	-3.2638 dB

MARKER 4	119.375000 MHz	134.105022 MHz
	OFF	-3.2638 dB

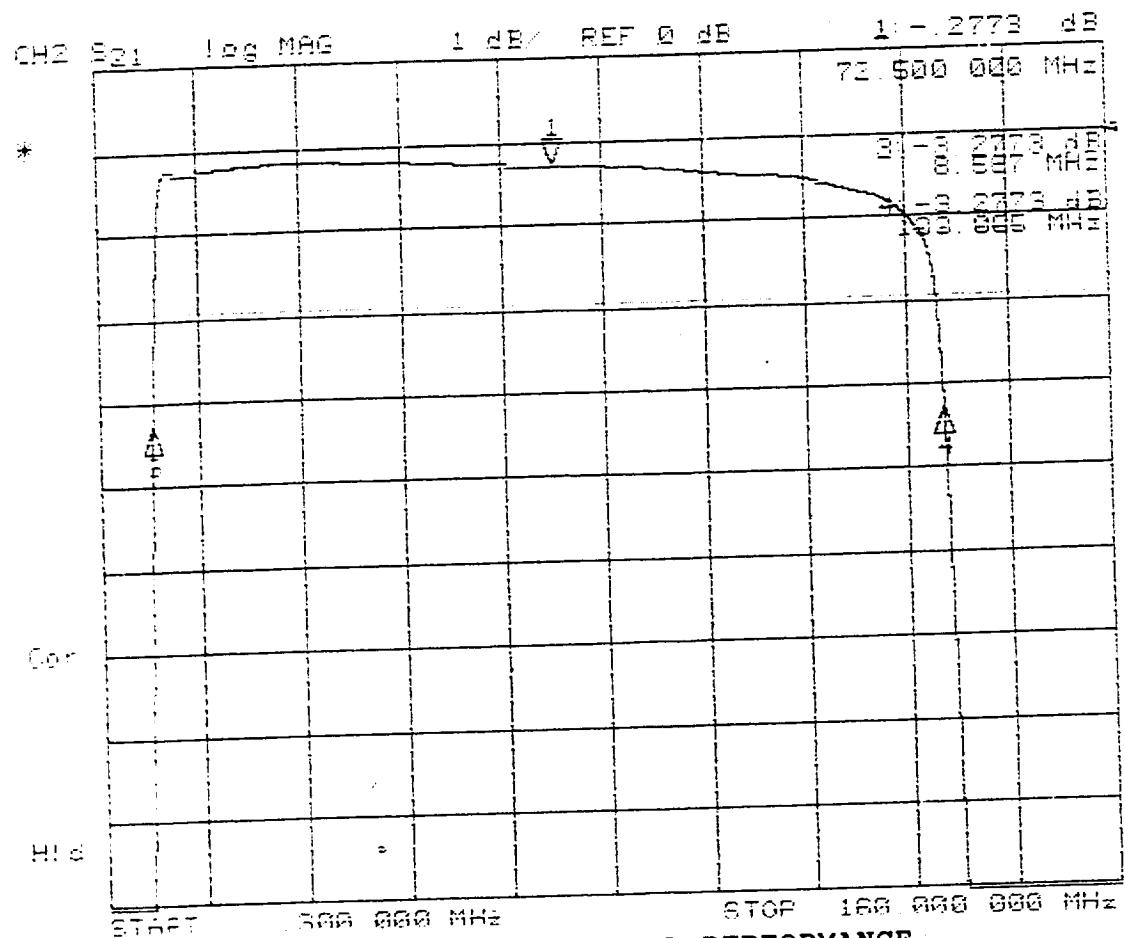
MKR STIMULUS OFFSET	0.000000 MHz	89.425802 MHz
	0 dB	-3.2342 dB

REFERENCE MARKER PLACEMENT	OFF	OFF
MARKER SEARCH	CONTINUOUS	CONTINUOUS

TARGET VALUE	OFF	OFF
--------------	-----	-----

MARKER WIDTH VALUE	-3 dB	-3 dB
--------------------	-------	-------

MARKER TRACKING	OFF	OFF
-----------------	-----	-----



**FINAL FUNCTIONAL PERFORMANCE
TRANSMISSION LOSS
SERIAL NO. P232-006
+40C DATA
OPR: R. HOGGATT DATE 12/11/96**

MARKEF PARAMETER

MARKER 1

16.250000 MHz
OFF

72.500000 MHz
-2773 dB

MARKER 2

128.750000 MHz
OFF

71.226904 MHz
OFF

MARKER 3

25.625000 MHz
OFF

8.587920 MHz
-3.2773 dB

MARKER 4

119.375000 MHz
OFF

133.865888 MHz
-3.2773 dB

MKR STIMULUS OFFSET

0.000000 MHz
0 dB

89.425802 MHz
-3.2342 dB

REFERENCE MARKER
PLACEMENT

OFF
CONTINUOUS

OFF
CONTINUOUS

MARKER SEARCH

OFF

OFF

TARGET VALUE

-14 dB

-3 dB

MARKER WIDTH VALUE

-3 dB

-3 dB

MARKER TRACKING

OFF

OFF

APPENDIX F

ACCEPTANCE TEST REPORT

BANDPASS FILTER MODEL HL72.5-125-10SS1 S/N P232 - C06
AEROJET 1331559-6 REV. E

PASSBAND RIPPLE (CON'T)

{11f} RECORD PASS/FAIL (0.5 dB MAX)

(PASSTICK) FAIL

(PASSTICK) FAIL

(PASSTICK) FAIL

{11g) ATTACH PASSBAND RIPPLE
PERFORMANCE X-Y PLOT(S)

✓(√)

✓(√)

✓(√)

OUT-OF-BAND REJECTION

ACCEPTANCE TEST PROCEDURE

-10°C

+15°C

+40°C

63-0005-02 PARA 4.5.5

Fc=72.5 MHz.

REF {5A} FOR INSERTION LOSS @ Fc

{12} WORST CASE REJECTION FROM
0.300 MHz TO 1.0 MHz>100 dB
(40.0 dB MIN)>100 dB
(40.0 dB MIN)>100 dB
(40.0 dB MIN){13a} WORST CASE REJECTION FROM
153.75 MHz TO 1000.0 MHz-66.0 dB
(40.0 dB MIN)-67.0 dB
(40.0 dB MIN)-68.1 dB
(40.0 dB MIN)

{13c} RECORD MEASURED TEMPERATURE

-13.3 °C
(-15.0 TO -10.0)+13.9 °C
(12.5 TO 17.5)+42.3 °C
(40.0 TO 45.0){14} ATTACH REJECTION PERFORMANCE
X-Y PLOT(S)✓(√)
✓(√)✓(√)
✓(√)✓(√)
✓(√)TEST PERFORMED BY T.R. HOGGARTH DATE 12/11/96NOTE IF TEST WITNESSED BY AESD: _____ GSI: Not witnessed
this time. DLD

***** END OF FUNCTIONAL PERFORMANCE TEST *****

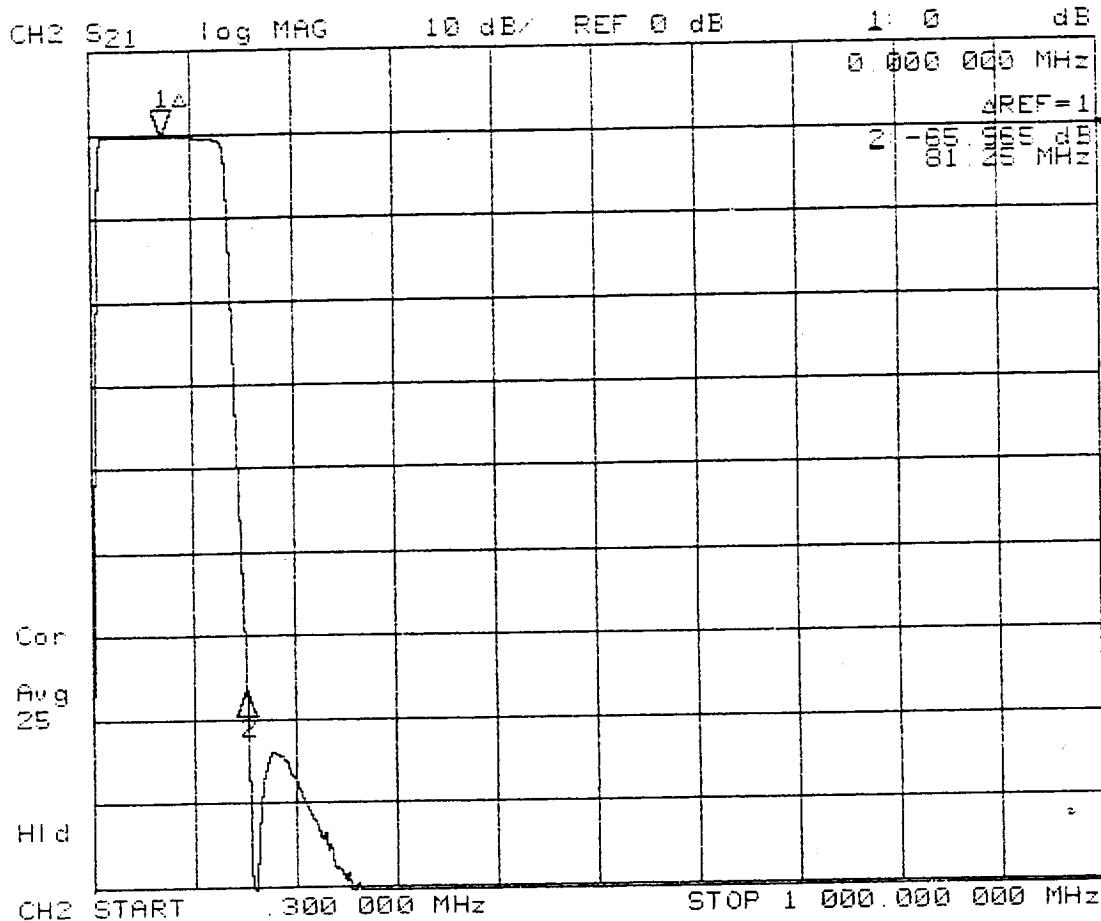
OUTLINE AND MOUNTING DIMENSIONS VERIFICATION

{16} REFERENCE CUSTOMER DRAWING 1331559

DESCRIPTION OF MEASUREMENT	DIMENSION AND TOLERANCE	ACTUAL MEASUREMENT
OVER ALL LENGTH	3.50 ± .03	<u>3.500</u>
MOUNTING HOLE CENTER	0.125 ± .010	<u>0.126</u>
BETWEEN UPPER MOUNTING HOLES	<u>3.250</u>	<u>3.249</u>
BETWEEN LOWER MOUNTING HOLES	<u>3.250</u>	<u>3.251</u>

Prepared in accordance with MIL-STD-100

CONTRACT NO.	SIZE A	CAGE CODE 57032	DWG. NO. 63-0005-02	REV. J
DADEN-ANTHONY ASSOCIATES INC.		FILE: ACAD/63/0502APFJ.DOC	SHEET	13



**FINAL FUNCTIONAL PERFORMANCE
REJECTION PERFORMANCE
SERIAL NO. P232-006**

-10C DATA
OPR: R. HOGGATT DATE 12/11/96

MARKER PARAMETER CHANNEL 2

MARKER 1	1.000000 MHz	72.500000 MHz
	OFF	0 dB

MARKER 2	5.000000 MHz	153.750000 MHz
	OFF	-65.965 dB

MARKER 3	5.000000 MHz	153.750000 MHz
	OFF	OFF

MARKER 4	5.000000 MHz	1000.000000 MHz
	OFF	OFF

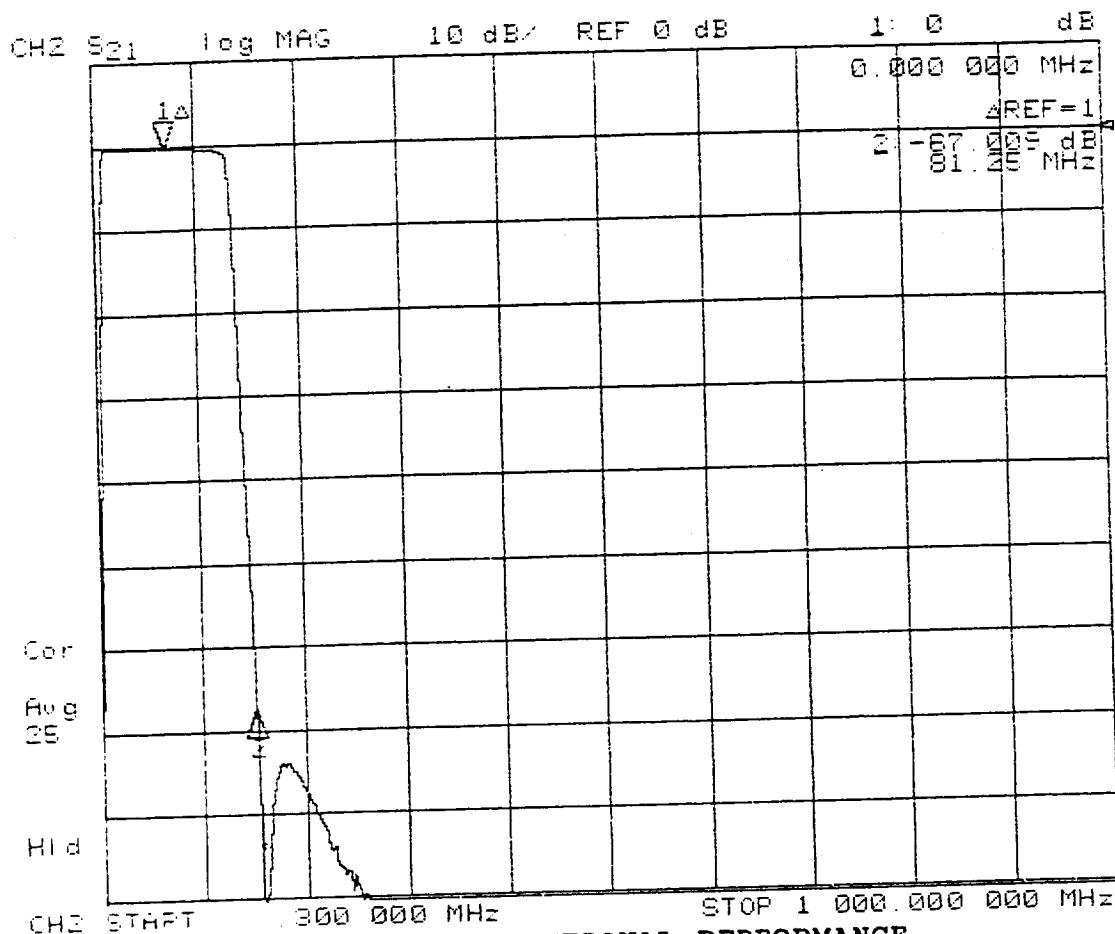
MKR STIMULUS OFFSET	0.000000 MHz	0.000000 MHz
	0 dB	0 dB

REFERENCE MARKER PLACEMENT	OFF	MARKER 1
MARKER SEARCH	CONTINUOUS	CONTINUOUS

TARGET VALUE	OFF	OFF
--------------	-----	-----

MARKER WIDTH VALUE	-3 dB	-3 dB
	OFF	OFF

MARKER TRACKING	OFF	OFF
-----------------	-----	-----



FINAL FUNCTIONAL PERFORMANCE

REJECTION PERFORMANCE

SERIAL NO. P232-006

+15C DATA

OPR: R. HOGGATT DATE 12/11/96

MARKER PARAMETER

Channel 2

MARKER 1	1.000000 MHz	72.500000 MHz
	OFF	0 dB

MARKER 2	5.000000 MHz	153.750000 MHz
	OFF	-67.009 dB

MARKER 3	5.000000 MHz	153.750000 MHz
	OFF	OFF

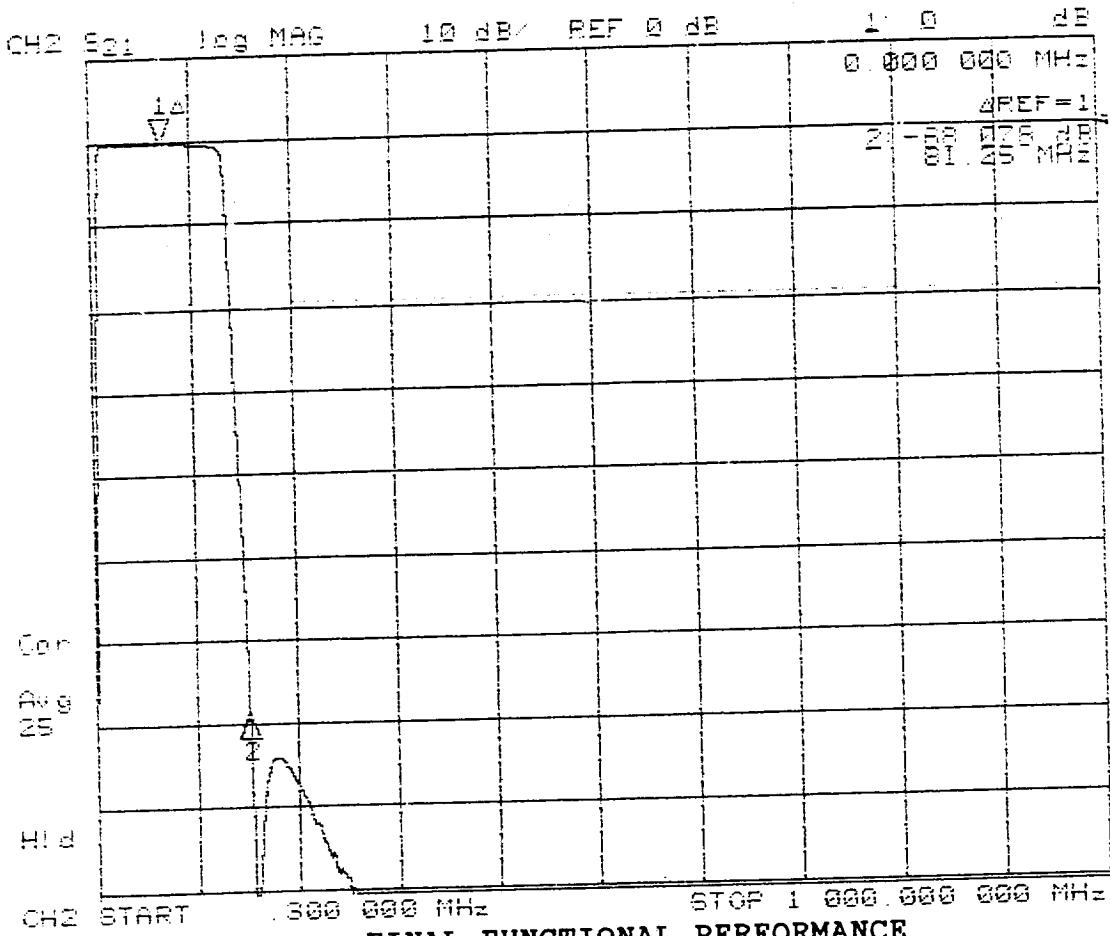
MARKER 4	5.000000 MHz	1000.000000 MHz
	OFF	OFF

MKR STIMULUS OFFSET	0.000000 MHz	0.000000 MHz
	0 dB	0 dB

REFERENCE MARKER PLACEMENT	OFF	MARKER 1
MARKER SEARCH	CONTINUOUS	CONTINUOUS

TARGET VALUE	OFF	OFF
MARKER WIDTH VALUE	-3 dB	-3 dB

MARKER TRACKING	-3 dB	-3 dB
	OFF	OFF



**FINAL FUNCTIONAL PERFORMANCE
REJECTION PERFORMANCE
SERIAL NO. P232-006
+40C DATA
OPR: R. HOGGATT DATE 12/11/90**

MARKER PARAMETERS

	Parameter	Value	Channel 2
MARKER 1	Frequency	1.000000 MHz	72.500000 MHz
MARKER 1	Offset	OFF	0 dB
MARKER 2	Frequency	5.000000 MHz	153.750000 MHz
MARKER 2	Offset	OFF	-88.078 dB
MARKER 3	Frequency	5.000000 MHz	153.750000 MHz
MARKER 3	Offset	OFF	0 dB
MARKER 4	Frequency	5.000000 MHz	1000.000000 MHz
MARKER 4	Offset	OFF	0 dB
MKR STIMULUS OFFSET	Frequency	0.000000 MHz	0.000000 MHz
MKR STIMULUS OFFSET	Offset	0 dB	0 dB
REFERENCE MARKER PLACEMENT	OFF	MARKER 1	
REFERENCE MARKER PLACEMENT	CONTINUOUS	CONTINUOUS	
MARKER SEARCH	OFF	OFF	
TARGET VALUE	-3 dB	-3 dB	
MARKER WIDTH VALUE	-3 dB	-3 dB	
MARKER TRACKING	OFF	OFF	
MARKER TRACKING	OFF	OFF	

BANDPASS FILTER MODEL HL72.5-125-10SS1 S/N P232-006
AEROJET 1331559-6 REV. E

BANDPASS CHARACTERISTICS MEASUREMENT

PER ATP PARA 4.6

(REF: AE-24687, PARA 4.8.2)

RECORD THE AMBIENT ROOM TEMPERATURE. +24.0 °C (+19°C TO +29.0°C)

{15} ATTACH PASSBAND PERFORMANCE X-Y PLOT

✓ (✓)

{24} TEST POINT MATRIX

REF	FREQ	UNIT	VALUE	REF	FREQ	UNIT	VALUE
F1	0.5	MHz	-98.1 dB	F11	(*) 80.0	MHz	-0.32 dB
F2	1.0	MHz	-91.4 dB	F12	(*) 100.0	MHz	-0.41 dB
F3	5.0	MHz	-30.2 dB	F13	120.0	MHz	-0.63 dB
F4	7.5	MHz	-9.15 dB	F14	130.0	MHz	-1.06 dB
F5	10.0	MHz	-0.84 dB	F15	135.0	MHz	-5.34 dB
F6	15.0	MHz	-0.30 dB	F16	140.0	MHz	-21.9 dB
F7	25.0	MHz	-0.22 dB	F17	150.0	MHz	-53.6 dB
F8	(*) 45.0	MHz	-0.18 dB	F18	200.0	MHz	-77.2 dB
F9	(*) 65.0	MHz	-0.25 dB	F19	500.0	MHz	-100.1 dB
F10	72.5	MHz	-0.30 dB	F20	1000.0	MHz	-103.7 dB

TEST PERFORMED BY: R. HOGGAN DA DATE 12/18/96NOTE IF TEST WITNESSED BY AESD _____ GSI Not witnessed
this time. DLD

***** END OF BANDPASS CHARACTERISTICS TEST *****

FUNCTIONAL PERFORMANCE TEST

ACCEPTANCE TEST PROCEDURE

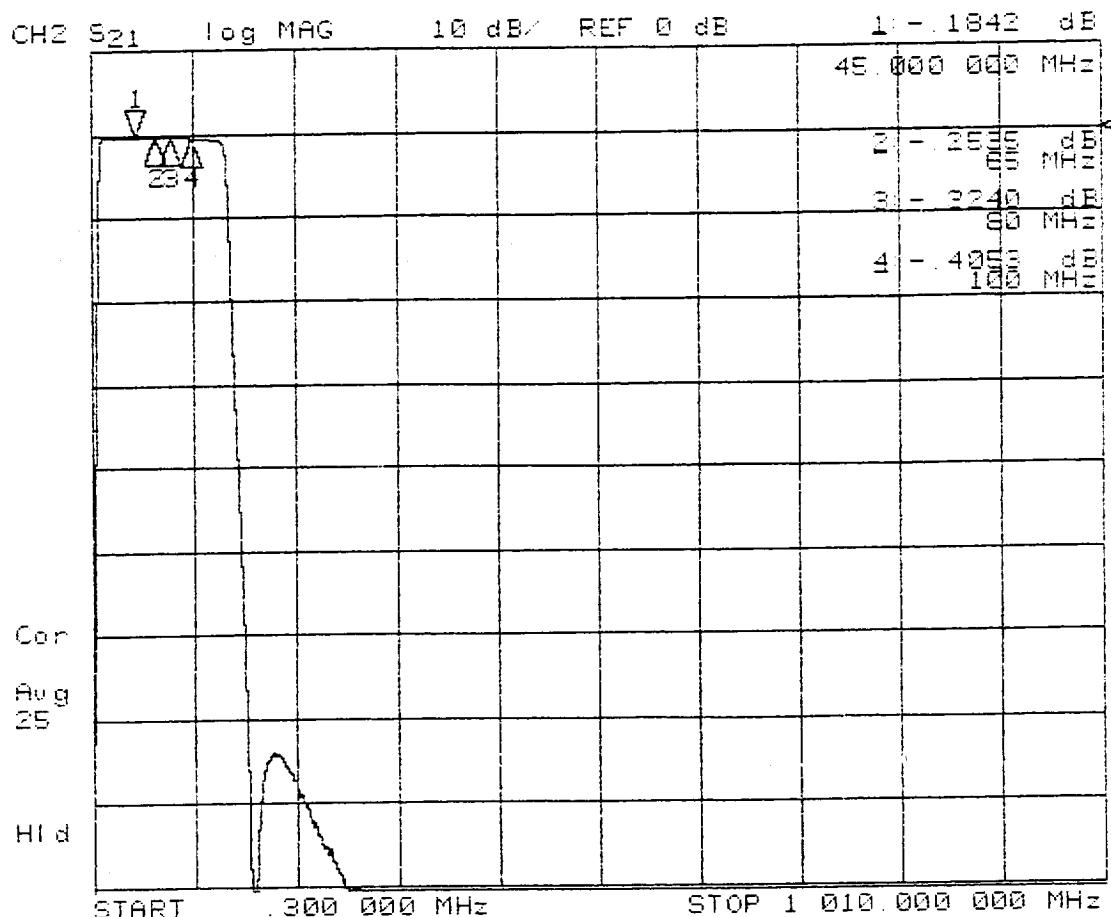
63-0005-02 PARA 4.1

BRIEF TEST DESCRIPTION: THE TESTS DESCRIBED IN APPENDIX F PAGE 10 THRU PAGE 13 ARE PERFORMED TO DOCUMENT THE FUNCTIONAL PERFORMANCE OF THE UNIT AT THE CONCLUSION OF ALL ENVIRONMENTAL TESTING. THE TESTS ARE AS FOLLOWS AND IN ANY SEQUENCE:

- a.) VSWR PER ATP PARA 4.5.1.
- b.) INSERTION LOSS PER ATP PARA 4.5.2
- c.) INSERTION LOSS VS TEMPERATURE PER ATP PARA 4.5.6.
- d.) 3.0 dB BANDWIDTH PER ATP PARA 4.5.3.
- e.) CENTER FREQUENCY (fc) PER ATP PARA 4.5.7 (PART OF 3.0 dB B/W TEST)
- f.) PASSBAND RIPPLE PER ATP PARA 4.5.4 (PART OF INSERTION LOSS TEST).
- g.) OUT-OF-BAND REJECTION PER ATP PARA 4.5.5.

Prepared in accordance with MIL-STD-100

CONTRACT NO.	SIZE A	CAGE CODE 57032	DWG. NO. 63-0005-02	REV. J
DADEN-ANTHONY ASSOCIATES INC.		FILE: ACAD/63/0502APFJ.DOC	SHEET	10



**POST THERMAL CYCLE
PASSBAND CHARACTERISTICS
SERIAL NO. P232-006**

AMBIENT OPR: R. HOGGATT DATE DEC 18 1996

MARKER PARAMETER SETTING CHANNEL 2

MARKER 1 45.000000 MHz - .1842 dB

OFF

MARKER 2 65.000000 MHz - 2535 dB

OFF

MARKER 3 80.000000 MHz - 3240 dB

OFF

MARKER 4 100.000000 MHz - 4053 dB

OFF

MKR STIMULUS OFFSET 0.000000 MHz 0 dB

0 dB

REFERENCE MARKER PLACEMENT OFF CONTINUOUS

CONTINUOUS

MARKER SEARCH OFF

OFF

TARGET VALUE -3 dB

-3 dB

MARKER WIDTH VALUE -3 dB

-3 dB

OFF

OFF

MARKER TRACKING OFF

OFF

Channel 2 Bandpass Filter

IF Filter (S/N: 1331559-3, S/N: P229-008)

APPENDIX C**ACCEPTANCE TEST REPORT**

BANDPASS FILTER MODEL HL50-80-10SS1 S/N P229-008
 AEROJET 1331559-3 REV. E

3.0 dB BANDWIDTH

ACCEPTANCE TEST PROCEDURE
 63-0005-02 PARA 4.5.3

	-10°C	+15°C	+40°C
{7} UPPER 3.0 dB BANDEDGE	<u>89.37</u> MHz (88.0-90.0)	<u>89.22</u> Mhz (88.0-90.0)	<u>89.06</u> MHz (88.0-90.0)
{8} LOWER 3.0 dB BANDEDGE	<u>9.07</u> MHz (8.0-10.0)	<u>9.06</u> Mhz (8.0-10.0)	<u>9.05</u> MHz (8.0-10.0)
{9} 3.0 dB RELATIVE BANDWIDTH	<u>80.30</u> MHz (78.0-82.0)	<u>80.16</u> Mhz (78.0-82.0)	<u>80.01</u> MHz (78.0-82.0)
{10} ADD {7} AND {8} ÷ 2 =	<u>49.22</u> MHz (50.0 NOM)	<u>49.14</u> MHz (50.0 NOM)	<u>49.06</u> Mhz (50.0 NOM)
{10a} RECORD MEASURED TEMPERATURE	<u>-12.7</u> °C (-15.0 TO -10.0)	<u>+14.1</u> °C (12.5 TO 17.5)	<u>+42.9</u> °C (40.0 TO 45.0)
{6} ATTACH TRANSMISSION LOSS PERFORMANCE X-Y PLOT	<u>✓</u> (✓)	<u>✓</u> (✓)	<u>✓</u> (✓)

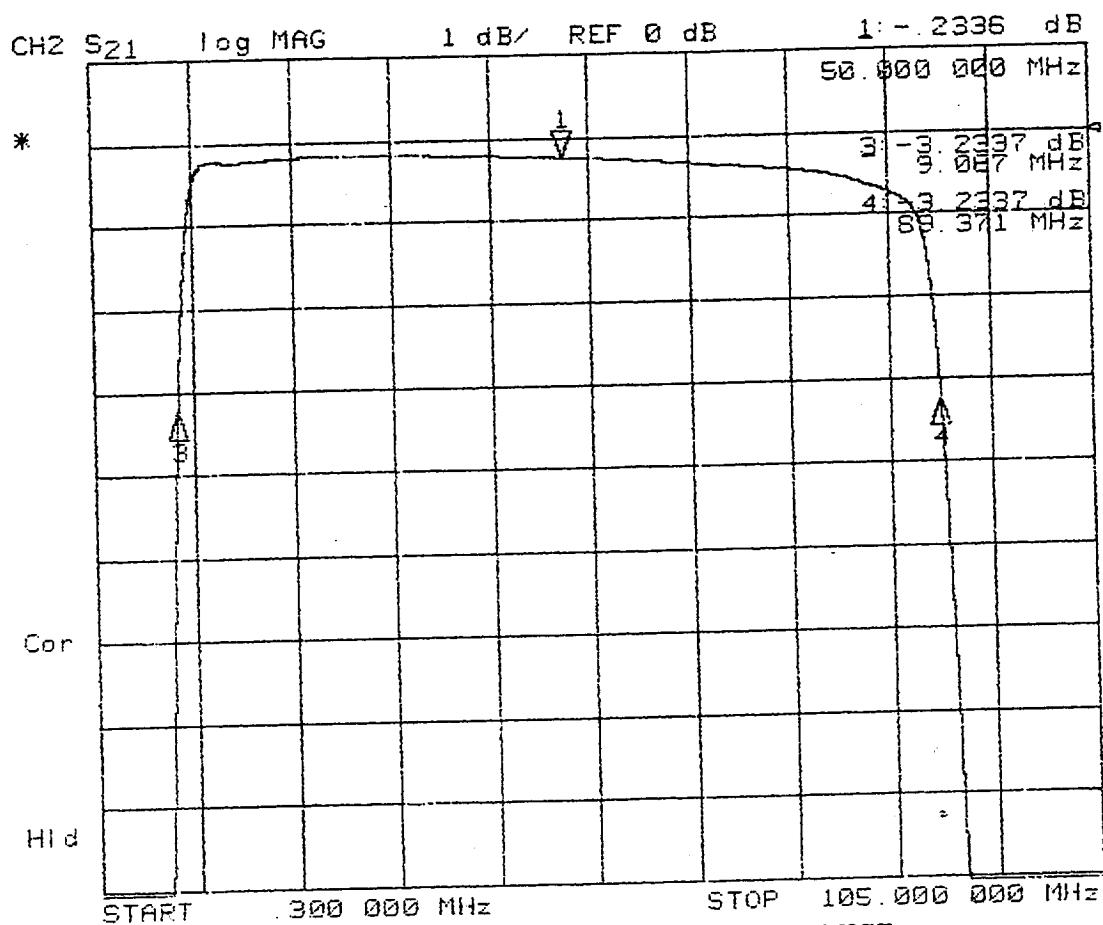
PASSBAND RIPPLE

ACCEPTANCE TEST PROCEDURE
 63-0005-02 PARA 4.5.4

	-10°C	+15°C	+40°C
{11a} MIN INSERTION LOSS FREQ	<u>21.00</u> MHz	<u>21.26</u> Mhz	<u>21.00</u> MHz
MIN INSERTION LOSS PERFORMANCE	<u>-0.17</u> dB	<u>-0.17</u> dB	<u>-0.18</u> dB
{11b} 75% BW LOWER BANDEDGE FREQ	<u>11.05</u> MHz	<u>11.00</u> Mhz	<u>10.94</u> MHz
75% BW LOWER BANDEDGE I.L. PERF	<u>-0.39</u> dB	<u>-0.41</u> dB	<u>-0.44</u> dB
{11c} 75% BW UPPER BANDEDGE FREQ	<u>71.05</u> MHz	<u>71.00</u> Mhz	<u>70.94</u> MHz
75% BW UPPER BANDEDGE I.L. PERF	<u>-0.39</u> dB	<u>-0.41</u> dB	<u>-0.43</u> dB
{11d} PERFORMANCE DELTA (I.L. @ {11b} - I.L. @ {11a})	<u>0.22</u> dB	<u>0.24</u> dB	<u>0.27</u> dB
{11e} PERFORMANCE DELTA (I.L. @ {11c} - I.L. @ {11a})	<u>0.22</u> dB	<u>0.24</u> dB	<u>0.27</u> dB

Prepared in accordance with MIL-STD-100

CONTRACT NO.	SIZE A	CAGE CODE 57032	DWG. NO. 63-0005-02	REV. J
DADEN-ANTHONY ASSOCIATES INC.		FILE: ACAD/63/0502APCJ.DOC	SHEET	13



FINAL FUNCTIONAL PERFORMANCE

TRANSMISSION LOSS
SERIAL NO. P229-008

-10C DATA

OPR: R. HOGGATT DATE DEC 18 1996

MARKER PARAMETERS

channel 2

MARKER 1	14.000000 MHz OFF	50.000000 MHz - .2336 dB
MARKER 2	86.000000 MHz OFF	49.219192 MHz OFF
MARKER 3	20.000000 MHz OFF	9.087004 MHz -3.2337 dB
MARKER 4	89.000000 MHz OFF	89.371381 MHz -3.2337 dB
MKR STIMULUS OFFSET	0.000000 MHz 0 dB	89.425802 MHz -3.2342 dB

REFERENCE MARKER PLACEMENT	OFF	OFF
MARKER SEARCH	CONTINUOUS	CONTINUOUS
TARGET VALUE	OFF	OFF
MARKER WIDTH VALUE	-14 dB	-3 dB
MARKER TRACKING	OFF	OFF

DOCUMENT APPROVAL SHEET



TITLE <u>Performance Verification Report</u> METSAT AMSU-A2 Receiver Assembly, (P/N 1356441-1, S/N F04) S/N 107			DOCUMENT NO. Report 11317 November 1998
INPUT FROM: R. Kapper	DATE 208	SPECIFICATION ENGINEER: N/A	DATE
CHECKED BY: N/A	DATE	JOB NUMBER: N/A	DATE
APPROVED SIGNATURES		DEPT. NO.	DATE
Product Team Leader (R. Kapper) <u>R. Kapper</u>		8661	11/10/98
Systems Engineer (R. Platt) <u>R. Platt</u>		8311	11/16/98
Design Assurance (E. Lorenz) <u>E. Lorenz</u>		8331	11/12/98
Quality Assurance (R. Taylor) <u>R. Taylor</u>		7831	11/16/98
Technical Director/PMO (R. Hauerwaas) <u>R. Hauerwaas</u>		4001	11/11/98
Released: Configuration Management (J. Cavanaugh) <u>J. Cavanaugh</u>		8361	11/16/98
By my signature, I certify the above document has been reviewed by me and concurs with the technical requirements related to my area of responsibility.			
(Data Center) FINAL			
Please return this sheet and the reproducible master to Jim Kirk (Bldg. 1/Dept. 8631), ext. 2081.			

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6. AUTHOR(S) R. Kapper			
7. PERFORMING ORGANIZATION NAME(S) AND ADDRESS(ES) Aerojet 1100 W. Hollyvale Azusa, CA 91702		8. PERFORMING ORGANIZATION REPORT NUMBER 11317 November 1998	
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